

# MSP430FR263x、MSP430FR253x 电容式触控感应混合信号微控制器

## 1 器件概述

### 1.1 特性

- CapTIvate™ 技术 – 电容式触控
  - 性能
    - 四路同步快速电极扫描
    - 支持点数高达 1024 的高分辨率滑块
    - 接近感应
  - 可靠性
    - 提高了针对电力线、射频及其他环境噪声的抗扰度
    - 内置扩展频谱、自动调优、噪声滤除和消抖算法
    - 提供可靠的触控解决方案，具有 10V RMS 共模噪声、4kV 电气快速瞬变以及 15kV 静电放电，符合 IEC-61000-4-6、IEC-61000-4-4 和 IEC-61000-4-2 标准
    - 降低了射频辐射，简化了电气设计
    - 支持金属触控和防水设计
  - 灵活性
    - 多达 16 个自电容式电极和 64 个互电容式电极
    - 在同一设计中混合使用自电容式电极和互电容式电极
    - 支持多点触控功能
    - 宽电容检测范围：0 至 300pF 宽电极范围
  - 低功耗
    - 四个传感器的触摸唤醒电流小于 5μA
    - 触摸唤醒状态机支持在 CPU 休眠过程中进行电极扫描
    - 用于环境补偿、滤波和阈值检测的硬件加速
  - 易于使用
    - CapTIvate 设计中心 PC GUI 允许工程师对电容按钮进行实时设计和调试，无需编写代码
    - 存储于 ROM 中的 CapTIvate 软件库为客户应用提供充足的 FRAM
- 嵌入式微控制器
  - 16 位 RISC 架构
  - 支持的时钟频率最高可达 16MHz
  - 3.6V 至 1.8V 的宽电源电压范围（最低电源电压受限于 SVS 电平，请参阅 SVS 规格）
- 优化的超低功耗模式
  - 激活模式：126μA/MHz（典型值）
  - 待机模式：四个传感器的触摸唤醒电流小于 5μA
  - 采用 32768Hz 晶振的 LPM3.5 实时时钟 (RTC) 计数器：730nA（典型值）
  - 关断电流 (LPM4.5)：16nA（典型值）
- 高性能模拟
  - 8 通道 10 位模数转换器 (ADC)
    - 1.5V 的内部基准电压
    - 采样与保持 200ksps
- 增强型串行通信
  - 两个增强型通用串行通信接口 (eUSCI\_A) 支持 UART、IrDA 和 SPI
  - 一个 eUSCI (eUSCI\_B) 支持 SPI 和 I<sup>2</sup>C
- 智能数字外设
  - 四个 16 位计时器
    - 两个计时器，每个计时器具有三个捕捉/比较寄存器 (Timer\_A3)
    - 两个计时器，每个计时器具有两个捕捉/比较寄存器 (Timer\_A2)
  - 一个采用 CapTIvate 技术的 16 位计时器
  - 一个仅用作计数器的 16 位 RTC
  - 16 位循环冗余校验 (CRC)
- 低功耗铁电 RAM (FRAM)
  - 容量高达 15.5KB 的非易失性存储器
  - 内置错误修正码 (ECC)
  - 可配置的写保护
  - 对程序、常量和存储的统一存储
  - 耐写次数达 10<sup>15</sup> 次
  - 抗辐射和非磁性
  - FRAM 与 SRAM 之比高达 4: 1

- 时钟系统 (CS)
  - 片上 32kHz RC 振荡器 (REFO)
  - 带有锁频环 (FLL) 的片上 16MHz 数控振荡器 (DCO)
    - 室温下的精度为  $\pm 1\%$  (具有片上基准)
  - 片上超低频 10kHz 振荡器 (VLO)
  - 片上高频调制振荡器 (MODOSC)
  - 外部 32kHz 晶振 (LFXT)
  - 可编程 MCLK 预分频器 (1 至 128)
  - 通过可编程预分频器 (1、2、4 或 8) 从 MCLK 获得的 SMCLK
- 通用输入/输出和引脚功能
  - 共计 19 个 I/O (采用 TSSOP-32 封装)
  - 16 个中断引脚 (P1 和 P2) 可以将 MCU 从低功耗模式下唤醒
- 开发工具和软件
  - 开发工具
    - MSP CapTIvate™ MCU 开发套件评估: 与 CAPTIVATE-PGMR 编程器和电容式触控 MSP430FR2633 MCU 板 CAPTIVATE-FR2633 配合使用
- 目标开发板 (MSP-TS430RGE24A)
- 易于使用的生态系统
  - CapTIvate 设计中心 – 代码生成、可自定义 GUI、实时调优
- 系列成员 (另请参阅 器件比较)
  - MSP430FR2633: 15KB 程序 FRAM、512 字节信息 FRAM、4KB RAM、多达 16 个自电容式传感器或 64 个互电容式传感器
  - MSP430FR2533: 15KB 程序 FRAM、512 字节信息 FRAM、2KB RAM、多达 16 个自电容式传感器或 24 个互电容式传感器
  - MSP430FR2632: 8KB 程序 FRAM、512 字节信息 FRAM、2KB RAM、多达 8 个自电容式传感器或 16 个互电容式传感器
  - MSP430FR2532: 8KB 程序 FRAM、512 字节信息 FRAM、1KB RAM、多达 8 个自电容式传感器或 8 个互电容式传感器
- 封装选项
  - 32 引脚: VQFN (RHB)
  - 32 引脚: TSSOP (DA)
  - 24 引脚: VQFN (RGE)
  - 24 引脚: DSBGA (YQW)

## 1.2 应用

- 电子智能锁、门键盘和读取器
- 车库门系统
- 入侵 HMI 键盘和控制面板
- 电动百叶窗
- 遥控器
- 个人电子产品
- 无线扬声器和耳机
- 手持式视频游戏控制器
- A/V 接收器
- 白色家电
- 小型电器
- 园艺和电动工具

## 1.3 说明

MSP430FR263x 和 MSP430FR253x 是用于电容式触控检测的超低功耗 MSP430™ 微控制器, 采用 CapTIvate™ 触控技术, 适用于按钮、滑块、滚轮及接近传感应用中的数字输入 D 类音频放大器。采用 CapTIvate 技术的 MSP430 MCU 提供市面上最高集成度和自主性的电容式触控解决方案, 具有高可靠性和抗噪能力以及最低功耗。TI 的电容式触控技术支持在同一设计方案中同时使用自电容式和互电容式电极, 最大限度地提高了灵活性。采用 CapTIvate 技术的 MSP430 MCU 可以穿透厚玻璃、塑料外壳、金属和木材, 在恶劣的环境 (包括潮湿、油腻和脏污环境) 中工作。

TI 电容式触控感应 MSP430 MCU 由一个由各种软、硬件资源组成的生态系统提供支持, 并配套提供有参考设计和代码示例, 可帮助您快速开展设计。开发套件包括 MSP-CAPT-FR2633 CapTIvate 技术开发套件。

TI 还提供免费的软件, 如 CapTIvate 设计中心, 工程师可以在其中借助方便易用的 GUI 和 MSP430Ware™ 软件以及包括 CapTIvate 技术指南在内的综合性文档快速进行应用开发。

TI 的 MSP430 超低功耗 (ULP) FRAM 微控制器平台将独特的嵌入式 FRAM 和全面的超低功耗系统架构相结合, 从而使系统设计人员能够在降低能耗的同时提升性能。FRAM 技术将 RAM 的低能耗快速写入、灵活性和耐用性与闪存的非易失性相结合。

有关完整的模块说明, 请参阅《MSP430FR4xx 和 MSP430FR2xx 系列器件用户指南》。

**器件信息<sup>(1)</sup>**

| 器件型号             | 封装                    | 封装尺寸 <sup>(2)</sup> |
|------------------|-----------------------|---------------------|
| MSP430FR2633IRHB | VQFN (32)             | 5mm x 5mm           |
| MSP430FR2533IRHB | VQFN (32)             | 5mm x 5mm           |
| MSP430FR2633IDA  | TSSOP (32)            | 11mm x 6.2mm        |
| MSP430FR2533IDA  | TSSOP (32)            | 11mm x 6.2mm        |
| MSP430FR2632IRGE | 超薄四方扁平无引线 (VQFN) (24) | 4mm x 4mm           |
| MSP430FR2532IRGE | 超薄四方扁平无引线 (VQFN) (24) | 4mm x 4mm           |
| MSP430FR2633IYQW | DSBGA (24)            | 2.29mm x 2.34mm     |
| MSP430FR2632IYQW | DSBGA (24)            | 2.29mm x 2.34mm     |

- (1) 要获得最新的产品、封装和订购信息，请参见封装选项附录（节 9），或者访问德州仪器 (TI) 网站 [www.ti.com.cn](http://www.ti.com.cn)。
- (2) 这里显示的尺寸为近似值。要获得包含误差值的封装尺寸，请参见机械数据（节 9 中）。

**CAUTION**

系统级静电放电 (ESD) 保护必须符合器件级 ESD 规范，以防发生电气过载或对数据或代码存储器造成干扰。有关更多信息，请参阅《MSP430 系统级 ESD 注意事项》。

## 1.4 功能框图

图 1-1 给出了功能框图。

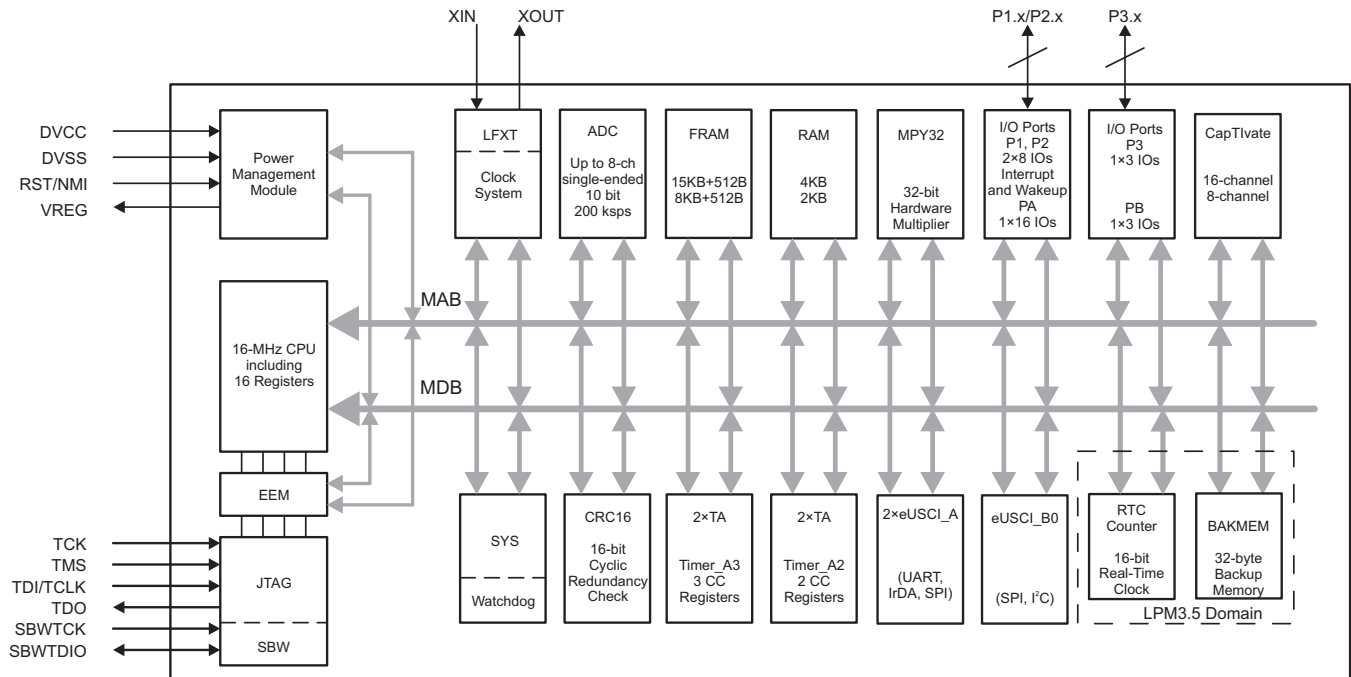


图 1-1. 功能框图

- MCU 的主电源对 DVCC 和 DVSS 分别为数字模块和模拟模块供电。推荐的旁路电容和去耦电容分别为 4.7μF 至 10μF 和 0.1μF，精度为 ±5%。
- VREG 是 CapTlvate 稳压器的去耦电容。所需去耦电容的建议值为 1μF，最大等效串联电阻 (ESR) ≤ 200mΩ。
- P1 和 P2 特有引脚中断功能，可将 MCU 从所有低功耗模式 (LPM) 唤醒（包括 LPM3.5 和 LPM4）。
- 每个 Timer\_A3 具有三个捕捉/比较寄存器。仅 CCR1 和 CCR2 从外部连接。CCR0 寄存器仅用于内部周期时序和生成中断。
- 每个 Timer\_A2 具有两个捕捉/比较寄存器。两个寄存器仅用于内部周期时序和生成中断。
- 在 LPM3 模式下，CapTlvate 可在其他外设停止工作的情况下继续工作。

## 内容

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## 2 修订历史记录

注：之前版本的页码可能与当前版本有所不同。

从修订版本 D 更改为修订版本 E

| Changes from August 20, 2019 to December 9, 2019                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                     | Page |
|------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|------|
| <ul style="list-style-type: none"> <li>Changed the note that begins "Supply voltage changes faster than 0.2 V/μs can trigger a BOR reset..." in <a href="#">Section 5.3, Recommended Operating Conditions</a> ..... <a href="#">20</a></li> <li>Added the note that begins "TI recommends that power to the DVCC pin must not exceed the limits..." in <a href="#">Section 5.3, Recommended Operating Conditions</a> ..... <a href="#">20</a></li> <li>Changed the note that begins "A capacitor tolerance of ±20% or better is required..." in <a href="#">Section 5.3, Recommended Operating Conditions</a> ..... <a href="#">20</a></li> <li>Changed the note that begins "Requires external capacitors at both terminals..." in <a href="#">Table 5-4, XT1 Crystal Oscillator (Low Frequency)</a> ..... <a href="#">28</a></li> <li>Added the <math>t_{(int)}</math> parameter in <a href="#">Table 5-10, Digital Inputs</a> ..... <a href="#">32</a></li> <li>Added the <math>t_{TA, cap}</math> parameter in <a href="#">Table 5-13, Timer_A</a> ..... <a href="#">34</a></li> <li>Corrected the test conditions for the <math>R_{I, MUX}</math> parameter in <a href="#">Table 5-20, ADC, Power Supply and Input Range Conditions</a> ..... <a href="#">40</a></li> <li>Added the note that begins "<math>t_{sample} = \ln(2^{n+1}) \times \tau</math> ..." in <a href="#">Table 5-21, ADC, 10-Bit Timing Parameters</a> ..... <a href="#">40</a></li> <li>Moved <math>C_{REG}</math> and <math>C_{ELECTRODE}</math> from <a href="#">Section 5.3, Recommended Operating Conditions</a> to <a href="#">Table 5-23, CapTIvate Electrical Characteristics</a> ..... <a href="#">42</a></li> <li>Changed the CRC covered end address to 0x1AF5 in note (1) in <a href="#">Table 6-22, Device Descriptors</a> ..... <a href="#">67</a></li> </ul> |      |

从修订版本 C 更改为修订版本 D

| Changes from August 29, 2018 to August 19, 2019                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                  | Page |
|----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|------|
| <ul style="list-style-type: none"> <li>更新了 <a href="#">节 1.1</a> 特性 ..... <a href="#">1</a></li> <li>在 <a href="#">节 1.1</a>，特性 中添加了“目标开发板”信息 ..... <a href="#">2</a></li> <li>Changed "<math>f_{CONVER} = 2</math> MHz" to "<math>f_{CONVER} = 4</math> MHz" in the note that begins "CapTIvate technology works in LPM3 with 64 mutual-capacitance buttons" on <a href="#">Section 5.7, Low-Power Mode (LPM3 and LPM4) Supply Currents (Into <math>V_{CC}</math>) Excluding External Current</a> ..... <a href="#">22</a></li> <li>Added the <math>t_{TA, cap}</math> parameter in <a href="#">Table 5-13, Timer_A</a> ..... <a href="#">34</a></li> <li>Changed the parameter symbol from <math>R_I</math> to <math>R_{I, MUX}</math> in <a href="#">Table 5-20, ADC, Power Supply and Input Range Conditions</a> . <a href="#">40</a></li> <li>Added <math>R_{I, Misc}</math> TYP value of 34 kΩ in <a href="#">Table 5-20, ADC, Power Supply and Input Range Conditions</a> ..... <a href="#">40</a></li> <li>Added formula for <math>R_I</math> calculation in <a href="#">Table 5-21, ADC, 10-Bit Timing Parameters</a> ..... <a href="#">40</a></li> <li>Removed the description of "±3°C" in table note that starts "The device descriptor structure ..." of <a href="#">Table 5-22, ADC, 10-Bit Linearity Parameters</a> ..... <a href="#">41</a></li> <li>Moved <math>C_{REG}</math> and <math>C_{ELECTRODE}</math> from <a href="#">Section 5.3, Recommended Operating Conditions</a> to <a href="#">Table 5-23, CapTIvate Electrical Characteristics</a> ..... <a href="#">42</a></li> <li>Added test condition for <math>C_{ELECTRODE}</math> in <a href="#">Table 5-23, CapTIvate Electrical Characteristics</a> ..... <a href="#">42</a></li> <li>Changed the symbol and description of the <math>DC_{CAPCLK}</math> parameter in <a href="#">Table 5-23, CapTIvate Electrical Characteristics</a> ..... <a href="#">42</a></li> <li>Moved the SNR parameter to <a href="#">Table 5-24, CapTIvate Signal-to-Noise Ratio Characteristics</a> ..... <a href="#">42</a></li> <li>Corrected bitfield from IRDSEL to IRDSSEL in <a href="#">Section 6.10.8, Timers (Timer0_A3, Timer1_A3, Timer2_A2 and Timer3_A2)</a>, in the description that starts "The interconnection of Timer0_A3 and ..." ..... <a href="#">56</a></li> <li>Corrected the ADCINCHx column heading in <a href="#">Table 6-15, ADC Channel Connections</a> ..... <a href="#">58</a></li> <li>Corrected the ADCSHSx column heading in <a href="#">Table 6-16, ADC Trigger Signal Connections</a> ..... <a href="#">58</a></li> <li>Added P1SELc information in <a href="#">Table 6-32, Port P1, P2 Registers (Base Address: 0200h)</a> ..... <a href="#">71</a></li> <li>Added P2SELc information in <a href="#">Table 6-32, Port P1, P2 Registers (Base Address: 0200h)</a> ..... <a href="#">71</a></li> <li>Added P3SELc information in <a href="#">Table 6-33, Port P3 Registers (Base Address: 0220h)</a> ..... <a href="#">71</a></li> <li>Updated <a href="#">Section 7.2.2, CapTIvate Peripheral</a> ..... <a href="#">81</a></li> </ul> |      |



从修订版本 B 更改为修订版本 C

| Changes from June 9, 2017 to August 28, 2018                                                                                                                 | Page      |
|--------------------------------------------------------------------------------------------------------------------------------------------------------------|-----------|
| • 删除了节 1.1, 特性 中“接近感应”项的“30cm” .....                                                                                                                         | <u>1</u>  |
| • Updated Section 3.1, Related Products .....                                                                                                                | <u>8</u>  |
| • Corrected package type in VQFN row (changed from QFN to VQFN) in Table 4-2, Signal Descriptions .....                                                      | <u>18</u> |
| • Changed HBM limit to $\pm 1000$ V and CDM limit to $\pm 250$ V in Section 5.2, ESD Ratings .....                                                           | <u>20</u> |
| • Added note to $V_{SVSH-}$ and $V_{SVSH+}$ parameters in Table 5-2, PMM, SVS and BOR .....                                                                  | <u>26</u> |
| • Added the $t_{TA, cap}$ parameter in Table 5-13, Timer_A .....                                                                                             | <u>34</u> |
| • Moved $C_{REG}$ and $C_{ELECTRODE}$ from Section 5.3, Recommended Operating Conditions to Table 5-23, CapTlvate Electrical Characteristics .....           | <u>42</u> |
| • Added the SNR parameter in Table 5-23, CapTlvate Electrical Characteristics .....                                                                          | <u>42</u> |
| • Moved "FRAM access time error" to "System Reset" row and added ACCTEIFG to interrupt flag column in Table 6-2, Interrupt Sources, Flags, and Vectors ..... | <u>47</u> |
| • Corrected the offset for P2SEL1 in Table 6-32, Port P1, P2 Registers (Base Address: 0200h) .....                                                           | <u>71</u> |
| • 更新了节 8.2 器件命名规则 中的文本和图 .....                                                                                                                               | <u>84</u> |

从修订版本 A 更改为修订版本 B

| Changes from December 10, 2015 to June 8, 2017                                                                                                                                                                    | Page      |
|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|-----------|
| • 更改了“特性”列表的组织结构 .....                                                                                                                                                                                            | <u>1</u>  |
| • 在节 1.1, 特性 中的“封装选项”列表中添加了 DSBGA (YQW) 封装 .....                                                                                                                                                                  | <u>2</u>  |
| • 更新了节 1.2, 应用 中的列表 .....                                                                                                                                                                                         | <u>2</u>  |
| • 更新节 1.3, 说明 .....                                                                                                                                                                                               | <u>2</u>  |
| • 在器件信息表 (位于节 1.3“说明”中) 中添加了 DSBGA (YQW) 封装选项 .....                                                                                                                                                               | <u>3</u>  |
| • Added MSP430FR2633IYQW and MSP430FR2632IYQW to Table 3-1, Device Comparison .....                                                                                                                               | <u>8</u>  |
| • Added Section 3.1, Related Products .....                                                                                                                                                                       | <u>8</u>  |
| • Added DSBGA (YQW) pinout .....                                                                                                                                                                                  | <u>12</u> |
| • Added DSBGA (YQW) package to Table 4-1, Pin Attributes .....                                                                                                                                                    | <u>13</u> |
| • Added DSBGA (YQW) package to Table 4-2, Signal Descriptions .....                                                                                                                                               | <u>16</u> |
| • Added row for VQFN thermal pad in Table 4-2, Signal Descriptions .....                                                                                                                                          | <u>18</u> |
| • Removed FRAM reflow note .....                                                                                                                                                                                  | <u>20</u> |
| • Updated the notes on $I_{LPM3}$ , CapTlvate, 16 buttons and $I_{LPM3}$ , CapTlvate, 64 buttons in Section 5.7, Low-Power Mode (LPM3 and LPM4) Supply Currents (Into $V_{CC}$ ) Excluding External Current ..... | <u>22</u> |
| • Added DSBGA (YQW) package and changed notes for Section 5.10, Thermal Resistance Characteristics .....                                                                                                          | <u>25</u> |
| • Added the $t_{TA, cap}$ parameter in Table 5-13, Timer_A .....                                                                                                                                                  | <u>34</u> |
| • Removed ADCDIV from the formula for the TYP value in the second row of the $t_{CONVERT}$ parameter in Table 5-21, ADC, 10-Bit Timing Parameters (removed because ADCCLK is after division) .....                | <u>40</u> |
| • Moved $C_{REG}$ and $C_{ELECTRODE}$ from Section 5.3, Recommended Operating Conditions to Table 5-23, CapTlvate Electrical Characteristics .....                                                                | <u>42</u> |
| • Add description of blank device detection .....                                                                                                                                                                 | <u>48</u> |
| • Changed the paragraph that starts "Quickly switching digital signals and ..." in Section 7.2.1.2, Design Requirements .....                                                                                     | <u>80</u> |
| • 更新了图 8-1, 器件命名规则 .....                                                                                                                                                                                          | <u>84</u> |
| • 将先前的开发工具支持 部分替换为节 8.3“工具和软件” .....                                                                                                                                                                              | <u>85</u> |
| • 更新了节 8.4“文档支持”的格式和内容 .....                                                                                                                                                                                      | <u>87</u> |

从初始发行版更改为修订版本 A

| Changes from November 6, 2015 to December 9, 2015                                                                                                | Page      |
|--------------------------------------------------------------------------------------------------------------------------------------------------|-----------|
| • 将文档状态从“产品预览”更改为“生产数据” .....                                                                                                                    | <u>1</u>  |
| • 更改了开头为“提供可靠的触控解决方案...”的列表项 .....                                                                                                               | <u>1</u>  |
| • 向开头为“宽电源电压范围...”的列表项添加了说明 .....                                                                                                                | <u>1</u>  |
| • In the note that starts "Low-power mode 3, VLO, excludes SVS test conditions...", changed " $f_{XT1} = 0$ Hz" to " $f_{XT1} = 32768$ Hz" ..... | <u>22</u> |

|                                                                                                                                                                              |                    |
|------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|--------------------|
| • Added note that starts "The VLO clock frequency is reduced by 15%..."                                                                                                      | <a href="#">31</a> |
| • Added the $t_{TA, cap}$ parameter in <a href="#">Table 5-13, Timer_A</a>                                                                                                   | <a href="#">34</a> |
| • Moved $C_{REG}$ and $C_{ELECTRODE}$ from <a href="#">Section 5.3, Recommended Operating Conditions</a> to <a href="#">Table 5-23, CapTlvate Electrical Characteristics</a> | <a href="#">42</a> |
| • Added note to "Clock" in <a href="#">Table 6-1, Operating Modes</a>                                                                                                        | <a href="#">46</a> |
| • Added note that starts "XT1CLK and VLOCLK can be active during LPM4..."                                                                                                    | <a href="#">46</a> |
| • Corrected description in <a href="#">Section 6.10.10, Backup Memory (BKMEM)</a>                                                                                            | <a href="#">57</a> |



### 3 Device Comparison

Table 3-1 summarizes the features of the available family members.

**Table 3-1. Device Comparison<sup>(1)(2)</sup>**

| DEVICE           | PROGRAM FRAM<br>+ INFORMATION<br>FRAM (BYTES) | SRAM<br>(BYTES) | TA0 TO TA3                              | eUSCI_A |         | eUSCI_B | 10-BIT ADC<br>CHANNELS | CapTIvate™<br>CHANNELS | GPIOs | PACKAGE<br>TYPE   |
|------------------|-----------------------------------------------|-----------------|-----------------------------------------|---------|---------|---------|------------------------|------------------------|-------|-------------------|
|                  |                                               |                 |                                         | UART    | SPI     |         |                        |                        |       |                   |
| MSP430FR2633IRHB | 15360 + 512                                   | 4096            | 2, 3 × CCR <sup>(3)</sup><br>2, 2 × CCR | up to 2 | up to 2 | 1       | 8                      | 16 <sup>(4)</sup>      | 19    | 32 RHB<br>(VQFN)  |
| MSP430FR2533IRHB | 15360 + 512                                   | 2048            | 2, 3 × CCR <sup>(3)</sup><br>2, 2 × CCR | up to 2 | up to 2 | 1       | 8                      | 16 <sup>(4)</sup>      | 19    | 32 RHB<br>(VQFN)  |
| MSP430FR2633IDA  | 15360 + 512                                   | 4096            | 2, 3 × CCR <sup>(3)</sup><br>2, 2 × CCR | up to 2 | up to 2 | 1       | 8                      | 16 <sup>(4)</sup>      | 19    | 32 DA<br>(TSSOP)  |
| MSP430FR2533IDA  | 15360 + 512                                   | 2048            | 2, 3 × CCR <sup>(3)</sup><br>2, 2 × CCR | up to 2 | up to 2 | 1       | 8                      | 16 <sup>(4)</sup>      | 19    | 32 DA<br>(TSSOP)  |
| MSP430FR2632IRGE | 8192 + 512                                    | 2048            | 2, 3 × CCR <sup>(3)</sup><br>2, 2 × CCR | up to 2 | 1       | 1       | 8                      | 8 <sup>(5)</sup>       | 15    | 24 RGE<br>(VQFN)  |
| MSP430FR2532IRGE | 8192 + 512                                    | 1024            | 2, 3 × CCR <sup>(3)</sup><br>2, 2 × CCR | up to 2 | 1       | 1       | 8                      | 8 <sup>(5)</sup>       | 15    | 24 RGE<br>(VQFN)  |
| MSP430FR2633IYQW | 15360 + 512                                   | 4096            | 2, 3 × CCR <sup>(3)</sup><br>2, 2 × CCR | up to 2 | 1       | 1       | 8                      | 8 <sup>(6)</sup>       | 17    | 24 YQW<br>(DSBGA) |
| MSP430FR2632IYQW | 8192 + 512                                    | 2048            | 2, 3 × CCR <sup>(3)</sup><br>2, 2 × CCR | up to 2 | 1       | 1       | 8                      | 8 <sup>(6)</sup>       | 17    | 24 YQW<br>(DSBGA) |

- (1) For the most current package and ordering information, see the *Package Option Addendum* in 节 9, or see the TI website at [www.ti.com](http://www.ti.com)
- (2) Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at [www.ti.com/packaging](http://www.ti.com/packaging)
- (3) A CCR register is a configurable register that provides internal and external capture or compare inputs, or internal and external PWM outputs.
- (4) Eight dedicated CapTIvate channels are included.
- (5) Four dedicated CapTIvate channels are included.
- (6) Two dedicated CapTIvate channels are included.

#### 3.1 Related Products

For information about other devices in this family of products or related products, see the following links.

[TI 16-bit and 32-bit microcontrollers](#)

High-performance, low-power solutions to enable the autonomous future

[Products for MSP430 ultra-low-power sensing & measurement MCUs](#)

One platform. One ecosystem. Endless possibilities.

[Companion products for MSP430FR2633](#)

Review products that are frequently purchased or used with this product.

[Reference designs for MSP430FR2633](#)

Find reference designs leveraging the best in TI technology – from analog and power management to embedded processors

## 4 Terminal Configuration and Functions

### 4.1 Pin Diagrams

Figure 4-1 shows the pinout for the 32-pin RHB package.

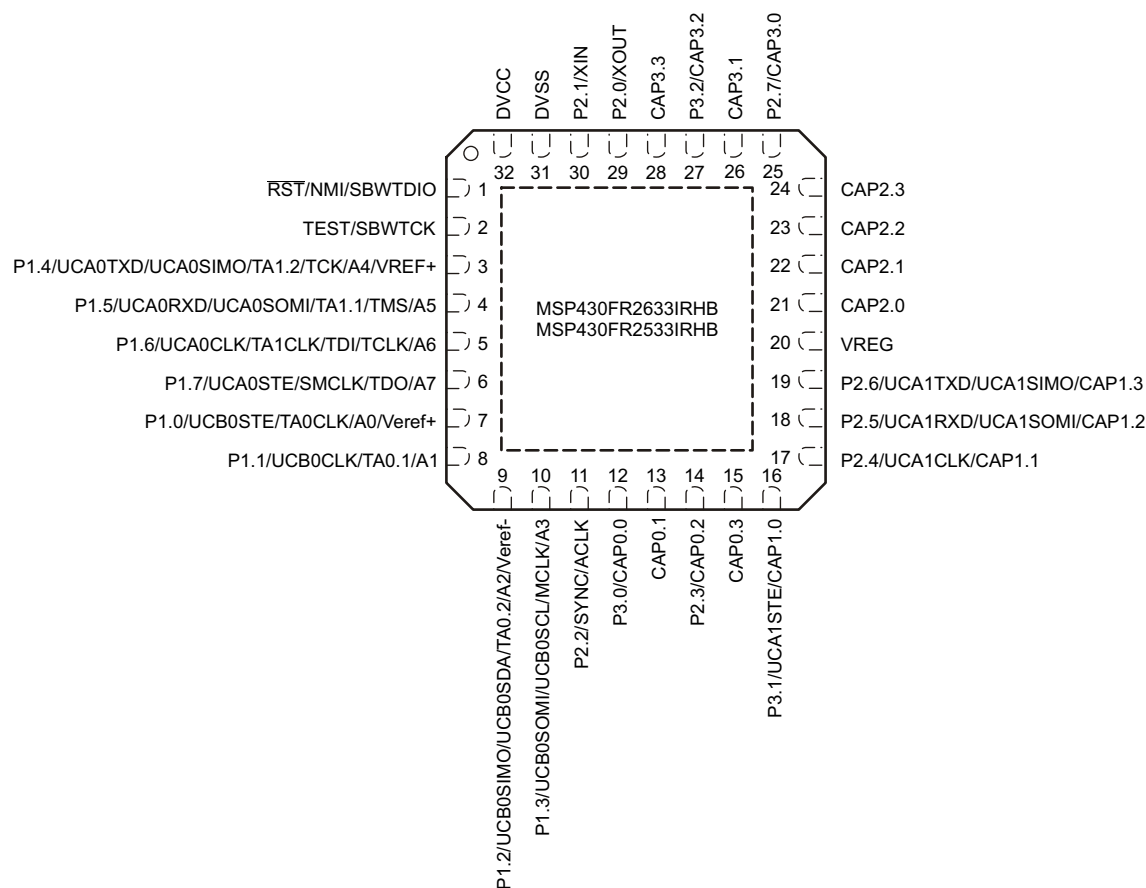
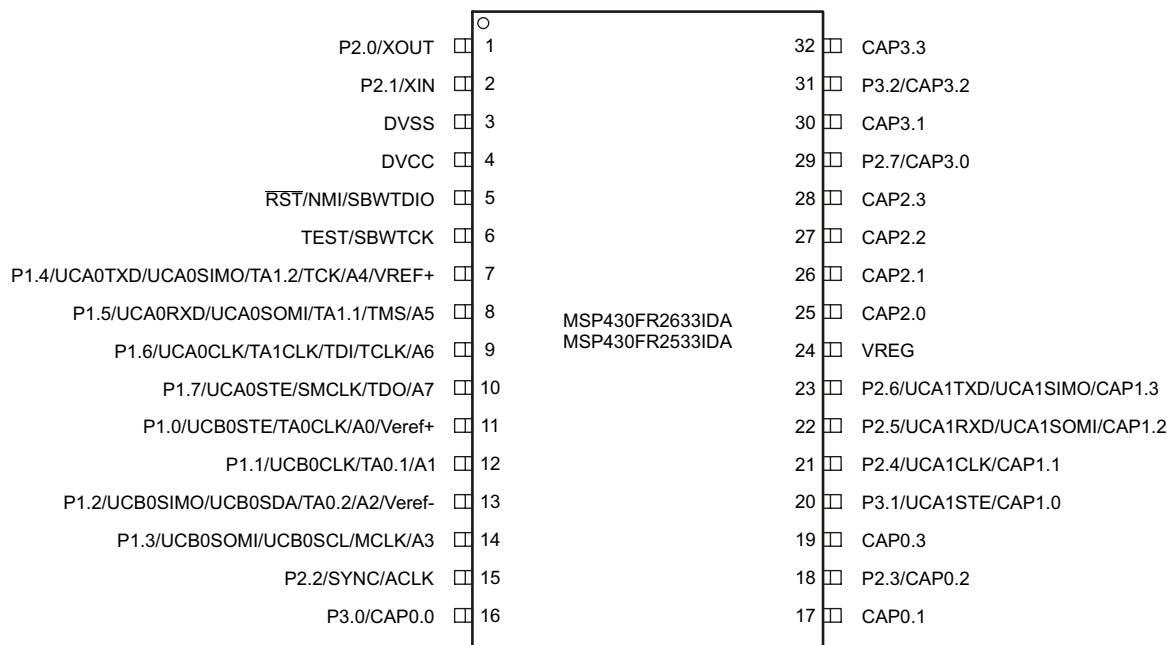


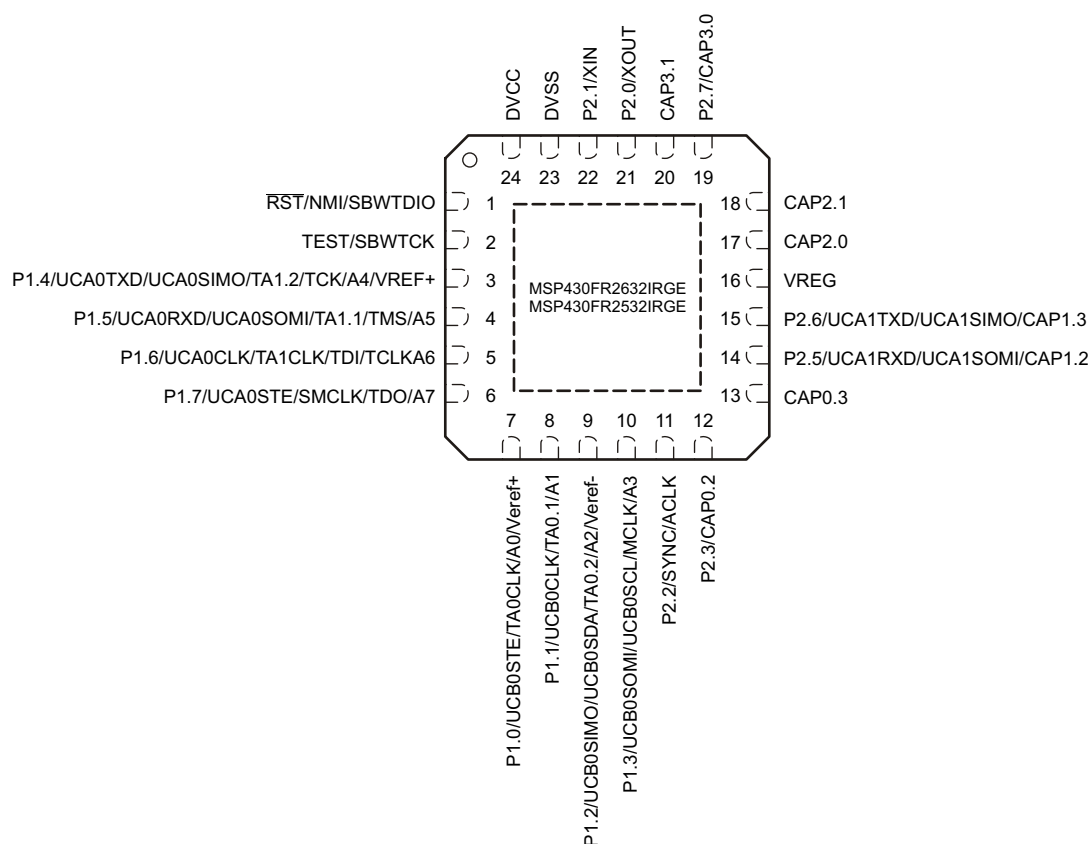
Figure 4-1. 32-Pin RHB Package (Top View)

Figure 4-2 shows the pinout for the 32-pin DA package.



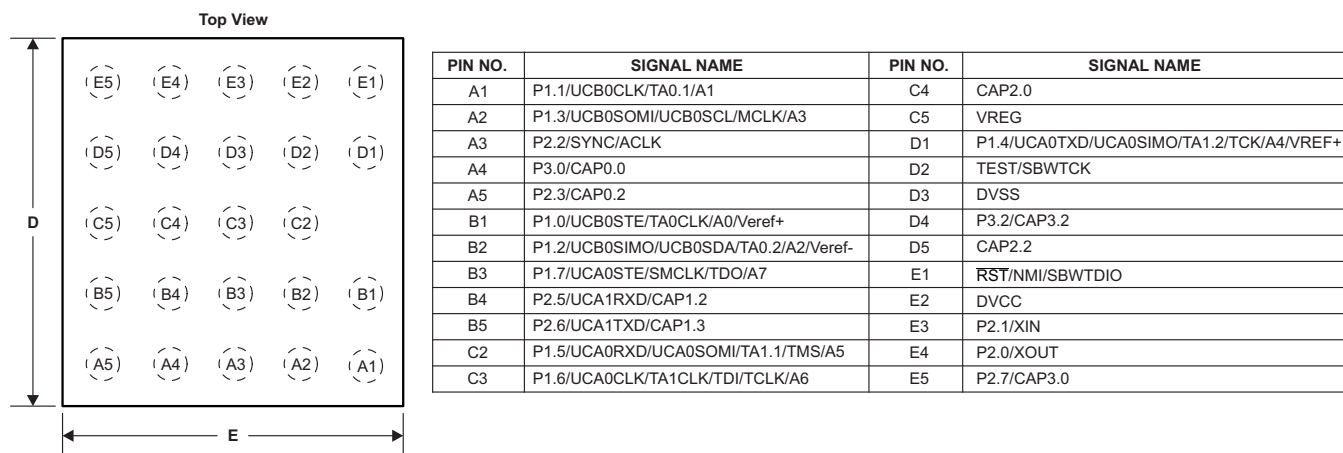
**Figure 4-2. 32-Pin DA Package (Top View)**

Figure 4-3 shows the pinout for the 24-pin RGE package.

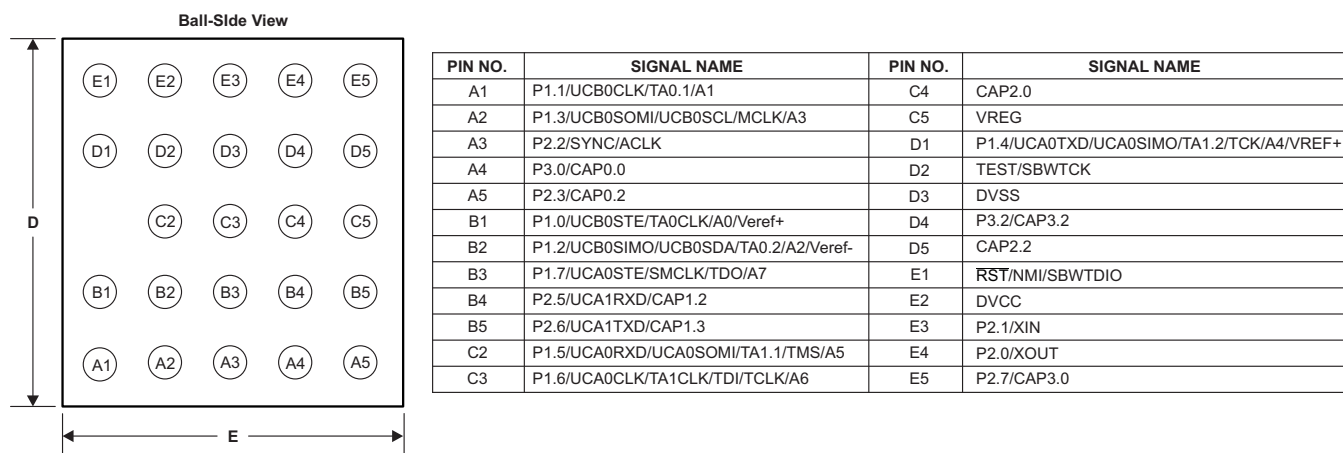


**Figure 4-3. 24-Pin RGE Package (Top View)**

Figure 4-4 shows the top view of the YQW package, and Figure 4-5 shows the bottom (ball-side) view.



**Figure 4-4. 24-Pin YQW Package (Top View)**



**Figure 4-5. 24-Pin YQW Package (Bottom View)**

## 4.2 Pin Attributes

Table 4-1 lists the attributes of all pins.

**Table 4-1. Pin Attributes**

| PIN NUMBER |    |     |     | SIGNAL NAME <sup>(1)</sup><br>(2) | SIGNAL TYPE <sup>(3)</sup> | BUFFER TYPE <sup>(4)</sup> | POWER SOURCE <sup>(5)</sup> | RESET STATE AFTER BOR <sup>(6)</sup> |
|------------|----|-----|-----|-----------------------------------|----------------------------|----------------------------|-----------------------------|--------------------------------------|
| RHB        | DA | RGE | YQW |                                   |                            |                            |                             |                                      |
| 1          | 5  | 1   | E1  | RST (RD)                          | I                          | LVC MOS                    | DVCC                        | OFF                                  |
|            |    |     |     | NMI                               | I                          | LVC MOS                    | DVCC                        | –                                    |
|            |    |     |     | SBWTDIO                           | I/O                        | LVC MOS                    | DVCC                        | –                                    |
| 2          | 6  | 2   | D2  | TEST (RD)                         | I                          | LVC MOS                    | DVCC                        | OFF                                  |
|            |    |     |     | SBWTK                             | I                          | LVC MOS                    | DVCC                        | –                                    |
| 3          | 7  | 3   | D1  | P1.4 (RD)                         | I/O                        | LVC MOS                    | DVCC                        | OFF                                  |
|            |    |     |     | UCA0TXD                           | O                          | LVC MOS                    | DVCC                        | –                                    |
|            |    |     |     | UCA0SIMO                          | I/O                        | LVC MOS                    | DVCC                        | –                                    |
|            |    |     |     | TA1.2                             | I/O                        | LVC MOS                    | DVCC                        | –                                    |
|            |    |     |     | TCK                               | I                          | LVC MOS                    | DVCC                        | –                                    |
|            |    |     |     | A4                                | I                          | Analog                     | DVCC                        | –                                    |
|            |    |     |     | VREF+                             | O                          | Power                      | DVCC                        | –                                    |
| 4          | 8  | 4   | C2  | P1.5 (RD)                         | I/O                        | LVC MOS                    | DVCC                        | OFF                                  |
|            |    |     |     | UCA0RXD                           | I                          | LVC MOS                    | DVCC                        | –                                    |
|            |    |     |     | UCA0SOMI                          | I/O                        | LVC MOS                    | DVCC                        | –                                    |
|            |    |     |     | TA1.1                             | I/O                        | LVC MOS                    | DVCC                        | –                                    |
|            |    |     |     | TMS                               | I                          | LVC MOS                    | DVCC                        | –                                    |
|            |    |     |     | A5                                | I                          | Analog                     | DVCC                        | –                                    |
| 5          | 9  | 5   | C3  | P1.6 (RD)                         | I/O                        | LVC MOS                    | DVCC                        | OFF                                  |
|            |    |     |     | UCA0CLK                           | I/O                        | LVC MOS                    | DVCC                        | –                                    |
|            |    |     |     | TA1CLK                            | I                          | LVC MOS                    | DVCC                        | –                                    |
|            |    |     |     | TDI                               | I                          | LVC MOS                    | DVCC                        | –                                    |
|            |    |     |     | TCLK                              | I                          | LVC MOS                    | DVCC                        | –                                    |
|            |    |     |     | A6                                | I                          | Analog                     | DVCC                        | –                                    |
| 6          | 10 | 6   | B3  | P1.7 (RD)                         | I/O                        | LVC MOS                    | DVCC                        | OFF                                  |
|            |    |     |     | UCA0STE                           | I/O                        | LVC MOS                    | DVCC                        | –                                    |
|            |    |     |     | SMCLK                             | O                          | LVC MOS                    | DVCC                        | –                                    |
|            |    |     |     | TDO                               | O                          | LVC MOS                    | DVCC                        | –                                    |
|            |    |     |     | A7                                | I                          | Analog                     | DVCC                        | –                                    |
| 7          | 11 | 7   | B1  | P1.0 (RD)                         | I/O                        | LVC MOS                    | DVCC                        | OFF                                  |
|            |    |     |     | UCB0STE                           | I/O                        | LVC MOS                    | DVCC                        | –                                    |
|            |    |     |     | TA0CLK                            | I                          | LVC MOS                    | DVCC                        | –                                    |
|            |    |     |     | A0                                | I                          | Analog                     | DVCC                        | –                                    |
|            |    |     |     | Veref+                            | I                          | Power                      | DVCC                        | –                                    |

(1) Signals names with (RD) denote the reset default pin name.

(2) To determine the pin mux encodings for each pin, see [Section 6.11, Input/Output Diagrams](#).

(3) Signal Types: I = Input, O = Output, I/O = Input or Output

(4) Buffer Types: LVC MOS, Analog, or Power (see [Table 4-3](#))

(5) The power source shown in this table is the I/O power source, which may differ from the module power source.

(6) Reset States:

OFF = High-impedance with Schmitt trigger and pullup or pulldown (if available) disabled

N/A = Not applicable

**Table 4-1. Pin Attributes (continued)**

| PIN NUMBER |    |     |     | SIGNAL NAME <sup>(1)</sup><br>(2) | SIGNAL TYPE <sup>(3)</sup> | BUFFER TYPE <sup>(4)</sup> | POWER SOURCE <sup>(5)</sup> | RESET STATE AFTER BOR <sup>(6)</sup> |
|------------|----|-----|-----|-----------------------------------|----------------------------|----------------------------|-----------------------------|--------------------------------------|
| RHB        | DA | RGE | YQW |                                   |                            |                            |                             |                                      |
| 8          | 12 | 8   | A1  | P1.1 (RD)                         | I/O                        | LVC MOS                    | DVCC                        | OFF                                  |
|            |    |     |     | UCB0CLK                           | I/O                        | LVC MOS                    | DVCC                        | –                                    |
|            |    |     |     | TA0.1                             | I/O                        | LVC MOS                    | DVCC                        | –                                    |
|            |    |     |     | A1                                | I                          | Analog                     | DVCC                        | –                                    |
| 9          | 13 | 9   | B2  | P1.2 (RD)                         | I/O                        | LVC MOS                    | DVCC                        | OFF                                  |
|            |    |     |     | UCB0SIMO                          | I/O                        | LVC MOS                    | DVCC                        | –                                    |
|            |    |     |     | UCB0SDA                           | I/O                        | LVC MOS                    | DVCC                        | –                                    |
|            |    |     |     | TA0.2                             | I/O                        | LVC MOS                    | DVCC                        | –                                    |
|            |    |     |     | A2                                | I                          | Analog                     | DVCC                        | –                                    |
|            |    |     |     | Veref-                            | I                          | Power                      | DVCC                        | –                                    |
| 10         | 14 | 10  | A2  | P1.3 (RD)                         | I/O                        | LVC MOS                    | DVCC                        | OFF                                  |
|            |    |     |     | UCB0SOMI                          | I/O                        | LVC MOS                    | DVCC                        | –                                    |
|            |    |     |     | UCB0SCL                           | I/O                        | LVC MOS                    | DVCC                        | –                                    |
|            |    |     |     | MCLK                              | O                          | LVC MOS                    | DVCC                        | –                                    |
|            |    |     |     | A3                                | I                          | Analog                     | DVCC                        | –                                    |
| 11         | 15 | 11  | A3  | P2.2 (RD)                         | I/O                        | LVC MOS                    | DVCC                        | OFF                                  |
|            |    |     |     | SYNC                              | I                          | LVC MOS                    | DVCC                        | –                                    |
|            |    |     |     | ACLK                              | O                          | LVC MOS                    | DVCC                        | –                                    |
| 12         | 16 | –   | A4  | P3.0 (RD)                         | I/O                        | LVC MOS                    | DVCC                        | OFF                                  |
|            |    |     |     | CAP0.0                            | I/O                        | Analog                     | V <sub>REG</sub>            | –                                    |
| 13         | 17 | –   | –   | CAP0.1                            | I/O                        | Analog                     | V <sub>REG</sub>            | OFF                                  |
| 14         | 18 | 12  | A5  | P2.3 (RD)                         | I/O                        | LVC MOS                    | DVCC                        | OFF                                  |
|            |    |     |     | CAP0.2                            | I/O                        | Analog                     | V <sub>REG</sub>            | –                                    |
| 15         | 19 | 13  | –   | CAP0.3                            | I/O                        | Analog                     | V <sub>REG</sub>            | OFF                                  |
| 16         | 20 | –   | –   | P3.1 (RD)                         | I/O                        | LVC MOS                    | DVCC                        | OFF                                  |
|            |    |     |     | UCA1STE                           | I/O                        | LVC MOS                    | DVCC                        | –                                    |
|            |    |     |     | CAP1.0                            | I/O                        | Analog                     | V <sub>REG</sub>            | –                                    |
| 17         | 21 | –   | –   | P2.4 (RD)                         | I/O                        | LVC MOS                    | DVCC                        | OFF                                  |
|            |    |     |     | UCA1CLK                           | I/O                        | LVC MOS                    | DVCC                        | –                                    |
|            |    |     |     | CAP1.1                            | I/O                        | Analog                     | V <sub>REG</sub>            | –                                    |
| 18         | 22 | 14  | B4  | P2.5 (RD)                         | I/O                        | LVC MOS                    | DVCC                        | OFF                                  |
|            |    |     |     | UCA1RXD                           | I                          | LVC MOS                    | DVCC                        | –                                    |
|            |    |     |     | UCA1SOMI                          | I/O                        | LVC MOS                    | DVCC                        | –                                    |
|            |    |     |     | CAP1.2                            | I/O                        | Analog                     | V <sub>REG</sub>            | –                                    |
| 19         | 23 | 15  | B5  | P2.6 (RD)                         | I/O                        | LVC MOS                    | DVCC                        | OFF                                  |
|            |    |     |     | UCA1TXD                           | O                          | LVC MOS                    | DVCC                        | –                                    |
|            |    |     |     | UCA1SIMO                          | I/O                        | LVC MOS                    | DVCC                        | –                                    |
|            |    |     |     | CAP1.3                            | I/O                        | Analog                     | V <sub>REG</sub>            | –                                    |
| 20         | 24 | 16  | C5  | VREG                              | P                          | Power                      | V <sub>REG</sub>            | N/A                                  |
| 21         | 25 | 17  | C4  | CAP2.0                            | I/O                        | Analog                     | V <sub>REG</sub>            | OFF                                  |
| 22         | 26 | 18  | –   | CAP2.1                            | I/O                        | Analog                     | V <sub>REG</sub>            | OFF                                  |
| 23         | 27 | –   | D5  | CAP2.2                            | I/O                        | Analog                     | V <sub>REG</sub>            | OFF                                  |
| 24         | 28 | –   | –   | CAP2.3                            | I/O                        | Analog                     | V <sub>REG</sub>            | OFF                                  |
| 25         | 29 | 19  | E5  | P2.7 (RD)                         | I/O                        | LVC MOS                    | DVCC                        | OFF                                  |
|            |    |     |     | CAP3.0                            | I/O                        | Analog                     | V <sub>REG</sub>            | –                                    |
| 26         | 30 | 20  | –   | CAP3.1                            | I/O                        | Analog                     | V <sub>REG</sub>            | OFF                                  |



**Table 4-1. Pin Attributes (continued)**

| PIN NUMBER |    |     |     | SIGNAL NAME <sup>(1)</sup><br>(2) | SIGNAL TYPE <sup>(3)</sup> | BUFFER TYPE <sup>(4)</sup> | POWER SOURCE <sup>(5)</sup> | RESET STATE AFTER BOR <sup>(6)</sup> |
|------------|----|-----|-----|-----------------------------------|----------------------------|----------------------------|-----------------------------|--------------------------------------|
| RHB        | DA | RGE | YQW |                                   |                            |                            |                             |                                      |
| 27         | 31 | –   | D4  | P3.2 (RD)                         | I/O                        | LVC MOS                    | DVCC                        | OFF                                  |
|            |    |     |     | CAP3.2                            | I/O                        | Analog                     | V <sub>REG</sub>            | –                                    |
| 28         | 32 | –   | –   | CAP3.3                            | I/O                        | Analog                     | V <sub>REG</sub>            | OFF                                  |
| 29         | 1  | 21  | E4  | P2.0 (RD)                         | I/O                        | LVC MOS                    | DVCC                        | OFF                                  |
|            |    |     |     | XOUT                              | O                          | LVC MOS                    | DVCC                        | –                                    |
| 30         | 2  | 22  | E3  | P2.1 (RD)                         | I/O                        | LVC MOS                    | DVCC                        | OFF                                  |
|            |    |     |     | XIN                               | I                          | LVC MOS                    | DVCC                        | –                                    |
| 31         | 3  | 23  | D3  | DVSS                              | P                          | Power                      | DVCC                        | N/A                                  |
| 32         | 4  | 24  | E2  | DVCC                              | P                          | Power                      | DVCC                        | N/A                                  |

### 4.3 Signal Descriptions

Table 4-2 describes the signals for all device variants and package options.

**Table 4-2. Signal Descriptions**

| FUNCTION  | SIGNAL NAME | PIN NUMBER |    |     |     | PIN TYPE <sup>(1)</sup> | DESCRIPTION                                                       |
|-----------|-------------|------------|----|-----|-----|-------------------------|-------------------------------------------------------------------|
|           |             | RHB        | DA | RGE | YQW |                         |                                                                   |
| ADC       | A0          | 7          | 11 | 7   | B1  | I                       | Analog input A0                                                   |
|           | A1          | 8          | 12 | 8   | A1  | I                       | Analog input A1                                                   |
|           | A2          | 9          | 13 | 9   | B2  | I                       | Analog input A2                                                   |
|           | A3          | 10         | 14 | 10  | A2  | I                       | Analog input A3                                                   |
|           | A4          | 3          | 7  | 3   | D1  | I                       | Analog input A4                                                   |
|           | A5          | 4          | 8  | 4   | C2  | I                       | Analog input A5                                                   |
|           | A6          | 5          | 9  | 5   | C3  | I                       | Analog input A6                                                   |
|           | A7          | 6          | 10 | 6   | B3  | I                       | Analog input A7                                                   |
|           | Veref+      | 7          | 11 | 7   | B1  | I                       | ADC positive reference                                            |
|           | Veref-      | 9          | 13 | 9   | B2  | I                       | ADC negative reference                                            |
| CapTlvate | CAP0.0      | 12         | 16 | –   | A4  | I/O                     | CapTlvate channel                                                 |
|           | CAP0.1      | 13         | 17 | –   | –   | I/O                     | CapTlvate channel                                                 |
|           | CAP0.2      | 14         | 18 | 12  | A5  | I/O                     | CapTlvate channel                                                 |
|           | CAP0.3      | 15         | 19 | 13  | –   | I/O                     | CapTlvate channel                                                 |
|           | CAP1.0      | 16         | 20 | –   | –   | I/O                     | CapTlvate channel                                                 |
|           | CAP1.1      | 17         | 21 | –   | –   | I/O                     | CapTlvate channel                                                 |
|           | CAP1.2      | 18         | 22 | 14  | B4  | I/O                     | CapTlvate channel                                                 |
|           | CAP1.3      | 19         | 23 | 15  | B5  | I/O                     | CapTlvate channel                                                 |
|           | CAP2.0      | 21         | 25 | 17  | C4  | I/O                     | CapTlvate channel                                                 |
|           | CAP2.1      | 22         | 26 | 18  | –   | I/O                     | CapTlvate channel                                                 |
|           | CAP2.2      | 23         | 27 | –   | D5  | I/O                     | CapTlvate channel                                                 |
|           | CAP2.3      | 24         | 28 | –   | –   | I/O                     | CapTlvate channel                                                 |
|           | CAP3.0      | 25         | 29 | 19  | E5  | I/O                     | CapTlvate channel                                                 |
|           | CAP3.1      | 26         | 30 | 20  | –   | I/O                     | CapTlvate channel                                                 |
|           | CAP3.2      | 27         | 31 | –   | D4  | I/O                     | CapTlvate channel                                                 |
|           | CAP3.3      | 28         | 32 | –   | –   | I/O                     | CapTlvate channel                                                 |
|           | SYNC        | 11         | 15 | 11  | A3  | I                       | CapTlvate synchronous trigger input for processing and conversion |
| Clock     | ACLK        | 11         | 15 | 11  | A3  | O                       | ACLK output                                                       |
|           | MCLK        | 10         | 14 | 10  | A2  | O                       | MCLK output                                                       |
|           | SMCLK       | 6          | 10 | 6   | B3  | O                       | SMCLK output                                                      |
|           | XIN         | 30         | 2  | 22  | E3  | I                       | Input terminal for crystal oscillator                             |
|           | XOUT        | 29         | 1  | 21  | E4  | O                       | Output terminal for crystal oscillator                            |
| Debug     | SBWTCK      | 2          | 6  | 2   | D2  | I                       | Spy-Bi-Wire input clock                                           |
|           | SBWTDIO     | 1          | 5  | 1   | E1  | I/O                     | Spy-Bi-Wire data input/output                                     |
|           | TCK         | 3          | 7  | 3   | D1  | I                       | Test clock                                                        |
|           | TCLK        | 5          | 9  | 5   | C3  | I                       | Test clock input                                                  |
|           | TDI         | 5          | 9  | 5   | C3  | I                       | Test data input                                                   |
|           | TDO         | 6          | 10 | 6   | B3  | O                       | Test data output                                                  |
|           | TEST        | 2          | 6  | 2   | D2  | I                       | Test Mode pin – selected digital I/O on JTAG pins                 |
|           | TMS         | 4          | 8  | 4   | C2  | I                       | Test mode select                                                  |

(1) Pin Types: I = Input, O = Output, I/O = Input or Output, P = Power

Table 4-2. Signal Descriptions (continued)

| FUNCTION         | SIGNAL NAME             | PIN NUMBER |    |     |     | PIN TYPE <sup>(1)</sup> | DESCRIPTION                                                   |
|------------------|-------------------------|------------|----|-----|-----|-------------------------|---------------------------------------------------------------|
|                  |                         | RHB        | DA | RGE | YQW |                         |                                                               |
| GPIO             | P1.0                    | 7          | 11 | 7   | B1  | I/O                     | General-purpose I/O                                           |
|                  | P1.1                    | 8          | 12 | 8   | A1  | I/O                     | General-purpose I/O                                           |
|                  | P1.2                    | 9          | 13 | 9   | B2  | I/O                     | General-purpose I/O                                           |
|                  | P1.3                    | 10         | 14 | 10  | A2  | I/O                     | General-purpose I/O                                           |
|                  | P1.4                    | 3          | 7  | 3   | D1  | I/O                     | General-purpose I/O <sup>(2)</sup>                            |
|                  | P1.5                    | 4          | 8  | 4   | C2  | I/O                     | General-purpose I/O <sup>(2)</sup>                            |
|                  | P1.6                    | 5          | 9  | 5   | C3  | I/O                     | General-purpose I/O <sup>(2)</sup>                            |
|                  | P1.7                    | 6          | 10 | 6   | B3  | I/O                     | General-purpose I/O <sup>(2)</sup>                            |
|                  | P2.0                    | 29         | 1  | 21  | E4  | I/O                     | General-purpose I/O                                           |
|                  | P2.1                    | 30         | 2  | 22  | E3  | I/O                     | General-purpose I/O                                           |
|                  | P2.2                    | 11         | 15 | 11  | A3  | I/O                     | General-purpose I/O                                           |
|                  | P2.3                    | 14         | 18 | 12  | A5  | I/O                     | General-purpose I/O                                           |
|                  | P2.4                    | 17         | 21 | –   | –   | I/O                     | General-purpose I/O                                           |
|                  | P2.5                    | 18         | 22 | 14  | B4  | I/O                     | General-purpose I/O                                           |
|                  | P2.6                    | 19         | 23 | 15  | B5  | I/O                     | General-purpose I/O                                           |
|                  | P2.7                    | 25         | 29 | 19  | E5  | I/O                     | General-purpose I/O                                           |
|                  | P3.0                    | 12         | 16 | –   | A4  | I/O                     | General-purpose I/O                                           |
|                  | P3.1                    | 16         | 20 | –   | –   | I/O                     | General-purpose I/O                                           |
|                  | P3.2                    | 27         | 31 | –   | D4  | I/O                     | General-purpose I/O                                           |
| I <sup>2</sup> C | UCB0SCL                 | 10         | 14 | 10  | A2  | I/O                     | eUSCI_B0 I <sup>2</sup> C clock                               |
|                  | UCB0SDA                 | 9          | 13 | 9   | B2  | I/O                     | eUSCI_B0 I <sup>2</sup> C data                                |
| Power            | DVCC                    | 32         | 4  | 24  | E2  | P                       | Power supply                                                  |
|                  | DVSS                    | 31         | 3  | 23  | D3  | P                       | Power ground                                                  |
|                  | VREF+                   | 3          | 7  | 3   | D1  | P                       | Output of positive reference voltage with ground as reference |
|                  | VREG                    | 20         | 24 | 16  | C5  | O                       | CapTivate regulator external decoupling capacitor             |
| SPI              | UCA0CLK                 | 5          | 9  | 5   | C3  | I/O                     | eUSCI_A0 SPI clock input/output                               |
|                  | UCA0SIMO                | 3          | 7  | 3   | D1  | I/O                     | eUSCI_A0 SPI slave in/master out                              |
|                  | UCA0SOMI                | 4          | 8  | 4   | C2  | I/O                     | eUSCI_A0 SPI slave out/master in                              |
|                  | UCA0STE                 | 6          | 10 | 6   | B3  | I/O                     | eUSCI_A0 SPI slave transmit enable                            |
|                  | UCA1CLK                 | 17         | 21 | –   | –   | I/O                     | eUSCI_A1 SPI clock input/output                               |
|                  | UCA1SIMO                | 19         | 23 | 15  | B5  | I/O                     | eUSCI_A1 SPI slave in/master out                              |
|                  | UCA1SOMI                | 18         | 22 | 14  | B4  | I/O                     | eUSCI_A1 SPI slave out/master in                              |
|                  | UCA1STE                 | 16         | 20 | –   | –   | I/O                     | eUSCI_A1 SPI slave transmit enable                            |
|                  | UCB0CLK                 | 8          | 12 | 8   | A1  | I/O                     | eUSCI_B0 clock input/output                                   |
|                  | UCB0SIMO                | 9          | 13 | 9   | B2  | I/O                     | eUSCI_B0 SPI slave in/master out                              |
|                  | UCB0SOMI                | 10         | 14 | 10  | A2  | I/O                     | eUSCI_B0 SPI slave out/master in                              |
|                  | UCB0STE                 | 7          | 11 | 7   | B1  | I/O                     | eUSCI_B0 slave transmit enable                                |
| System           | NMI                     | 1          | 5  | 1   | E1  | I                       | Nonmaskable interrupt input                                   |
|                  | $\overline{\text{RST}}$ | 1          | 5  | 1   | E1  | I                       | Active-low reset input                                        |

(2) Because this pin is multiplexed with the JTAG function, TI recommends disabling the pin interrupt function while in JTAG debug to prevent collisions.

**Table 4-2. Signal Descriptions (continued)**

| FUNCTION | SIGNAL NAME      | PIN NUMBER |     |     |     | PIN TYPE <sup>(1)</sup> | DESCRIPTION                                                                     |
|----------|------------------|------------|-----|-----|-----|-------------------------|---------------------------------------------------------------------------------|
|          |                  | RHB        | DA  | RGE | YQW |                         |                                                                                 |
| Timer_A  | TA0.1            | 8          | 12  | 8   | A1  | I/O                     | Timer TA0 CCR1 capture: CCI1A input, compare: Out1 outputs                      |
|          | TA0.2            | 9          | 13  | 9   | B2  | I/O                     | Timer TA0 CCR2 capture: CCI2A input, compare: Out2 outputs                      |
|          | TA0CLK           | 7          | 11  | 7   | B1  | I                       | Timer clock input TACLK for TA0                                                 |
|          | TA1.1            | 4          | 8   | 4   | C2  | I/O                     | Timer TA1 CCR1 capture: CCI1A input, compare: Out1 outputs                      |
|          | TA1.2            | 3          | 7   | 3   | D1  | I/O                     | Timer TA1 CCR2 capture: CCI2A input, compare: Out2 outputs                      |
|          | TA1CLK           | 5          | 9   | 5   | C3  | I                       | Timer clock input TACLK for TA1                                                 |
| UART     | UCA0RXD          | 4          | 8   | 4   | C2  | I                       | eUSCI_A0 UART receive data                                                      |
|          | UCA0TXD          | 3          | 7   | 3   | D1  | O                       | eUSCI_A0 UART transmit data                                                     |
|          | UCA1RXD          | 18         | 22  | 14  | B4  | I                       | eUSCI_A1 UART receive data                                                      |
|          | UCA1TXD          | 19         | 23  | 15  | B5  | O                       | eUSCI_A1 UART transmit data                                                     |
| VQFN Pad | VQFN thermal pad | Pad        | N/A | Pad | N/A |                         | VQFN package exposed thermal pad. TI recommends connecting to V <sub>SS</sub> . |

## 4.4 Pin Multiplexing

Pin multiplexing for these MCUs is controlled by both register settings and operating modes (for example, if the MCU is in test mode). For details of the settings for each pin and schematics of the multiplexed ports, see [Section 6.11](#).

## 4.5 Buffer Types

[Table 4-3](#) defines the pin buffer types that are listed in [Table 4-1](#).

**Table 4-3. Buffer Types**

| BUFFER TYPE (STANDARD) | NOMINAL VOLTAGE | HYSTERESIS     | PU OR PD     | NOMINAL PU OR PD STRENGTH ( $\mu$ A) | OUTPUT DRIVE STRENGTH (mA)         | OTHER CHARACTERISTICS                                        |
|------------------------|-----------------|----------------|--------------|--------------------------------------|------------------------------------|--------------------------------------------------------------|
| LVC MOS                | 3.0 V           | $\gamma^{(1)}$ | Programmable | See <a href="#">Section 5.11.4</a>   | See <a href="#">Section 5.11.4</a> |                                                              |
| Analog                 | 3.0 V           | N              | N/A          | N/A                                  | N/A                                | See analog modules in <a href="#">Section 5</a> for details. |
| Power (DVCC)           | 3.0 V           | N              | N/A          | N/A                                  | N/A                                | SVS enables hysteresis on DVCC.                              |
| Power (AVCC)           | 3.0 V           | N              | N/A          | N/A                                  | N/A                                |                                                              |

(1) Only for input pins.

## 4.6 Connection of Unused Pins

[Table 4-4](#) lists the correct termination of unused pins.

**Table 4-4. Connection of Unused Pins<sup>(1)</sup>**

| PIN                                | POTENTIAL        | COMMENT                                                                                              |
|------------------------------------|------------------|------------------------------------------------------------------------------------------------------|
| Px.0 to Px.7                       | Open             | Switched to port function, output direction (PxDIR.n = 1)                                            |
| $\overline{\text{RST}}/\text{NMI}$ | DV <sub>CC</sub> | 47-k $\Omega$ pullup or internal pullup selected with 10-nF (or 1.1-nF) pulldown <sup>(2)</sup>      |
| TEST                               | Open             | This pin always has an internal pulldown enabled.                                                    |
| CAP2.x, CAPx.1, CAPx.3             | Open             | These pins have internal pullup and pulldown resistors, and high impedance is their default setting. |

(1) Any unused pin with a secondary function that is shared with general-purpose I/O should follow the Px.0 to Px.7 unused pin connection guidelines.

(2) The pulldown capacitor should not exceed 1.1 nF when using MCUs with Spy-Bi-Wire interface in Spy-Bi-Wire mode with TI tools like FET interfaces or GANG programmers.

## 5 Specifications

### 5.1 Absolute Maximum Ratings<sup>(1)</sup>

over operating free-air temperature range (unless otherwise noted)

|                                                                                        | MIN  | MAX                                  | UNIT |
|----------------------------------------------------------------------------------------|------|--------------------------------------|------|
| Voltage applied at DVCC pin to V <sub>SS</sub>                                         | −0.3 | 4.1                                  | V    |
| Voltage applied to any dedicated CapTivate pin or pin in CapTivate mode <sup>(2)</sup> | −0.3 | V <sub>REG</sub>                     | V    |
| Voltage applied to any other pin <sup>(3)</sup>                                        | −0.3 | V <sub>CC</sub> + 0.3<br>(4.1 V Max) | V    |
| Diode current at any device pin                                                        |      | ±2                                   | mA   |
| Maximum junction temperature, T <sub>J</sub>                                           |      | 85                                   | °C   |
| Storage temperature, T <sub>stg</sub> <sup>(4)</sup>                                   | −40  | 125                                  | °C   |

- (1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions* is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) This applies to dedicated CapTivate I/Os only or I/Os worked in CapTivate mode.
- (3) All voltages referenced to V<sub>SS</sub>.
- (4) Higher temperature may be applied during board soldering according to the current JEDEC J-STD-020 specification with peak reflow temperatures not higher than classified on the device label on the shipping boxes or reels.

### 5.2 ESD Ratings

|                                            | VALUE                                                                          | UNIT  |
|--------------------------------------------|--------------------------------------------------------------------------------|-------|
| V <sub>(ESD)</sub> Electrostatic discharge | Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 <sup>(1)</sup>              | ±1000 |
|                                            | Charged-device model (CDM), per JEDEC specification JESD22-C101 <sup>(2)</sup> | ±250  |

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process. Pins listed as ±1000 V may actually have higher performance.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process. Pins listed as ±250 V may actually have higher performance.

### 5.3 Recommended Operating Conditions

|                                                                                 | MIN                                                | NOM | MAX               | UNIT              |
|---------------------------------------------------------------------------------|----------------------------------------------------|-----|-------------------|-------------------|
| V <sub>CC</sub> Supply voltage applied at DVCC pin <sup>(1)(2)(3)(4)</sup>      | 1.8                                                |     | 3.6               | V                 |
| V <sub>SS</sub> Supply voltage applied at DVSS pin                              |                                                    | 0   |                   | V                 |
| T <sub>A</sub> Operating free-air temperature                                   | −40                                                |     | 85                | °C                |
| T <sub>J</sub> Operating junction temperature                                   | −40                                                |     | 85                | °C                |
| C <sub>DVCC</sub> Recommended capacitor at DVCC <sup>(5)</sup>                  | 4.7                                                | 10  |                   | μF                |
| f <sub>SYSTEM</sub> Processor frequency (maximum MCLK frequency) <sup>(6)</sup> | No FRAM wait states (NWAITSx = 0)                  |     | 0                 | 8                 |
|                                                                                 | With FRAM wait states (NWAITSx = 1) <sup>(7)</sup> |     | 0                 | 16 <sup>(8)</sup> |
| f <sub>ACLK</sub> Maximum ACLK frequency                                        |                                                    |     | 40                | kHz               |
| f <sub>SMCLK</sub> Maximum SMCLK frequency                                      |                                                    |     | 16 <sup>(8)</sup> | MHz               |

- (1) Supply voltage changes faster than 0.2 V/μs can trigger a BOR reset even within the recommended supply voltage range. Following the data sheet recommendation for capacitor C<sub>DVCC</sub> limits the slopes accordingly.
- (2) Modules may have a different supply voltage range specification. See the specification of the respective module in this data sheet.
- (3) TI recommends that power to the DVCC pin must not exceed the limits specified in *Recommended Operating Conditions*. Exceeding the specified limits can cause malfunction of the device including erroneous writes to RAM and FRAM.
- (4) The minimum supply voltage is defined by the SVS levels. See the SVS threshold parameters in [Table 5-2](#).
- (5) A capacitor tolerance of ±20% or better is required. A low-ESR ceramic capacitor of 100 nF (minimum) should be placed as close as possible (within a few millimeters) to the respective pin pair.
- (6) Modules may have a different maximum input clock specification. See the specification of the respective module in this data sheet.
- (7) Wait states only occur on actual FRAM accesses (that is, on FRAM cache misses). RAM and peripheral accesses are always executed without wait states.
- (8) If clock sources such as HF crystals or the DCO with frequencies >16 MHz are used, the clock must be divided in the clock system to comply with this operating condition.

## 5.4 Active Mode Supply Current Into $V_{CC}$ Excluding External Current<sup>(1)</sup>

 $V_{CC} = 3\text{ V}$ ,  $T_A = 25^\circ\text{C}$  (unless otherwise noted)

| PARAMETER                           | EXECUTION MEMORY             | TEST CONDITION | FREQUENCY (f <sub>MCLK</sub> = f <sub>SMCLK</sub> ) |     |                                         |     |                                         |      | UNIT |
|-------------------------------------|------------------------------|----------------|-----------------------------------------------------|-----|-----------------------------------------|-----|-----------------------------------------|------|------|
|                                     |                              |                | 1 MHz<br>0 WAIT STATES<br>(NWAITSx = 0)             |     | 8 MHz<br>0 WAIT STATES<br>(NWAITSx = 0) |     | 16 MHz<br>1 WAIT STATE<br>(NWAITSx = 1) |      |      |
|                                     |                              |                | TYP                                                 | MAX | TYP                                     | MAX | TYP                                     | MAX  |      |
| I <sub>AM, FRAM</sub> (0%)          | FRAM<br>0% cache hit ratio   | 3 V, 25°C      | 504                                                 |     | 2772                                    |     | 3047                                    | 3480 | μA   |
|                                     |                              | 3 V, 85°C      | 516                                                 |     | 2491                                    |     | 2871                                    |      |      |
| I <sub>AM, FRAM</sub> (100%)        | FRAM<br>100% cache hit ratio | 3 V, 25°C      | 203                                                 |     | 625                                     |     | 1000                                    | 1215 | μA   |
|                                     |                              | 3 V, 85°C      | 212                                                 |     | 639                                     |     | 1016                                    |      |      |
| I <sub>AM, RAM</sub> <sup>(2)</sup> | RAM                          | 3 V, 25°C      | 229                                                 |     | 818                                     |     | 1377                                    |      | μA   |

(1) All inputs are tied to 0 V or to  $V_{CC}$ . Outputs do not source or sink any current. Characterized with program executing typical data processing.

$f_{ACLK} = 32768\text{ Hz}$ ,  $f_{MCLK} = f_{SMCLK} = f_{DCO}$  at specified frequency

Program and data entirely reside in FRAM. All execution is from FRAM.

(2) Program and data reside entirely in RAM. All execution is from RAM. No access to FRAM.

## 5.5 Active Mode Supply Current Per MHz

 $V_{CC} = 3\text{ V}$ ,  $T_A = 25^\circ\text{C}$  (unless otherwise noted)

| PARAMETER         | TEST CONDITIONS                                                                                                                                                            | TYP | UNIT                     |
|-------------------|----------------------------------------------------------------------------------------------------------------------------------------------------------------------------|-----|--------------------------|
| $dI_{AM,FRAM}/df$ | Active mode current consumption per MHz, execution from FRAM, no wait states<br>[ $I_{AM}$ (75% cache hit rate) at 8 MHz – $I_{AM}$ (75% cache hit rate) at 1 MHz] / 7 MHz | 126 | $\mu\text{A}/\text{MHz}$ |

## 5.6 Low-Power Mode LPM0 Supply Currents Into $V_{CC}$ Excluding External Current

 $V_{CC} = 3\text{ V}$ ,  $T_A = 25^\circ\text{C}$  (unless otherwise noted)<sup>(1)(2)</sup>

| PARAMETER         | V <sub>CC</sub> | FREQUENCY (f <sub>SMCLK</sub> ) |     |       |     |        |     | UNIT |
|-------------------|-----------------|---------------------------------|-----|-------|-----|--------|-----|------|
|                   |                 | 1 MHz                           |     | 8 MHz |     | 16 MHz |     |      |
|                   |                 | TYP                             | MAX | TYP   | MAX | TYP    | MAX |      |
| I <sub>LPM0</sub> | 2 V             | 156                             |     | 328   |     | 420    |     | μA   |
|                   | 3 V             | 166                             |     | 342   |     | 433    |     |      |

(1) All inputs are tied to 0 V or to  $V_{CC}$ . Outputs do not source or sink any current.

(2) Current for watchdog timer clocked by SMCLK included.

$f_{ACLK} = 32768\text{ Hz}$ ,  $f_{MCLK} = 0\text{ MHz}$ ,  $f_{SMCLK}$  at specified frequency.

## 5.7 Low-Power Mode (LPM3 and LPM4) Supply Currents (Into $V_{CC}$ ) Excluding External Current

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) <sup>(1)</sup>

| PARAMETER                                         |                                                                                      | $V_{CC}$ | –40°C |     | 25°C  |      | 85°C |     | UNIT    |
|---------------------------------------------------|--------------------------------------------------------------------------------------|----------|-------|-----|-------|------|------|-----|---------|
|                                                   |                                                                                      |          | TYP   | MAX | TYP   | MAX  | TYP  | MAX |         |
| $I_{LPM3,XT1}$                                    | Low-power mode 3, 12.5-pF crystal, includes SVS <sup>(2)(3)(4)</sup>                 | 3 V      | 0.98  |     | 1.18  | 1.65 | 3.24 |     | $\mu A$ |
|                                                   |                                                                                      | 2 V      | 0.96  |     | 1.16  |      | 3.21 |     |         |
| $I_{LPM3,VLO}$                                    | Low-power mode 3, VLO, excludes SVS <sup>(5)</sup>                                   | 3 V      | 0.78  |     | 0.98  | 1.40 | 3.04 |     | $\mu A$ |
|                                                   |                                                                                      | 2 V      | 0.76  |     | 0.96  |      | 3.01 |     |         |
| $I_{LPM3, RTC}$                                   | Low-power mode 3, RTC, excludes SVS <sup>(6)</sup> (see <a href="#">Figure 5-1</a> ) | 3 V      | 0.93  |     | 1.13  |      | 3.19 |     | $\mu A$ |
| $I_{LPM3, CapTivate, 1 proximity, wake on touch}$ | Low-power mode 3, CapTivate, excludes SVS <sup>(7)</sup>                             | 3.3 V    |       |     | 5     |      |      |     | $\mu A$ |
| $I_{LPM3, CapTivate, 1 button, wake on touch}$    | Low-power mode 3, CapTivate, excludes SVS <sup>(8)</sup>                             | 3.3 V    |       |     | 3.4   |      |      |     | $\mu A$ |
| $I_{LPM3, CapTivate, 4 buttons, wake on touch}$   | Low-power mode 3, CapTivate, excludes SVS <sup>(9)</sup>                             | 3.3 V    |       |     | 3.6   |      |      |     | $\mu A$ |
| $I_{LPM3, CapTivate, 16 buttons}$                 | Low-power mode 3, CapTivate, excludes SVS <sup>(10)</sup>                            | 3.3 V    |       |     | 27.2  |      |      |     | $\mu A$ |
| $I_{LPM3, CapTivate, 64 buttons}$                 | Low-power mode 3, CapTivate, excludes SVS <sup>(11)</sup>                            | 3.3 V    |       |     | 109.2 |      |      |     | $\mu A$ |
| $I_{LPM4, SVS}$                                   | Low-power mode 4, includes SVS                                                       | 3 V      | 0.51  |     | 0.65  |      | 2.65 |     | $\mu A$ |
|                                                   |                                                                                      | 2 V      | 0.49  |     | 0.64  |      | 2.63 |     |         |
| $I_{LPM4}$                                        | Low-power mode 4, excludes SVS                                                       | 3 V      | 0.35  |     | 0.49  |      | 2.49 |     | $\mu A$ |
|                                                   |                                                                                      | 2 V      | 0.34  |     | 0.48  |      | 2.46 |     |         |
| $I_{LPM4, CapTivate, 1 proximity, wake on touch}$ | Low-power mode 4, CapTivate, excludes SVS <sup>(12)</sup>                            | 3 V      |       |     | 4.4   |      |      |     | $\mu A$ |

- (1) All inputs are tied to 0 V or to  $V_{CC}$ . Outputs do not source or sink any current.
- (2) Not applicable for MCUs with HF crystal oscillator only.
- (3) Characterized with a Micro Crystal MS1V-T1K crystal with a load capacitance of 12.5 pF. The internal and external load capacitance are chosen to closely match the required 12.5-pF load.
- (4) Low-power mode 3, 12.5-pF crystal, includes SVS test conditions:  
Current for watchdog timer clocked by ACLK and RTC clocked by XT1 included. Current for brownout and SVS included (SVSHE = 1).  
CPUOFF = 1, SCG0 = 1 SCG1 = 1, OSCOFF = 0 (LPM3),  
 $f_{XT1}$  = 32768 Hz,  $f_{ACLK}$  =  $f_{XT1}$ ,  $f_{MCLK}$  =  $f_{SMCLK}$  = 0 MHz
- (5) Low-power mode 3, VLO, excludes SVS test conditions:  
Current for watchdog timer clocked by VLO included. RTC disabled. Current for brownout included. SVS disabled (SVSHE = 0).  
CPUOFF = 1, SCG0 = 1 SCG1 = 1, OSCOFF = 0 (LPM3)  
 $f_{XT1}$  = 32768 Hz,  $f_{ACLK}$  =  $f_{MCLK}$  =  $f_{SMCLK}$  = 0 MHz
- (6) RTC periodically wakes up every second with external 32768-Hz input as source.
- (7) CapTivate technology works in LPM3 with one proximity sensor for wake on touch. [CapTivate BSWP demonstration board](#) with 1.5-mm overlay. Current for brownout included. SVS disabled (SVSHE = 0).  
 $f_{SCAN}$  = 8 Hz,  $f_{CONVER}$  = 2 MHz, COUNTS = 800
- (8) CapTivate technology works in LPM3 with one button, wake on touch. [CapTivate BSWP demonstration board](#) with 1.5-mm overlay, Current for brownout included. SVS disabled (SVSHE = 0).  
 $f_{SCAN}$  = 8 Hz,  $f_{CONVER}$  = 2 MHz, COUNTS = 250
- (9) CapTivate technology works in LPM3 with four self-capacitance buttons, wake on touch. [CapTivate BSWP demonstration board](#) with 1.5-mm overlay. Current for brownout included. SVS disabled (SVSHE = 0).  
 $f_{SCAN}$  = 8 Hz,  $f_{CONVER}$  = 2 MHz, COUNTS = 250
- (10) CapTivate technology works in LPM3 with 16 self-capacitance buttons. The CPU enters active mode between time cycles to configure the conversions and read the results. [CapTivate BSWP demonstration board](#) with 1.5-mm overlay. Current for brownout included. SVS disabled (SVSHE = 0).  
 $f_{SCAN}$  = 8 Hz,  $f_{CONVER}$  = 2 MHz, COUNTS = 250
- (11) CapTivate technology works in LPM3 with 64 mutual-capacitance buttons. The CPU enters active mode between time cycles to configure the conversions and read the results. TIDM-CAPTIVATE-64-BUTTON 64-Button Capacitive Touch Panel. Current for brownout included. SVS disabled (SVSHE = 0).  
 $f_{SCAN}$  = 8 Hz,  $f_{CONVER}$  = 4 MHz, COUNTS = 250
- (12) CapTivate technology works in LPM4 with one proximity sensor for wake on touch. [CapTivate BSWP demonstration board](#) with 1.5-mm overlay. Current for brownout included. SVS disabled (SVSHE = 0). VLO (10 kHz) sources to CapTivate timer, no external crystal.  
 $f_{SCAN}$  = 8 Hz,  $f_{CONVER}$  = 2 MHz, COUNTS = 800



## Low-Power Mode (LPM3 and LPM4) Supply Currents (Into $V_{CC}$ ) Excluding External Current (continued)

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) <sup>(1)</sup>

| PARAMETER                                        |                                                           | $V_{CC}$ | –40°C |     | 25°C |     | 85°C |     | UNIT |
|--------------------------------------------------|-----------------------------------------------------------|----------|-------|-----|------|-----|------|-----|------|
|                                                  |                                                           |          | TYP   | MAX | TYP  | MAX | TYP  | MAX |      |
| $I_{LPM4}$ , CapTivate, 1 button, wake on touch  | Low-power mode 4, CapTivate, excludes SVS <sup>(13)</sup> | 3 V      |       |     | 2.7  |     |      |     | μA   |
| $I_{LPM4}$ , CapTivate, 4 buttons, wake on touch | Low-power mode 4, CapTivate, excludes SVS <sup>(14)</sup> | 3 V      |       |     | 3.0  |     |      |     | μA   |

(13) CapTivate technology works in LPM4 with one button, wake on touch. [CapTivate BSWP demonstration board](#) with 1.5-mm overlay, Current for brownout included. SVS disabled (SVSHE = 0). VLO (10 kHz) sources to CapTivate timer, no external crystal.

$f_{SCAN} = 8$  Hz,  $f_{CONVER} = 2$  MHz, COUNTS = 250

(14) CapTivate technology works in LPM4 with four self-capacitance buttons, wake on touch. [CapTivate BSWP demonstration board](#) with 1.5-mm overlay. Current for brownout included. SVS disabled (SVSHE = 0). VLO (10 kHz) sources to CapTivate timer, no external crystal.

$f_{SCAN} = 8$  Hz,  $f_{CONVER} = 2$  MHz, COUNTS = 250

## 5.8 Low-Power Mode LPMx.5 Supply Currents (Into $V_{CC}$ ) Excluding External Current

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER          |                                                                                                          | $V_{CC}$ | –40°C |     | 25°C  |       | 85°C  |       | UNIT |
|--------------------|----------------------------------------------------------------------------------------------------------|----------|-------|-----|-------|-------|-------|-------|------|
|                    |                                                                                                          |          | TYP   | MAX | TYP   | MAX   | TYP   | MAX   |      |
| $I_{LPM3.5}$ , XT1 | Low-power mode 3.5, 12.5-pF crystal, includes SVS <sup>(1)(2)(3)</sup> (see <a href="#">Figure 5-2</a> ) | 3 V      | 0.65  |     | 0.73  | 0.95  | 0.99  | 1.42  | μA   |
|                    |                                                                                                          | 2 V      | 0.63  |     | 0.71  |       | 0.87  |       |      |
| $I_{LPM4.5}$ , SVS | Low-power mode 4.5, includes SVS <sup>(4)</sup> (see <a href="#">Figure 5-3</a> )                        | 3 V      | 0.22  |     | 0.24  | 0.31  | 0.30  | 0.38  | μA   |
|                    |                                                                                                          | 2 V      | 0.21  |     | 0.23  |       | 0.28  |       |      |
| $I_{LPM4.5}$       | Low-power mode 4.5, excludes SVS <sup>(5)</sup>                                                          | 3 V      | 0.012 |     | 0.016 | 0.055 | 0.061 | 0.120 | μA   |
|                    |                                                                                                          | 2 V      | 0.002 |     | 0.007 |       | 0.044 |       |      |

(1) Not applicable for MCUs with HF crystal oscillator only.

(2) Characterized with a Micro Crystal MS1V-T1K crystal with a load capacitance of 12.5 pF. The internal and external load capacitance are chosen to closely match the required 12.5-pF load.

(3) Low-power mode 3.5, 12.5-pF crystal, includes SVS test conditions:

Current for RTC clocked by XT1 included. Current for brownout and SVS included (SVSHE = 1). Core regulator disabled.

PMMREGOFF = 1, CPUOFF = 1, SCG0 = 1 SCG1 = 1, OSCOFF = 1 (LPMx.5),

$f_{XT1} = 32768$  Hz,  $f_{ACLK} = 0$ ,  $f_{MCLK} = f_{SMCLK} = 0$  MHz

(4) Low-power mode 4.5, includes SVS test conditions:

Current for brownout and SVS included (SVSHE = 1). Core regulator disabled.

PMMREGOFF = 1, CPUOFF = 1, SCG0 = 1 SCG1 = 1, OSCOFF = 1 (LPMx.5),

$f_{XT1} = 0$  Hz,  $f_{ACLK} = f_{MCLK} = f_{SMCLK} = 0$  MHz

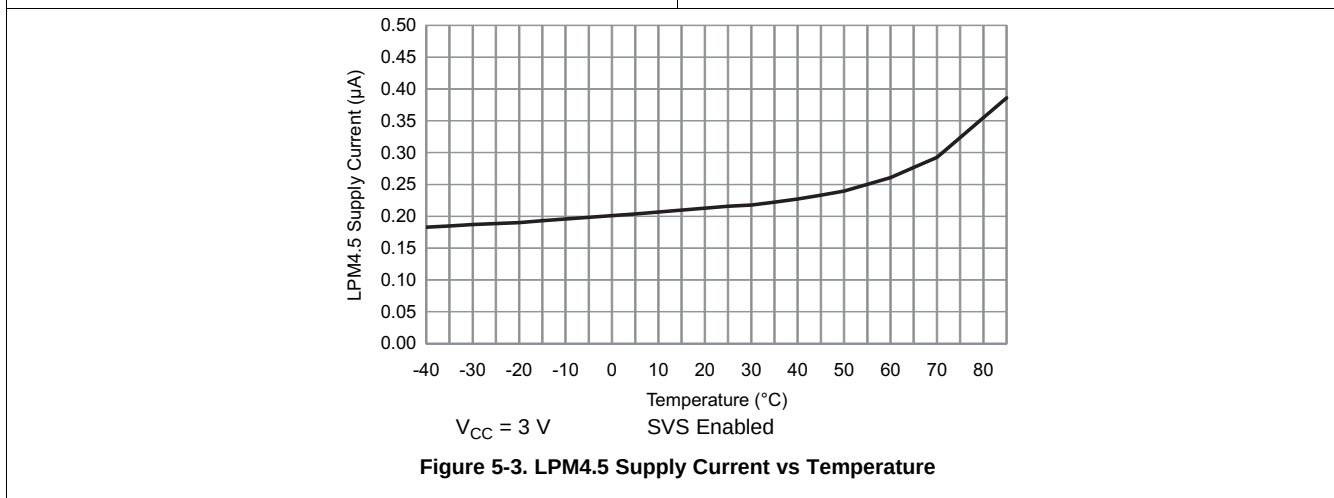
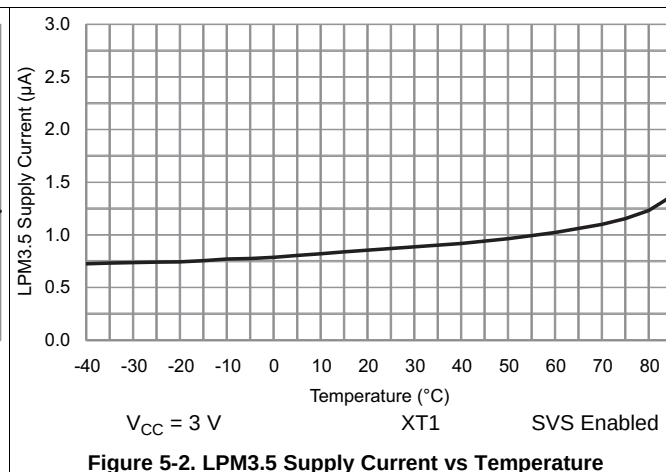
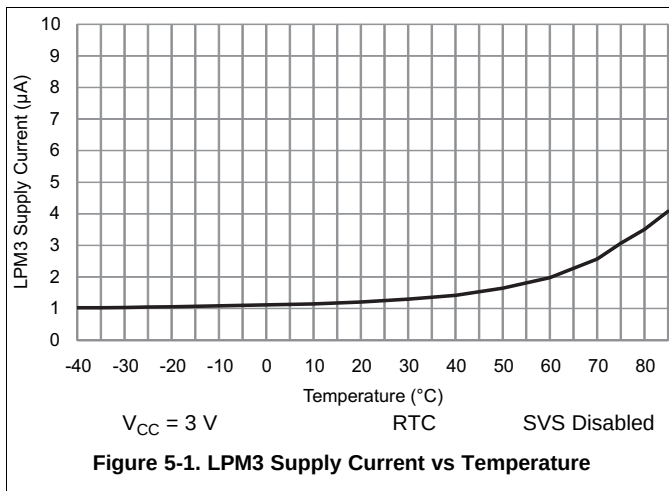
(5) Low-power mode 4.5, excludes SVS test conditions:

Current for brownout included. SVS disabled (SVSHE = 0). Core regulator disabled.

PMMREGOFF = 1, CPUOFF = 1, SCG0 = 1 SCG1 = 1, OSCOFF = 1 (LPMx.5),

$f_{XT1} = 0$  Hz,  $f_{ACLK} = f_{MCLK} = f_{SMCLK} = 0$  MHz

## 5.9 Typical Characteristics - Low-Power Mode Supply Currents



**Table 5-1. Typical Characteristics – Current Consumption Per Module**

| MODULE  | TEST CONDITIONS                  | REFERENCE CLOCK    | MIN | TYP | MAX | UNIT   |
|---------|----------------------------------|--------------------|-----|-----|-----|--------|
| Timer_A |                                  | Module input clock |     | 5   |     | µA/MHz |
| eUSCI_A | UART mode                        | Module input clock |     | 7   |     | µA/MHz |
| eUSCI_A | SPI mode                         | Module input clock |     | 5   |     | µA/MHz |
| eUSCI_B | SPI mode                         | Module input clock |     | 5   |     | µA/MHz |
| eUSCI_B | I <sup>2</sup> C mode, 100 kbaud | Module input clock |     | 5   |     | µA/MHz |
| RTC     |                                  | 32 kHz             |     | 85  |     | nA     |
| CRC     | From start to end of operation   | MCLK               |     | 8.5 |     | µA/MHz |

## 5.10 Thermal Resistance Characteristics

| THERMAL METRIC <sup>(1)</sup>                                     |                    | VALUE <sup>(2)</sup> | UNIT |
|-------------------------------------------------------------------|--------------------|----------------------|------|
| R $\theta_{JA}$ Junction-to-ambient thermal resistance, still air | VQFN 32 pin (RHB)  | 33.5                 | °C/W |
|                                                                   | TSSOP 32 pin (DA)  | 69.4                 |      |
|                                                                   | VQFN 24 pin (RGE)  | 32.6                 |      |
|                                                                   | DSBGA 24 pin (YQW) | 63.7                 |      |
| R $\theta_{JC(top)}$ Junction-to-case (top) thermal resistance    | VQFN 32 pin (RHB)  | 25.7                 | °C/W |
|                                                                   | TSSOP 32 pin (DA)  | 18.1                 |      |
|                                                                   | VQFN 24 pin (RGE)  | 32.4                 |      |
|                                                                   | DSBGA 24 pin (YQW) | 0.3                  |      |
| R $\theta_{JB}$ Junction-to-board thermal resistance              | VQFN 32 pin (RHB)  | 7.6                  | °C/W |
|                                                                   | TSSOP 32 pin (DA)  | 33.1                 |      |
|                                                                   | VQFN 24 pin (RGE)  | 10.1                 |      |
|                                                                   | DSBGA 24 pin (YQW) | 9.2                  |      |

(1) For more information about traditional and new thermal metrics, see [Semiconductor and IC Package Thermal Metrics](#).

(2) These values are based on a JEDEC-defined 2S2P system (with the exception of the Theta JC (R $\theta_{JC}$ ) value, which is based on a JEDEC-defined 1S0P system) and will change based on environment and application. For more information, see these EIA/JEDEC standards:

- JESD51-2, *Integrated Circuits Thermal Test Method Environmental Conditions - Natural Convection (Still Air)*
- JESD51-3, *Low Effective Thermal Conductivity Test Board for Leaded Surface Mount Packages*
- JESD51-7, *High Effective Thermal Conductivity Test Board for Leaded Surface Mount Packages*
- JESD51-9, *Test Boards for Area Array Surface Mount Package Thermal Measurements*

## 5.11 Timing and Switching Characteristics

### 5.11.1 Power Supply Sequencing

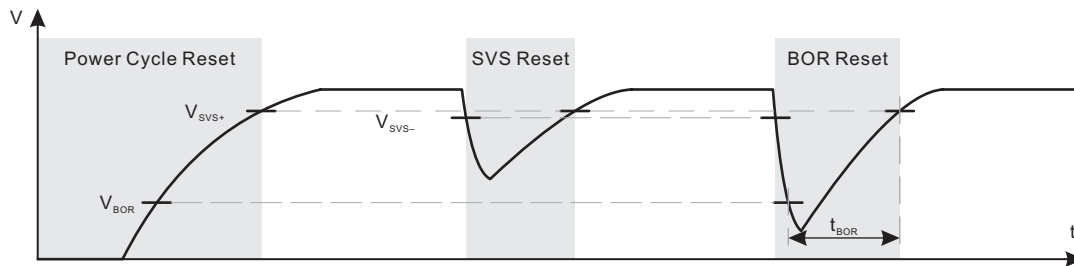
Table 5-2 lists the characteristics of the SVS and BOR.

**Table 5-2. PMM, SVS and BOR**

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 5-4)

| PARAMETER               | TEST CONDITIONS                                       | MIN   | TYP  | MAX   | UNIT |
|-------------------------|-------------------------------------------------------|-------|------|-------|------|
| $V_{BOR, \text{ safe}}$ | Safe BOR power-down level <sup>(1)</sup>              | 0.1   |      |       | V    |
| $t_{BOR, \text{ safe}}$ | Safe BOR reset delay <sup>(2)</sup>                   | 10    |      |       | ms   |
| $I_{SVSH, AM}$          | SVS <sub>H</sub> current consumption, active mode     |       |      | 1.5   | μA   |
| $I_{SVSH, LPM}$         | SVS <sub>H</sub> current consumption, low-power modes |       | 240  |       | nA   |
| $V_{SVSH-}$             | SVS <sub>H</sub> power-down level <sup>(3)</sup>      | 1.71  | 1.80 | 1.86  | V    |
| $V_{SVSH+}$             | SVS <sub>H</sub> power-up level <sup>(3)</sup>        | 1.74  | 1.89 | 1.99  | V    |
| $V_{SVSH, \text{ hys}}$ | SVS <sub>H</sub> hysteresis                           |       | 80   |       | mV   |
| $t_{PD, SVSH, AM}$      | SVS <sub>H</sub> propagation delay, active mode       |       |      | 10    | μs   |
| $t_{PD, SVSH, LPM}$     | SVS <sub>H</sub> propagation delay, low-power modes   |       |      | 100   | μs   |
| $V_{REF, 1.2V}$         | 1.2-V REF voltage <sup>(4)</sup>                      | 1.158 | 1.20 | 1.242 | V    |

- (1) A safe BOR can be correctly generated only if DVCC drops below this voltage before it rises.
- (2) When an BOR occurs, a safe BOR can be correctly generated only if DVCC is kept low longer than this period before it reaches  $V_{SVSH+}$ .
- (3) For additional information, see the [Dynamic Voltage Scaling Power Solution for MSP430 Devices With Single-Channel LDO Reference Design](#).
- (4) This is a characterized result with external 1-mA load to ground from –40°C to 85°C.



**Figure 5-4. Power Cycle, SVS, and BOR Reset Conditions**

### 5.11.2 Reset Timing

Table 5-3 lists the wake-up times.

**Table 5-3. Wake-up Times From Low-Power Modes and Reset**

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER                   |                                                                                                                                                                              | TEST CONDITIONS | V <sub>CC</sub> | MIN | TYP                             | MAX | UNIT |
|-----------------------------|------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|-----------------|-----------------|-----|---------------------------------|-----|------|
| t <sub>WAKE-UP FRAM</sub>   | Additional wake-up time to activate the FRAM in AM if previously disabled by the FRAM controller or from a LPM if immediate activation is selected for wakeup <sup>(1)</sup> |                 | 3 V             |     | 10                              |     | μs   |
| t <sub>WAKE-UP LPM0</sub>   | Wake-up time from LPM0 to active mode <sup>(1)</sup>                                                                                                                         |                 | 3 V             |     | 200 +<br>2.5 / f <sub>DCO</sub> |     | ns   |
| t <sub>WAKE-UP LPM3</sub>   | Wake-up time from LPM3 to active mode <sup>(2)</sup>                                                                                                                         |                 | 3 V             |     | 10                              |     | μs   |
| t <sub>WAKE-UP LPM4</sub>   | Wake-up time from LPM4 to active mode                                                                                                                                        |                 | 3 V             |     | 10                              |     | μs   |
| t <sub>WAKE-UP LPM3.5</sub> | Wake-up time from LPM3.5 to active mode <sup>(2)</sup>                                                                                                                       |                 | 3 V             |     | 350                             |     | μs   |
| t <sub>WAKE-UP LPM4.5</sub> | Wake-up time from LPM4.5 to active mode <sup>(2)</sup>                                                                                                                       | SVSHE = 1       | 3 V             |     | 350                             |     | μs   |
|                             |                                                                                                                                                                              | SVSHE = 0       |                 |     | 1                               |     | ms   |
| t <sub>WAKE-UP-RESET</sub>  | Wake-up time from $\overline{\text{RST}}$ or BOR event to active mode <sup>(2)</sup>                                                                                         |                 | 3 V             |     | 1                               |     | ms   |
| t <sub>RESET</sub>          | Pulse duration required at $\overline{\text{RST}}$ /NMI pin to accept a reset                                                                                                |                 | 3 V             |     | 2                               |     | μs   |

- (1) The wake-up time is measured from the edge of an external wake-up signal (for example, port interrupt or wake-up event) to the first externally observable MCLK clock edge.
- (2) The wake-up time is measured from the edge of an external wake-up signal (for example, port interrupt or wake-up event) until the first instruction of the user program is executed.

### 5.11.3 Clock Specifications

Table 5-4 lists the characteristics of XT1.

**Table 5-4. XT1 Crystal Oscillator (Low Frequency)**

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)<sup>(1)</sup>

| PARAMETER                | TEST CONDITIONS                                          | V <sub>CC</sub> | MIN | TYP    | MAX  | UNIT |
|--------------------------|----------------------------------------------------------|-----------------|-----|--------|------|------|
| f <sub>XT1, LF</sub>     | XT1 oscillator crystal, low frequency                    |                 |     | 32768  |      | Hz   |
| DC <sub>XT1, LF</sub>    | XT1 oscillator LF duty cycle                             |                 | 30% |        | 70%  |      |
| f <sub>XT1, SW</sub>     | XT1 oscillator logic-level square-wave input frequency   |                 |     | 32.768 |      | kHz  |
| DC <sub>XT1, SW</sub>    | LFXT oscillator logic-level square-wave input duty cycle |                 | 40% |        | 60%  |      |
| OA <sub>LFXT</sub>       | Oscillation allowance for LF crystals <sup>(4)</sup>     |                 |     | 200    |      | kΩ   |
| C <sub>L, eff</sub>      | Integrated effective load capacitance <sup>(5)</sup>     |                 |     | 1      |      | pF   |
| t <sub>START, LFXT</sub> | Start-up time <sup>(7)</sup>                             |                 |     | 1000   |      | ms   |
| f <sub>Fault, LFXT</sub> | Oscillator fault frequency <sup>(8)</sup>                |                 | 0   |        | 3500 | Hz   |

- (1) To improve EMI on the LFXT oscillator, observe the following guidelines:
  - Keep the trace between the device and the crystal as short as possible.
  - Design a good ground plane around the oscillator pins.
  - Prevent crosstalk from other clock or data lines into oscillator pins XIN and XOUT.
  - Avoid running PCB traces underneath or adjacent to the XIN and XOUT pins.
  - Use assembly materials and processes that avoid any parasitic load on the oscillator XIN and XOUT pins.
  - If conformal coating is used, make sure that it does not induce capacitive or resistive leakage between the oscillator pins.
- (2) When LFXTBYPASS is set, LFXT circuits are automatically powered down. Input signal is a digital square wave with parametrics defined in the Schmitt-trigger inputs section of this data sheet. Duty cycle requirements are defined by DC<sub>LFXT, SW</sub>.
- (3) Maximum frequency of operation of the entire device cannot be exceeded.
- (4) Oscillation allowance is based on a safety factor of 5 for recommended crystals. The oscillation allowance is a function of the LFXTDRIVE settings and the effective load. In general, comparable oscillator allowance can be achieved based on the following guidelines, but should be evaluated based on the actual crystal selected for the application:
  - For LFXTDRIVE = {0}, C<sub>L, eff</sub> = 3.7 pF
  - For LFXTDRIVE = {1}, 6 pF ≤ C<sub>L, eff</sub> ≤ 9 pF
  - For LFXTDRIVE = {2}, 6 pF ≤ C<sub>L, eff</sub> ≤ 10 pF
  - For LFXTDRIVE = {3}, 6 pF ≤ C<sub>L, eff</sub> ≤ 12 pF
- (5) Includes parasitic bond and package capacitance (approximately 2 pF per pin).
- (6) Requires external capacitors at both terminals to meet the effective load capacitance specified by crystal manufacturers. Recommended effective load capacitance values supported are 3.7 pF, 6 pF, 9 pF, and 12.5 pF. Maximum shunt capacitance of 1.6 pF. The PCB adds additional capacitance, so it must also be considered in the overall capacitance. Verify that the recommended effective load capacitance of the selected crystal is met.
- (7) Includes start-up counter of 1024 clock cycles.
- (8) Frequencies above the MAX specification do not set the fault flag. Frequencies between the MIN and MAX specifications might set the flag. A static condition or stuck at fault condition sets the flag.
- (9) Measured with logic-level input frequency but also applies to operation with crystals.

Table 5-5 lists the characteristics of the FLL.

**Table 5-5. DCO FLL, Frequency**

over recommended operating free-air temperature (unless otherwise noted)

| PARAMETER             | TEST CONDITIONS                           | V <sub>CC</sub> | MIN   | TYP | MAX  | UNIT |
|-----------------------|-------------------------------------------|-----------------|-------|-----|------|------|
| f <sub>DCO, FLL</sub> | FLL lock frequency, 16 MHz, 25°C          | 3 V             | –1.0% |     | 1.0% |      |
|                       | FLL lock frequency, 16 MHz, –40°C to 85°C | 3 V             | –2.0% |     | 2.0% |      |
|                       | FLL lock frequency, 16 MHz, –40°C to 85°C | 3 V             | –0.5% |     | 0.5% |      |

**Table 5-5. DCO FLL, Frequency (continued)**

over recommended operating free-air temperature (unless otherwise noted)

| PARAMETER                                          | TEST CONDITIONS                            | V <sub>CC</sub> | MIN | TYP    | MAX | UNIT |
|----------------------------------------------------|--------------------------------------------|-----------------|-----|--------|-----|------|
| f <sub>DUTY</sub> Duty cycle                       | Measured at MCLK, XT1 crystal as reference | 3 V             | 40% | 50%    | 60% |      |
| Jitter <sub>cc</sub> Cycle-to-cycle jitter, 16 MHz |                                            | 3 V             |     | 0.25%  |     |      |
| Jitter <sub>long</sub> Long term jitter, 16 MHz    |                                            | 3 V             |     | 0.022% |     |      |
| t <sub>FLL, lock</sub> FLL lock time               |                                            | 3 V             |     | 280    |     | ms   |
| t <sub>start-up</sub> DCO start-up time, 2 MHz     | Measured at MCLK                           | 3 V             |     | 16     |     | μs   |

Table 5-6 lists the characteristics of the DCO.

**Table 5-6. DCO Frequency**

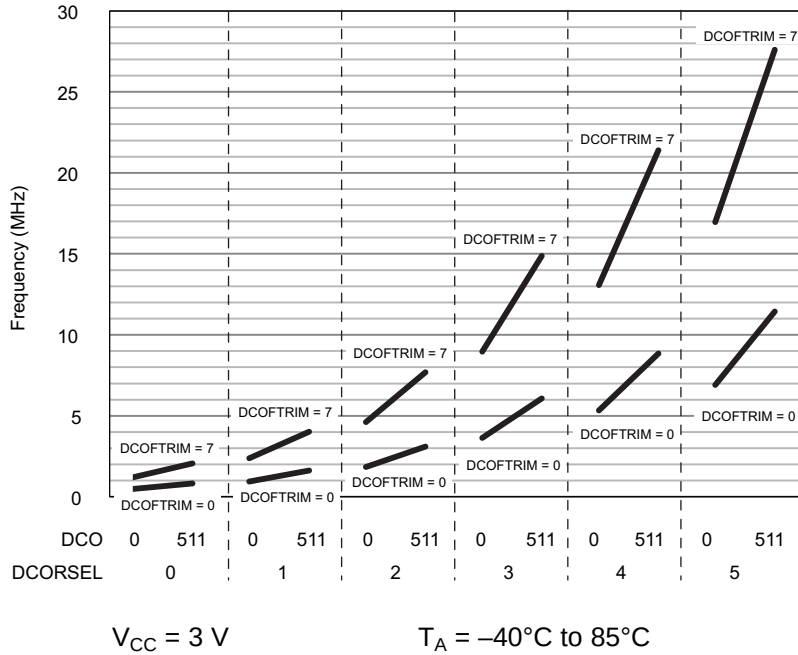
over recommended operating free-air temperature (unless otherwise noted) (also see Figure 5-5)

| PARAMETER                                     | TEST CONDITIONS                                                          | V <sub>CC</sub> | TYP    | UNIT |
|-----------------------------------------------|--------------------------------------------------------------------------|-----------------|--------|------|
| f <sub>DCO, 16MHz</sub> DCO frequency, 16 MHz | DCORSEL = 101b, DISMOD = 1b, DCOFTRIMEN = 1b, DCOFTRIM = 000b, DCO = 0   | 3 V             | 7.46   | MHz  |
|                                               | DCORSEL = 101b, DISMOD = 1b, DCOFTRIMEN = 1b, DCOFTRIM = 000b, DCO = 511 |                 | 12.26  |      |
|                                               | DCORSEL = 101b, DISMOD = 1b, DCOFTRIMEN = 1b, DCOFTRIM = 111b, DCO = 0   |                 | 17.93  |      |
|                                               | DCORSEL = 101b, DISMOD = 1b, DCOFTRIMEN = 1b, DCOFTRIM = 111b, DCO = 511 |                 | 29.1   |      |
| f <sub>DCO, 12MHz</sub> DCO frequency, 12 MHz | DCORSEL = 100b, DISMOD = 1b, DCOFTRIMEN = 1b, DCOFTRIM = 000b, DCO = 0   | 3 V             | 5.75   | MHz  |
|                                               | DCORSEL = 100b, DISMOD = 1b, DCOFTRIMEN = 1b, DCOFTRIM = 000b, DCO = 511 |                 | 9.5    |      |
|                                               | DCORSEL = 100b, DISMOD = 1b, DCOFTRIMEN = 1b, DCOFTRIM = 111b, DCO = 0   |                 | 13.85  |      |
|                                               | DCORSEL = 100b, DISMOD = 1b, DCOFTRIMEN = 1b, DCOFTRIM = 111b, DCO = 511 |                 | 22.5   |      |
| f <sub>DCO, 8MHz</sub> DCO frequency, 8 MHz   | DCORSEL = 011b, DISMOD = 1b, DCOFTRIMEN = 1b, DCOFTRIM = 000b, DCO = 0   | 3 V             | 3.91   | MHz  |
|                                               | DCORSEL = 011b, DISMOD = 1b, DCOFTRIMEN = 1b, DCOFTRIM = 000b, DCO = 511 |                 | 6.49   |      |
|                                               | DCORSEL = 011b, DISMOD = 1b, DCOFTRIMEN = 1b, DCOFTRIM = 111b, DCO = 0   |                 | 9.5    |      |
|                                               | DCORSEL = 011b, DISMOD = 1b, DCOFTRIMEN = 1b, DCOFTRIM = 111b, DCO = 511 |                 | 15.6   |      |
| f <sub>DCO, 4MHz</sub> DCO frequency, 4 MHz   | DCORSEL = 010b, DISMOD = 1b, DCOFTRIMEN = 1b, DCOFTRIM = 000b, DCO = 0   | 3 V             | 2.026  | MHz  |
|                                               | DCORSEL = 010b, DISMOD = 1b, DCOFTRIMEN = 1b, DCOFTRIM = 000b, DCO = 511 |                 | 3.407  |      |
|                                               | DCORSEL = 010b, DISMOD = 1b, DCOFTRIMEN = 1b, DCOFTRIM = 111b, DCO = 0   |                 | 4.95   |      |
|                                               | DCORSEL = 010b, DISMOD = 1b, DCOFTRIMEN = 1b, DCOFTRIM = 111b, DCO = 511 |                 | 8.26   |      |
| f <sub>DCO, 2MHz</sub> DCO frequency, 2 MHz   | DCORSEL = 001b, DISMOD = 1b, DCOFTRIMEN = 1b, DCOFTRIM = 000b, DCO = 0   | 3 V             | 1.0225 | MHz  |
|                                               | DCORSEL = 001b, DISMOD = 1b, DCOFTRIMEN = 1b, DCOFTRIM = 000b, DCO = 511 |                 | 1.729  |      |
|                                               | DCORSEL = 001b, DISMOD = 1b, DCOFTRIMEN = 1b, DCOFTRIM = 111b, DCO = 0   |                 | 2.525  |      |
|                                               | DCORSEL = 001b, DISMOD = 1b, DCOFTRIMEN = 1b, DCOFTRIM = 111b, DCO = 511 |                 | 4.25   |      |

**Table 5-6. DCO Frequency (continued)**

over recommended operating free-air temperature (unless otherwise noted) (also see [Figure 5-5](#))

| PARAMETER                                   | TEST CONDITIONS                                                          | V <sub>CC</sub> | TYP    | UNIT |
|---------------------------------------------|--------------------------------------------------------------------------|-----------------|--------|------|
| f <sub>DCO, 1MHz</sub> DCO frequency, 1 MHz | DCORSEL = 000b, DISMOD = 1b, DCOFTRIMEN = 1b, DCOFTRIM = 000b, DCO = 0   | 3 V             | 0.5319 | MHz  |
|                                             | DCORSEL = 000b, DISMOD = 1b, DCOFTRIMEN = 1b, DCOFTRIM = 000b, DCO = 511 |                 | 0.9029 |      |
|                                             | DCORSEL = 000b, DISMOD = 1b, DCOFTRIMEN = 1b, DCOFTRIM = 111b, DCO = 0   |                 | 1.307  |      |
|                                             | DCORSEL = 000b, DISMOD = 1b, DCOFTRIMEN = 1b, DCOFTRIM = 111b, DCO = 511 |                 | 2.21   |      |



**Figure 5-5. Typical DCO Frequency**

[Table 5-7](#) lists the characteristics of the REFO.

**Table 5-7. REFO**

over recommended operating free-air temperature (unless otherwise noted)

| PARAMETER                            | TEST CONDITIONS                     | V <sub>CC</sub>                         | MIN | TYP   | MAX | UNIT |
|--------------------------------------|-------------------------------------|-----------------------------------------|-----|-------|-----|------|
| I <sub>REFO</sub>                    | REFO oscillator current consumption | T <sub>A</sub> = 25°C                   |     | 15    |     | μA   |
| f <sub>REFO</sub>                    | REFO calibrated frequency           | Measured at MCLK                        |     | 32768 |     | Hz   |
|                                      | REFO absolute calibrated tolerance  | -40°C to 85°C                           |     |       |     |      |
| df <sub>REFO</sub> /dT               | REFO frequency temperature drift    | Measured at MCLK <sup>(1)</sup>         |     | 0.01  |     | %/°C |
| df <sub>REFO</sub> /dV <sub>CC</sub> | REFO frequency supply voltage drift | Measured at MCLK at 25°C <sup>(2)</sup> |     | 1     |     | %/V  |
| f <sub>DC</sub>                      | REFO duty cycle                     | Measured at MCLK                        | 40% | 50%   | 60% |      |
| t <sub>START</sub>                   | REFO start-up time                  | 40% to 60% duty cycle                   |     | 50    |     | μs   |

(1) Calculated using the box method: (MAX(-40°C to 85°C) – MIN(-40°C to 85°C)) / MIN(-40°C to 85°C) / (85°C – (-40°C))

(2) Calculated using the box method: (MAX(1.8 V to 3.6 V) – MIN(1.8 V to 3.6 V)) / MIN(1.8 V to 3.6 V) / (3.6 V – 1.8 V)



Table 5-8 lists the characteristics of the VLO.

#### NOTE

The VLO clock frequency is reduced by 15% (typical) when the device switches from active mode to LPM3 or LPM4, because the reference changes. This lower frequency is not a violation of the VLO specifications (see Table 5-8).

**Table 5-8. Internal Very-Low-Power Low-Frequency Oscillator (VLO)**

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER                                                              | TEST CONDITIONS                 | V <sub>CC</sub> | TYP | UNIT |
|------------------------------------------------------------------------|---------------------------------|-----------------|-----|------|
| f <sub>VLO</sub> VLO frequency                                         | Measured at MCLK                | 3 V             | 10  | kHz  |
| df <sub>VLO</sub> /dT VLO frequency temperature drift                  | Measured at MCLK <sup>(1)</sup> | 3 V             | 0.5 | %/°C |
| df <sub>VLO</sub> /dV <sub>CC</sub> VLO frequency supply voltage drift | Measured at MCLK <sup>(2)</sup> | 2 V to 3.6 V    | 4   | %/V  |
| f <sub>VLO,DC</sub> Duty cycle                                         | Measured at MCLK                | 3 V             | 50% |      |

(1) Calculated using the box method: (MAX(–40°C to 85°C) – MIN(–40°C to 85°C)) / MIN(–40°C to 85°C) / (85°C – (–40°C))

(2) Calculated using the box method: (MAX(1.8 V to 3.6 V) – MIN(1.8 V to 3.6 V)) / MIN(1.8 V to 3.6 V) / (3.6 V – 1.8 V)

Table 5-9 lists the characteristics of the MODOSC.

**Table 5-9. Module Oscillator (MODOSC)**

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER                                                                   | V <sub>CC</sub> | MIN | TYP   | MAX | UNIT |
|-----------------------------------------------------------------------------|-----------------|-----|-------|-----|------|
| f <sub>MODOSC</sub> MODOSC frequency                                        | 3 V             | 3.8 | 4.8   | 5.8 | MHz  |
| f <sub>MODOSC</sub> /dT MODOSC frequency temperature drift                  | 3 V             |     | 0.102 |     | %/°C |
| f <sub>MODOSC</sub> /dV <sub>CC</sub> MODOSC frequency supply voltage drift | 1.8 V to 3.6 V  |     | 1.02  |     | %/V  |
| f <sub>MODOSC,DC</sub> Duty cycle                                           | 3 V             | 40% | 50%   | 60% |      |

### 5.11.4 Digital I/Os

Table 5-10 lists the characteristics of the digital inputs.

**Table 5-10. Digital Inputs**

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER                                                                                                           | TEST CONDITIONS                                                                                  | V <sub>CC</sub> | MIN  | TYP | MAX  | UNIT |
|---------------------------------------------------------------------------------------------------------------------|--------------------------------------------------------------------------------------------------|-----------------|------|-----|------|------|
| V <sub>IT+</sub> Positive-going input threshold voltage                                                             |                                                                                                  | 2 V             | 0.90 |     | 1.50 | V    |
|                                                                                                                     |                                                                                                  | 3 V             | 1.35 |     | 2.25 |      |
| V <sub>IT–</sub> Negative-going input threshold voltage                                                             |                                                                                                  | 2 V             | 0.50 |     | 1.10 | V    |
|                                                                                                                     |                                                                                                  | 3 V             | 0.75 |     | 1.65 |      |
| V <sub>hys</sub> Input voltage hysteresis (V <sub>IT+</sub> – V <sub>IT–</sub> )                                    |                                                                                                  | 2 V             | 0.3  |     | 0.8  | V    |
|                                                                                                                     |                                                                                                  | 3 V             | 0.4  |     | 1.2  |      |
| R <sub>Pull</sub> Pullup or pulldown resistor                                                                       | For pullup: V <sub>IN</sub> = V <sub>SS</sub><br>For pulldown: V <sub>IN</sub> = V <sub>CC</sub> |                 | 20   | 35  | 50   | kΩ   |
| C <sub>I,dig</sub> Input capacitance, digital only port pins                                                        | V <sub>IN</sub> = V <sub>SS</sub> or V <sub>CC</sub>                                             |                 |      | 3   |      | pF   |
| C <sub>I,ana</sub> Input capacitance, port pins with shared analog functions                                        | V <sub>IN</sub> = V <sub>SS</sub> or V <sub>CC</sub>                                             |                 |      | 5   |      | pF   |
| I <sub>lkg(Px.y)</sub> High-impedance leakage current                                                               | See <sup>(1)</sup> <sup>(2)</sup>                                                                | 2 V, 3 V        | –20  |     | 20   | nA   |
| t <sub>(int)</sub> External interrupt timing (external trigger pulse duration to set interrupt flag) <sup>(3)</sup> | Ports with interrupt capability (see block diagram and terminal function descriptions)           | 2 V, 3 V        | 50   |     |      | ns   |

- (1) The leakage current is measured with V<sub>SS</sub> or V<sub>CC</sub> applied to the corresponding pins, unless otherwise noted.
- (2) The leakage of the digital port pins is measured individually. The port pin is selected for input and the pullup or pulldown resistor is disabled.
- (3) An external signal sets the interrupt flag every time the minimum interrupt pulse duration t<sub>(int)</sub> is met. It may be set by trigger signals shorter than t<sub>(int)</sub>.

Table 5-11 lists the characteristics of the digital outputs.

**Table 5-11. Digital Outputs**

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (also see Figure 5-6, Figure 5-7, Figure 5-8, and Figure 5-9)

| PARAMETER                                                           | TEST CONDITIONS                             | V <sub>CC</sub> | MIN | TYP | MAX  | UNIT |
|---------------------------------------------------------------------|---------------------------------------------|-----------------|-----|-----|------|------|
| V <sub>OH</sub> High-level output voltage                           | I <sub>(OHmax)</sub> = –3 mA <sup>(1)</sup> | 2 V             | 1.4 |     | 2.0  | V    |
|                                                                     | I <sub>(OHmax)</sub> = –5 mA <sup>(1)</sup> | 3 V             | 2.4 |     | 3.0  |      |
| V <sub>OL</sub> Low-level output voltage                            | I <sub>(OLmax)</sub> = 3 mA <sup>(1)</sup>  | 2 V             | 0.0 |     | 0.60 | V    |
|                                                                     | I <sub>(OHmax)</sub> = 5 mA <sup>(1)</sup>  | 3 V             | 0.0 |     | 0.60 |      |
| f <sub>Port_CLK</sub> Clock output frequency                        | C <sub>L</sub> = 20 pF <sup>(2)</sup>       | 2 V             | 16  |     |      | MHz  |
|                                                                     |                                             | 3 V             | 16  |     |      |      |
| t <sub>rise,dig</sub> Port output rise time, digital only port pins | C <sub>L</sub> = 20 pF                      | 2 V             |     | 10  |      | ns   |
|                                                                     |                                             | 3 V             |     | 7   |      |      |
| t <sub>fall,dig</sub> Port output fall time, digital only port pins | C <sub>L</sub> = 20 pF                      | 2 V             |     | 10  |      | ns   |
|                                                                     |                                             | 3 V             |     | 5   |      |      |

- (1) The maximum total current, I<sub>(OHmax)</sub> and I<sub>(OLmax)</sub>, for all outputs combined should not exceed ±48 mA to hold the maximum voltage drop specified.
- (2) The port can output frequencies at least up to the specified limit and might support higher frequencies.

#### 5.11.4.1 Typical Characteristics – Outputs at 3 V and 2 V

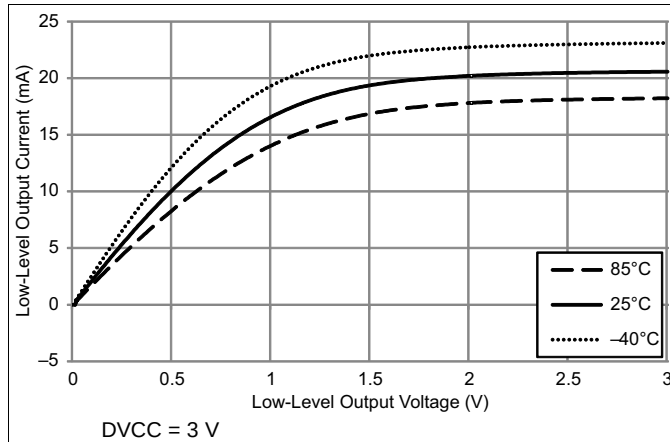


Figure 5-6. Typical Low-Level Output Current vs Low-Level Output Voltage

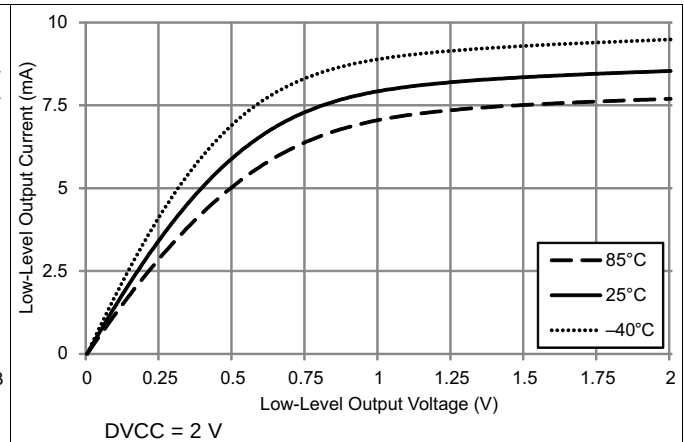


Figure 5-7. Typical Low-Level Output Current vs Low-Level Output Voltage

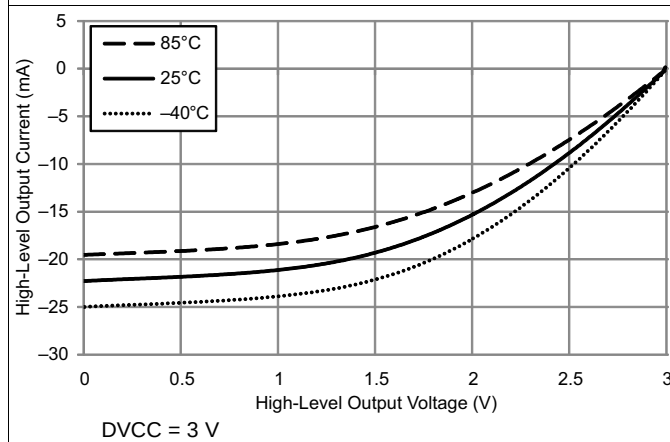


Figure 5-8. Typical High-Level Output Current vs High-Level Output Voltage

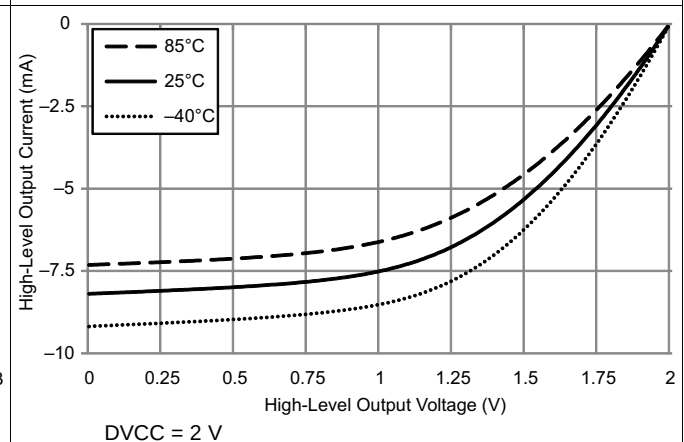


Figure 5-9. Typical High-Level Output Current vs High-Level Output Voltage

### 5.11.5 VREF+ Built-in Reference

Table 5-12 lists the characteristics of VREF+.

**Table 5-12. VREF+**

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER          | TEST CONDITIONS                                       | V <sub>CC</sub>                     | MIN      | TYP  | MAX  | UNIT   |
|--------------------|-------------------------------------------------------|-------------------------------------|----------|------|------|--------|
| V <sub>REF+</sub>  | Positive built-in reference voltage                   | EXTREFEN = 1 with 1-mA load current | 2 V, 3 V | 1.15 | 1.19 | 1.23 V |
| TC <sub>REF+</sub> | Temperature coefficient of built-in reference voltage |                                     |          | 30   |      | μV/°C  |

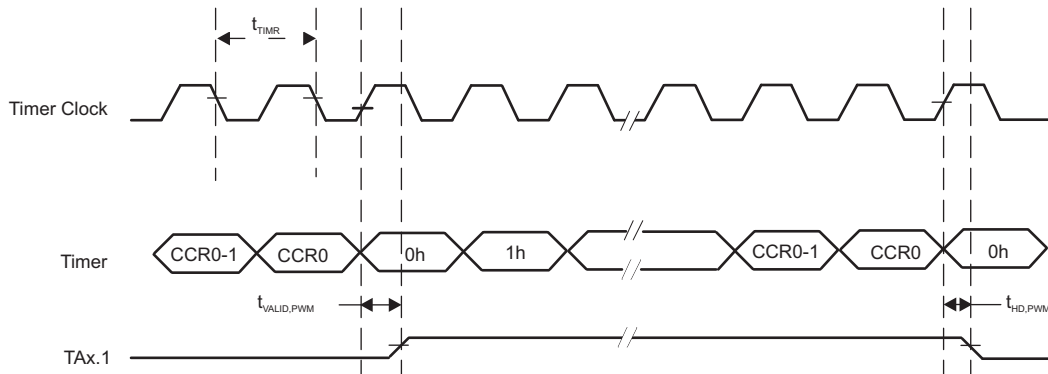
### 5.11.6 Timer\_A

Table 5-13 lists the characteristics of Timer\_A.

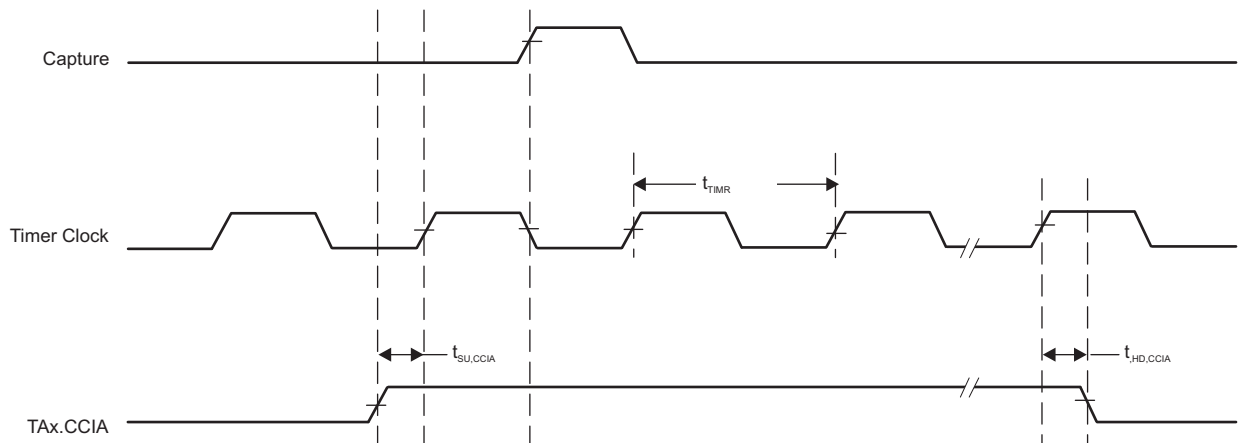
**Table 5-13. Timer\_A**

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 5-10 and Figure 5-11)

| PARAMETER           | TEST CONDITIONS               | V <sub>CC</sub>                                                       | MIN      | TYP | MAX | UNIT |
|---------------------|-------------------------------|-----------------------------------------------------------------------|----------|-----|-----|------|
| f <sub>TA</sub>     | Timer_A input clock frequency | Internal: SMCLK or ACLK,<br>External: TACLK,<br>duty cycle = 50% ±10% | 2 V, 3 V |     | 16  | MHz  |
| t <sub>TA,cap</sub> | Timer_A capture timing        | All capture inputs, minimum pulse duration required for capture       | 2 V, 3 V | 20  |     | ns   |



**Figure 5-10. Timer PWM Mode**



**Figure 5-11. Timer Capture Mode**

### 5.11.7 eUSCI

Table 5-14 lists the supported frequencies of the eUSCI in UART mode.

**Table 5-14. eUSCI (UART Mode) Clock Frequency**

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER                                                              | TEST CONDITIONS                                                  | V <sub>CC</sub> | MIN | MAX | UNIT |
|------------------------------------------------------------------------|------------------------------------------------------------------|-----------------|-----|-----|------|
| f <sub>eUSCI</sub> eUSCI input clock frequency                         | Internal: SMCLK or MODCLK, External: UCLK, duty cycle = 50% ±10% | 2 V, 3 V        |     | 16  | MHz  |
| f <sub>BITCLK</sub> BITCLK clock frequency (equals baud rate in Mbaud) |                                                                  | 2 V, 3 V        |     | 5   | MHz  |

Table 5-15 lists the characteristics of the eUSCI in UART mode.

**Table 5-15. eUSCI (UART Mode)**

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER                                                | TEST CONDITIONS | V <sub>CC</sub> | TYP | UNIT |
|----------------------------------------------------------|-----------------|-----------------|-----|------|
| t <sub>t</sub> UART receive deglitch time <sup>(1)</sup> | UCGLITx = 0     | 2 V, 3 V        | 12  | ns   |
|                                                          | UCGLITx = 1     |                 | 40  |      |
|                                                          | UCGLITx = 2     |                 | 68  |      |
|                                                          | UCGLITx = 3     |                 | 110 |      |

- (1) Pulses on the UART receive input (UCxRX) shorter than the UART receive deglitch time are suppressed. To ensure that pulses are correctly recognized, their duration should exceed the maximum specification of the deglitch time.

Table 5-16 lists the supported frequencies of the eUSCI in SPI master mode.

**Table 5-16. eUSCI (SPI Master Mode) Clock Frequency**

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER                                      | TEST CONDITIONS                                  | MIN | MAX | UNIT |
|------------------------------------------------|--------------------------------------------------|-----|-----|------|
| f <sub>eUSCI</sub> eUSCI input clock frequency | Internal: SMCLK or MODCLK, duty cycle = 50% ±10% |     | 8   | MHz  |

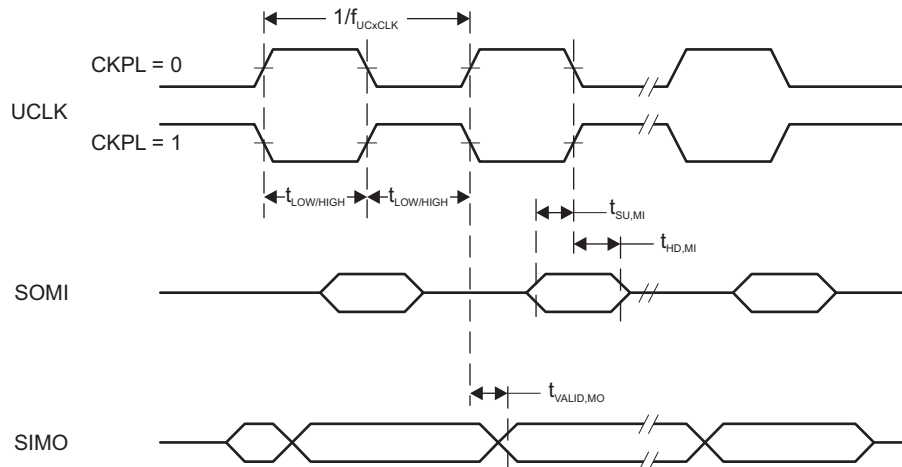
Table 5-17 lists the characteristics of the eUSCI in SPI master mode.

**Table 5-17. eUSCI (SPI Master Mode)**

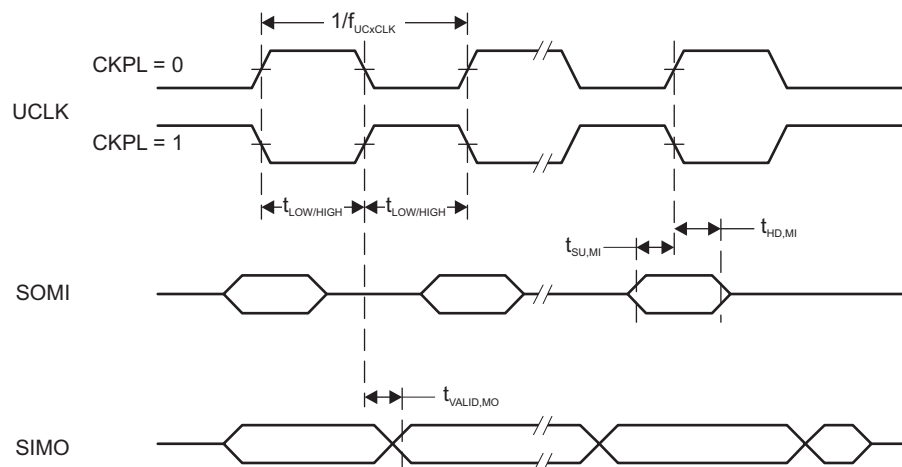
over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)<sup>(1)</sup>

| PARAMETER                                                        | TEST CONDITIONS                                 | V <sub>CC</sub> | MIN | MAX | UNIT          |
|------------------------------------------------------------------|-------------------------------------------------|-----------------|-----|-----|---------------|
| t <sub>STE,LEAD</sub> STE lead time, STE active to clock         | UCSTEM = 0, UCMODEx = 01 or 10                  |                 | 1   |     | UCxCLK cycles |
|                                                                  | UCSTEM = 1, UCMODEx = 01 or 10                  |                 |     |     |               |
| t <sub>STE,LAG</sub> STE lag time, last clock to STE inactive    | UCSTEM = 0, UCMODEx = 01 or 10                  |                 | 1   |     | UCxCLK cycles |
|                                                                  | UCSTEM = 1, UCMODEx = 01 or 10                  |                 |     |     |               |
| t <sub>SU,MI</sub> SOMI input data setup time                    |                                                 | 2 V             | 45  |     | ns            |
|                                                                  |                                                 | 3 V             | 35  |     |               |
| t <sub>HD,MI</sub> SOMI input data hold time                     |                                                 | 2 V             | 0   |     | ns            |
|                                                                  |                                                 | 3 V             | 0   |     |               |
| t <sub>VALID,MO</sub> SIMO output data valid time <sup>(2)</sup> | UCLK edge to SIMO valid, C <sub>L</sub> = 20 pF | 2 V             |     | 20  | ns            |
|                                                                  |                                                 | 3 V             |     | 20  |               |
| t <sub>HD,MO</sub> SIMO output data hold time <sup>(3)</sup>     | C <sub>L</sub> = 20 pF                          | 2 V             | 0   |     | ns            |
|                                                                  |                                                 | 3 V             | 0   |     |               |

- (1)  $f_{UCxCLK} = 1 / 2t_{LO/Hi}$  with  $t_{LO/Hi} = \max(t_{VALID,MO}(eUSCI) + t_{SU,SI}(Slave), t_{SU,MI}(eUSCI) + t_{VALID,SO}(Slave))$   
 For the slave parameters  $t_{SU,SI}(Slave)$  and  $t_{VALID,SO}(Slave)$ , see the SPI parameters of the attached slave.
- (2) Specifies the time to drive the next valid data to the SIMO output after the output changing UCLK clock edge. See the timing diagrams in Figure 5-12 and Figure 5-13.
- (3) Specifies how long data on the SIMO output is valid after the output changing UCLK clock edge. Negative values indicate that the data on the SIMO output can become invalid before the output changing clock edge observed on UCLK. See the timing diagrams in Figure 5-12 and Figure 5-13.



**Figure 5-12. SPI Master Mode, CKPH = 0**



**Figure 5-13. SPI Master Mode, CKPH = 1**

Table 5-18 lists the characteristics of the eUSCI in SPI slave mode.

**Table 5-18. eUSCI (SPI Slave Mode)**

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)<sup>(1)</sup>

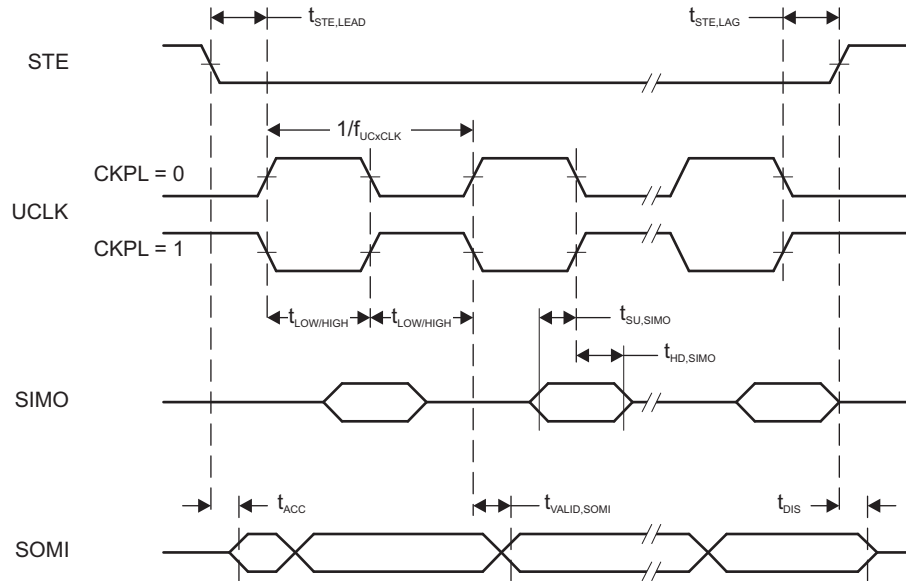
| PARAMETER             |                                                       | TEST CONDITIONS                                    | V <sub>CC</sub> | MIN | MAX | UNIT |
|-----------------------|-------------------------------------------------------|----------------------------------------------------|-----------------|-----|-----|------|
| t <sub>STE,LEAD</sub> | STE lead time, STE active to clock                    |                                                    | 2 V             | 55  |     | ns   |
|                       |                                                       |                                                    | 3 V             | 45  |     |      |
| t <sub>STE,LAG</sub>  | STE lag time, Last clock to STE inactive              |                                                    | 2 V             | 20  |     | ns   |
|                       |                                                       |                                                    | 3 V             | 20  |     |      |
| t <sub>STE,ACC</sub>  | STE access time, STE active to SOMI data out          |                                                    | 2 V             |     | 65  | ns   |
|                       |                                                       |                                                    | 3 V             |     | 40  |      |
| t <sub>STE,DIS</sub>  | STE disable time, STE inactive to SOMI high impedance |                                                    | 2 V             |     | 40  | ns   |
|                       |                                                       |                                                    | 3 V             |     | 35  |      |
| t <sub>SU,SI</sub>    | SIMO input data setup time                            |                                                    | 2 V             | 6   |     | ns   |
|                       |                                                       |                                                    | 3 V             | 4   |     |      |
| t <sub>HD,SI</sub>    | SIMO input data hold time                             |                                                    | 2 V             | 12  |     | ns   |
|                       |                                                       |                                                    | 3 V             | 12  |     |      |
| t <sub>VALID,SO</sub> | SOMI output data valid time <sup>(2)</sup>            | UCLK edge to SOMI valid,<br>C <sub>L</sub> = 20 pF | 2 V             |     | 65  | ns   |
|                       |                                                       |                                                    | 3 V             |     | 40  |      |
| t <sub>HD,SO</sub>    | SOMI output data hold time <sup>(3)</sup>             | C <sub>L</sub> = 20 pF                             | 2 V             | 5   |     | ns   |
|                       |                                                       |                                                    | 3 V             | 5   |     |      |

(1)  $f_{UCXCLK} = 1/2t_{LO/HI}$  with  $t_{LO/HI} \geq \max(t_{VALID,MO(Master)} + t_{SU,SI(eUSCI)}, t_{SU,MI(Master)} + t_{VALID,SO(eUSCI)})$

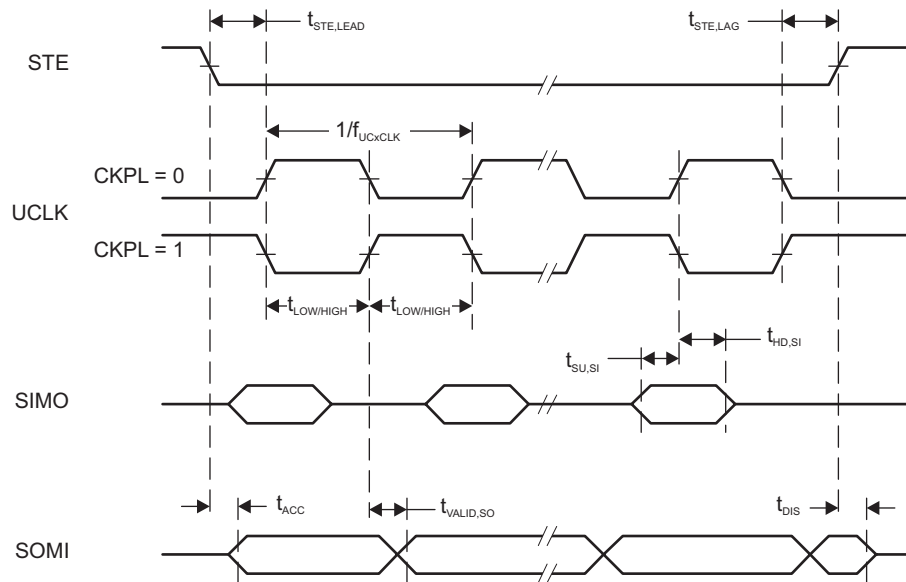
For the master parameters  $t_{SU,MI(Master)}$  and  $t_{VALID,MO(Master)}$ , see the SPI parameters of the attached master.

(2) Specifies the time to drive the next valid data to the SOMI output after the output changing UCLK clock edge. See the timing diagrams in [Figure 5-14](#) and [Figure 5-15](#).

(3) Specifies how long data on the SOMI output is valid after the output changing UCLK clock edge. See the timing diagrams in [Figure 5-14](#) and [Figure 5-15](#).



**Figure 5-14. SPI Slave Mode, CKPH = 0**



**Figure 5-15. SPI Slave Mode, CKPH = 1**

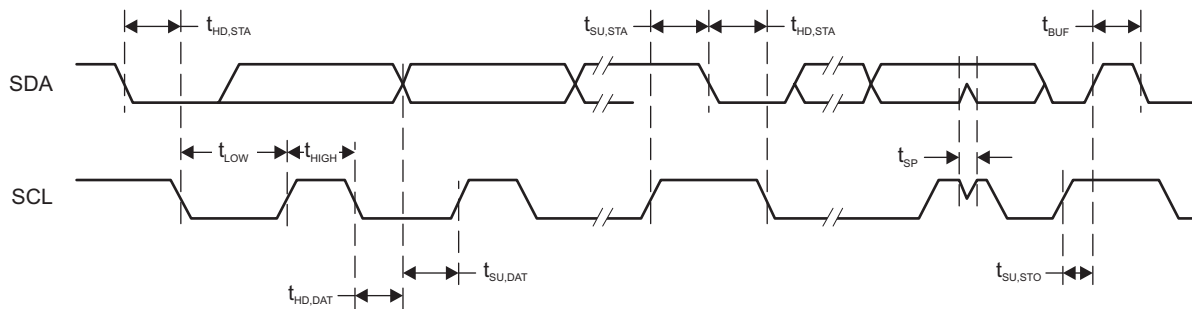


Table 5-19 lists the characteristics of the eUSCI in I<sup>2</sup>C mode.

**Table 5-19. eUSCI (I<sup>2</sup>C Mode)**

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 5-16)

| PARAMETER                                                           | TEST CONDITIONS                                                       | V <sub>CC</sub> | MIN                     | TYP            | MAX                     | UNIT |
|---------------------------------------------------------------------|-----------------------------------------------------------------------|-----------------|-------------------------|----------------|-------------------------|------|
| f <sub>eUSCI</sub> eUSCI input clock frequency                      | Internal: SMCLK or MODCLK,<br>External: UCLK<br>Duty cycle = 50% ±10% |                 |                         |                | 16                      | MHz  |
| f <sub>SCL</sub> SCL clock frequency                                |                                                                       | 2 V, 3 V        | 0                       |                | 400                     | kHz  |
| t <sub>HD,STA</sub> Hold time (repeated) START                      | f <sub>SCL</sub> = 100 kHz<br>f <sub>SCL</sub> > 100 kHz              | 2 V, 3 V        | 4.0<br>0.6              |                |                         | μs   |
| t <sub>SU,STA</sub> Setup time for a repeated START                 | f <sub>SCL</sub> = 100 kHz<br>f <sub>SCL</sub> > 100 kHz              | 2 V, 3 V        | 4.7<br>0.6              |                |                         | μs   |
| t <sub>HD,DAT</sub> Data hold time                                  |                                                                       | 2 V, 3 V        | 0                       |                |                         | ns   |
| t <sub>SU,DAT</sub> Data setup time                                 |                                                                       | 2 V, 3 V        | 250                     |                |                         | ns   |
| t <sub>SU,STO</sub> Setup time for STOP                             | f <sub>SCL</sub> = 100 kHz<br>f <sub>SCL</sub> > 100 kHz              | 2 V, 3 V        | 4.0<br>0.6              |                |                         | μs   |
| t <sub>SP</sub> Pulse duration of spikes suppressed by input filter | UCGLITx = 0<br>UCGLITx = 1<br>UCGLITx = 2<br>UCGLITx = 3              | 2 V, 3 V        | 50<br>25<br>12.5<br>6.3 |                | 600<br>300<br>150<br>75 | ns   |
| t <sub>TIMEOUT</sub> Clock low time-out                             | UCCLTOx = 1<br>UCCLTOx = 2<br>UCCLTOx = 3                             | 2 V, 3 V        |                         | 27<br>30<br>33 |                         | ms   |



**Figure 5-16. I<sup>2</sup>C Mode Timing**

### 5.11.8 ADC

Table 5-20 lists the input requirements of the ADC.

**Table 5-20. ADC, Power Supply and Input Range Conditions**

over operating free-air temperature range (unless otherwise noted)

| PARAMETER                                                                                                                | TEST CONDITIONS                                                                                                     | V <sub>CC</sub> | MIN | TYP | MAX              | UNIT |
|--------------------------------------------------------------------------------------------------------------------------|---------------------------------------------------------------------------------------------------------------------|-----------------|-----|-----|------------------|------|
| DV <sub>CC</sub> ADC supply voltage                                                                                      |                                                                                                                     |                 | 2.0 |     | 3.6              | V    |
| V <sub>(Ax)</sub> Analog input voltage range                                                                             | All ADC pins                                                                                                        |                 | 0   |     | DV <sub>CC</sub> | V    |
| I <sub>ADC</sub> Operating supply current into DVCC terminal, reference current not included, repeat-single-channel mode | f <sub>ADCCLK</sub> = 5 MHz, ADCON = 1, REFON = 0, SHT0 = 0, SHT1 = 0, ADCDIV = 0, ADCCONSEQx = 10b                 | 2 V             |     | 185 |                  | μA   |
|                                                                                                                          |                                                                                                                     | 3 V             |     | 207 |                  |      |
| C <sub>I</sub> Input capacitance                                                                                         | Only one terminal Ax can be selected at one time, from the pad to the ADC capacitor array, including wiring and pad | 2.2 V           |     | 1.6 | 2.0              | pF   |
| R <sub>I,MUX</sub> Input MUX ON resistance                                                                               | DV <sub>CC</sub> = 2 V, 0 V ≤ V <sub>Ax</sub> ≤ DV <sub>CC</sub>                                                    |                 |     |     | 2                | kΩ   |
| R <sub>I,Misc</sub> Input miscellaneous resistance                                                                       |                                                                                                                     |                 |     | 34  |                  | kΩ   |

Table 5-21 lists the timing parameters of the ADC.

**Table 5-21. ADC, 10-Bit Timing Parameters**

over operating free-air temperature range (unless otherwise noted)

| PARAMETER                                            | TEST CONDITIONS                                                                                                                                                                   | V <sub>CC</sub> | MIN  | TYP                             | MAX  | UNIT |
|------------------------------------------------------|-----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|-----------------|------|---------------------------------|------|------|
| f <sub>ADCCLK</sub>                                  | For specified performance of ADC linearity parameters                                                                                                                             | 2 V to 3.6 V    | 0.45 | 5                               | 5.5  | MHz  |
| f <sub>ADCOSC</sub> Internal ADC oscillator (MODOSC) | ADCDIV = 0, f <sub>ADCCLK</sub> = f <sub>ADCOSC</sub>                                                                                                                             | 2 V to 3.6 V    | 4.5  | 5.0                             | 5.5  | MHz  |
| t <sub>CONVERT</sub> Conversion time                 | REFON = 0, Internal oscillator, 10 ADCCLK cycles, 10-bit mode, f <sub>ADCOSC</sub> = 4.5 MHz to 5.5 MHz                                                                           | 2 V to 3.6 V    | 2.18 |                                 | 2.67 | μs   |
|                                                      | External f <sub>ADCCLK</sub> from ACLK or SMCLK, ADCSSEL ≠ 0                                                                                                                      | 2 V to 3.6 V    |      | 12 ×<br>1 / f <sub>ADCCLK</sub> |      |      |
| t <sub>ADCON</sub> Turnon settling time of the ADC   | The error in a conversion started after t <sub>ADCON</sub> is less than ±0.5 LSB, Reference and input signal already settled                                                      |                 |      |                                 | 100  | ns   |
| t <sub>Sample</sub> Sampling time                    | R <sub>S</sub> = 1000 Ω, R <sub>I</sub> <sup>(1)</sup> = 36000 Ω, C <sub>I</sub> = 3.5 pF, Approximately 8 Tau (t) are required for an error of less than ±0.5 LSB <sup>(2)</sup> | 2 V             | 1.5  |                                 |      | μs   |
|                                                      |                                                                                                                                                                                   | 3 V             | 2.0  |                                 |      |      |

(1) R<sub>I</sub> = R<sub>I,MUX</sub> + R<sub>I,Misc</sub>

(2) t<sub>Sample</sub> = ln(2<sup>n+1</sup>) × τ, where n = ADC resolution, τ = (R<sub>I</sub> + R<sub>S</sub>) × C<sub>I</sub>

Table 5-22 lists the linearity parameters of the ADC.

**Table 5-22. ADC, 10-Bit Linearity Parameters**

over operating free-air temperature range (unless otherwise noted)

| PARAMETER                       |                                                               | TEST CONDITIONS                                                                      | V <sub>CC</sub> | MIN   | TYP  | MAX  | UNIT  |
|---------------------------------|---------------------------------------------------------------|--------------------------------------------------------------------------------------|-----------------|-------|------|------|-------|
| E <sub>I</sub>                  | Integral linearity error (10-bit mode)                        | V <sub>ref+</sub> as reference                                                       | 2.4 V to 3.6 V  | –2    |      | 2    | LSB   |
|                                 | Integral linearity error (8-bit mode)                         |                                                                                      | 2 V to 3.6 V    | –2    |      | 2    |       |
| E <sub>D</sub>                  | Differential linearity error (10-bit mode)                    | V <sub>ref+</sub> as reference                                                       | 2.4 V to 3.6 V  | –1    |      | 1    | LSB   |
|                                 | Differential linearity error (8-bit mode)                     |                                                                                      | 2 V to 3.6 V    | –1    |      | 1    |       |
| E <sub>O</sub>                  | Offset error (10-bit mode)                                    | V <sub>ref+</sub> as reference                                                       | 2.4 V to 3.6 V  | –6.5  |      | 6.5  | mV    |
|                                 | Offset error (8-bit mode)                                     |                                                                                      | 2 V to 3.6 V    | –6.5  |      | 6.5  |       |
| E <sub>G</sub>                  | Gain error (10-bit mode)                                      | V <sub>ref+</sub> as reference                                                       | 2.4 V to 3.6 V  | –2.0  |      | 2.0  | LSB   |
|                                 |                                                               | Internal 1.5-V reference                                                             |                 | –3.0% |      | 3.0% |       |
|                                 | Gain error (8-bit mode)                                       | V <sub>ref+</sub> as reference                                                       | 2 V to 3.6 V    | –2.0  |      | 2.0  | LSB   |
|                                 |                                                               | Internal 1.5-V reference                                                             |                 | –3.0% |      | 3.0% |       |
| E <sub>T</sub>                  | Total unadjusted error (10-bit mode)                          | V <sub>ref+</sub> as reference                                                       | 2.4 V to 3.6 V  | –2.0  |      | 2.0  | LSB   |
|                                 |                                                               | Internal 1.5-V reference                                                             |                 | –3.0% |      | 3.0% |       |
|                                 | Total unadjusted error (8-bit mode)                           | V <sub>ref+</sub> as reference                                                       | 2 V to 3.6 V    | –2.0  |      | 2.0  | LSB   |
|                                 |                                                               | Internal 1.5-V reference                                                             |                 | –3.0% |      | 3.0% |       |
| V <sub>SENSOR</sub>             | See <sup>(1)</sup>                                            | ADCON = 1, INCH = 0Ch, T <sub>A</sub> = 0°C                                          | 3 V             |       | 913  |      | mV    |
| TC <sub>SENSOR</sub>            | See <sup>(2)</sup>                                            | ADCON = 1, INCH = 0Ch                                                                | 3 V             |       | 3.35 |      | mV/°C |
| t <sub>SENSOR</sub><br>(sample) | Sample time required if channel 12 is selected <sup>(3)</sup> | ADCON = 1, INCH = 0Ch, Error of conversion result ≤1 LSB, AM and all LPMs above LPM3 | 3 V             |       | 30   |      | μs    |
|                                 |                                                               | ADCON = 1, INCH = 0Ch, Error of conversion result ≤1 LSB, LPM3                       | 3 V             |       | 100  |      |       |

(1) The temperature sensor offset can vary significantly. TI recommends a single-point calibration to minimize the offset error of the built-in temperature sensor.

(2) The device descriptor structure contains calibration values for 30°C and 85°C for each available reference voltage level. The sensor voltage can be computed as  $V_{SENSE} = TC_{SENSOR} \times (\text{Temperature, } ^\circ\text{C}) + V_{SENSOR}$ , where TC<sub>SENSOR</sub> and V<sub>SENSOR</sub> can be computed from the calibration values for higher accuracy.

(3) The typical equivalent impedance of the sensor is 700 kΩ. The sample time required includes the sensor on time, t<sub>SENSOR(on)</sub>.

### 5.11.9 CapTivate

Table 5-23 lists the characteristics of the CapTivate module.

**Table 5-23. CapTivate Electrical Characteristics**

over operating free-air temperature range (unless otherwise noted)

| PARAMETER                | TEST CONDITIONS                                                        | MIN                                                     | TYP  | MAX | UNIT |
|--------------------------|------------------------------------------------------------------------|---------------------------------------------------------|------|-----|------|
| V <sub>REG</sub>         | Reference voltage output                                               | 1.5                                                     | 1.55 | 1.6 | V    |
| C <sub>REG</sub>         | External buffer capacitor                                              | ESR ≤ 200 mΩ                                            | 0.8  | 1   | 1.2  |
| C <sub>ELECTRODE</sub>   | Maximum capacitance of all external electrodes on all CapTivate blocks | Running a conversion at 4 MHz                           |      | 300 | pF   |
| t <sub>WAKEUP,COLD</sub> | Voltage regulator wake-up time                                         | LDO completely off then turned on                       |      | 1   | ms   |
| t <sub>WAKEUP,WARM</sub> | Voltage regulator wake-up time                                         | LDO in low-power mode then turned on                    |      | 300 | us   |
| f <sub>CAPCLK</sub>      | Captivate oscillator frequency, nominal                                | T <sub>A</sub> = 25°C, CAPCLK0, FREQSHFT = 00b          | –3%  | 16  | +3%  |
| DC <sub>CAPCLK</sub>     | CapTivate oscillator duty cycle                                        | Excluding first clock cycle, DC = t <sub>high</sub> × f | 40%  | 50% | 60%  |

Table 5-24 lists the signal-to-noise ratio of the CapTivate module.

**Table 5-24. CapTivate Signal-to-Noise Ratio Characteristics**

over operating free-air temperature range from –40°C to 105°C ambient (T<sub>A</sub>), unless otherwise noted

| PARAMETER | TEST CONDITIONS                                                                                                     | MIN | TYP  | MAX | UNIT |
|-----------|---------------------------------------------------------------------------------------------------------------------|-----|------|-----|------|
| SNR       | T <sub>A</sub> = 25°C, C <sub>t</sub> > 0.5 pF, C <sub>p</sub> < 20 pF, >2.5% change in capacitance <sup>(2)</sup>  | 5:1 | 36:1 |     |      |
|           | T <sub>A</sub> = 0°C, C <sub>t</sub> > 0.5 pF, C <sub>p</sub> < 20 pF, >2.5% change in capacitance <sup>(2)</sup>   |     | 28:1 |     |      |
|           | T <sub>A</sub> = –40°C, C <sub>t</sub> > 0.5 pF, C <sub>p</sub> < 20 pF, >2.5% change in capacitance <sup>(2)</sup> |     | 19:1 |     |      |

- (1) SNR is defined as the ratio of the measured change in electrode capacitance due to a touch compared with the measured change in capacitance due to the device noise floor. For additional detail on SNR in capacitive sensing applications and how to measure it in your system, see [Sensitivity, SNR, and Design Margin in Capacitive Touch Applications](#).
- (2) C<sub>t</sub> represents the increase or decrease in electrode capacitance due to a touch. C<sub>p</sub> represents the inherent parasitic capacitance of the sensing electrode that is present when no touch is applied. Therefore, the touch signal is defined as C<sub>t</sub>/C<sub>p</sub>, expressed as a percent change in capacitance. Increasing C<sub>t</sub> or decreasing C<sub>p</sub> increases signal.

### 5.11.10 FRAM

Table 5-25 lists the characteristics of the FRAM.

**Table 5-25. FRAM**

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER                | TEST CONDITIONS            | MIN              | TYP                                  | MAX | UNIT   |
|--------------------------|----------------------------|------------------|--------------------------------------|-----|--------|
| Read and write endurance |                            | 10 <sup>15</sup> |                                      |     | cycles |
| t <sub>Retention</sub>   | T <sub>J</sub> = 25°C      | 100              |                                      |     | years  |
|                          | T <sub>J</sub> = 70°C      | 40               |                                      |     |        |
|                          | T <sub>J</sub> = 85°C      | 10               |                                      |     |        |
| I <sub>WRITE</sub>       | Current to write into FRAM |                  | I <sub>READ</sub> <sup>(1)</sup>     |     | nA     |
| I <sub>ERASE</sub>       | Erase current              |                  | N/A <sup>(2)</sup>                   |     | nA     |
| t <sub>WRITE</sub>       | Write time                 |                  | t <sub>READ</sub> <sup>(3)</sup>     |     | ns     |
| t <sub>READ</sub>        | NWAITSx = 0                |                  | 1/f <sub>SYSTEM</sub> <sup>(4)</sup> |     | ns     |
|                          | NWAITSx = 1                |                  | 2/f <sub>SYSTEM</sub> <sup>(4)</sup> |     |        |

- (1) Writing to FRAM does not require a setup sequence or additional power when compared to reading from FRAM. The FRAM read current I<sub>READ</sub> is included in the active mode current consumption parameter I<sub>AM,FRAM</sub>.
- (2) FRAM does not require a special erase sequence.
- (3) Writing into FRAM is as fast as reading.
- (4) The maximum read (and write) speed is specified by f<sub>SYSTEM</sub> using the appropriate wait state settings (NWAITSx).

### 5.11.11 Debug and Emulation

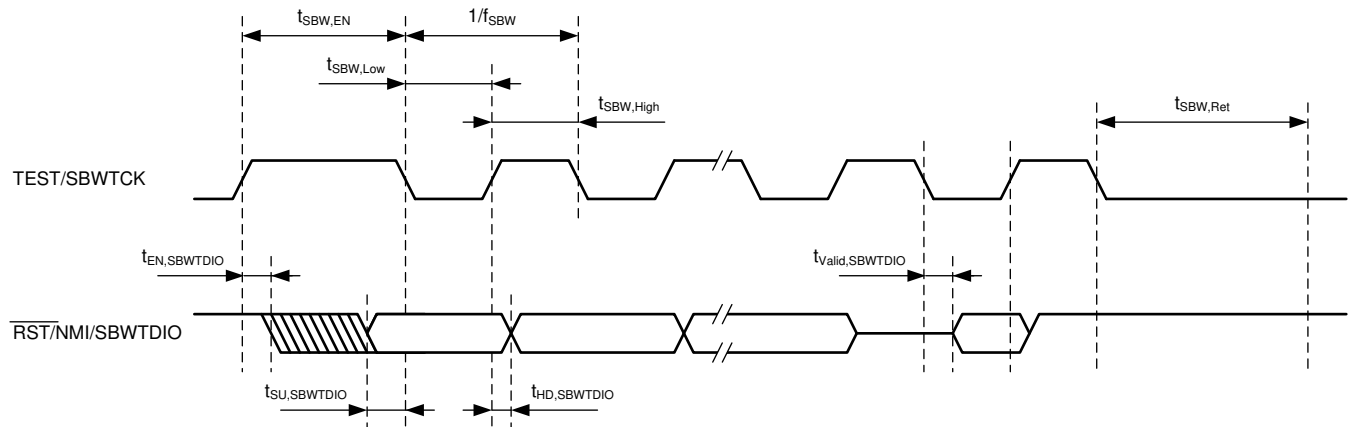
Table 5-26 lists the characteristics of the Spy-Bi-Wire interface.

**Table 5-26. JTAG, Spy-Bi-Wire Interface**

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 5-17)

| PARAMETER                   |                                                                                      | V <sub>CC</sub> | MIN   | TYP | MAX | UNIT |
|-----------------------------|--------------------------------------------------------------------------------------|-----------------|-------|-----|-----|------|
| f <sub>SBW</sub>            | Spy-Bi-Wire input frequency                                                          | 2 V, 3 V        | 0     |     | 10  | MHz  |
| t <sub>SBW,Low</sub>        | Spy-Bi-Wire low clock pulse duration                                                 | 2 V, 3 V        | 0.028 |     | 15  | μs   |
| t <sub>SU, SBWTDIO</sub>    | SBWTDIO setup time (before falling edge of SBWTCK in TMS and TDI slot, Spy-Bi-Wire)  | 2 V, 3 V        | 4     |     |     | ns   |
| t <sub>HD, SBWTDIO</sub>    | SBWTDIO hold time (after rising edge of SBWTCK in TMS and TDI slot, Spy-Bi-Wire)     | 2 V, 3 V        | 19    |     |     | ns   |
| t <sub>Valid, SBWTDIO</sub> | SBWTDIO data valid time (after falling edge of SBWTCK in TDO slot, Spy-Bi-Wire)      | 2 V, 3 V        |       |     | 31  | ns   |
| t <sub>SBW, En</sub>        | Spy-Bi-Wire enable time (TEST high to acceptance of first clock edge) <sup>(1)</sup> | 2 V, 3 V        |       |     | 110 | μs   |
| t <sub>SBW, Ret</sub>       | Spy-Bi-Wire return to normal operation time <sup>(2)</sup>                           | 2 V, 3 V        | 15    |     | 100 | μs   |
| R <sub>internal</sub>       | Internal pulldown resistance on TEST                                                 | 2 V, 3 V        | 20    | 35  | 50  | kΩ   |

- (1) Tools that access the Spy-Bi-Wire interface must wait for the t<sub>SBW,En</sub> time after pulling the TEST/SBWTCK pin high before applying the first SBWTCK clock edge.
- (2) Maximum t<sub>SBW,Ret</sub> time after pulling or releasing the TEST/SBWTCK pin low until the Spy-Bi-Wire pins revert from their Spy-Bi-Wire function to their application function. This time applies only if the Spy-Bi-Wire mode is selected.



**Figure 5-17. JTAG Spy-Bi-Wire Timing**

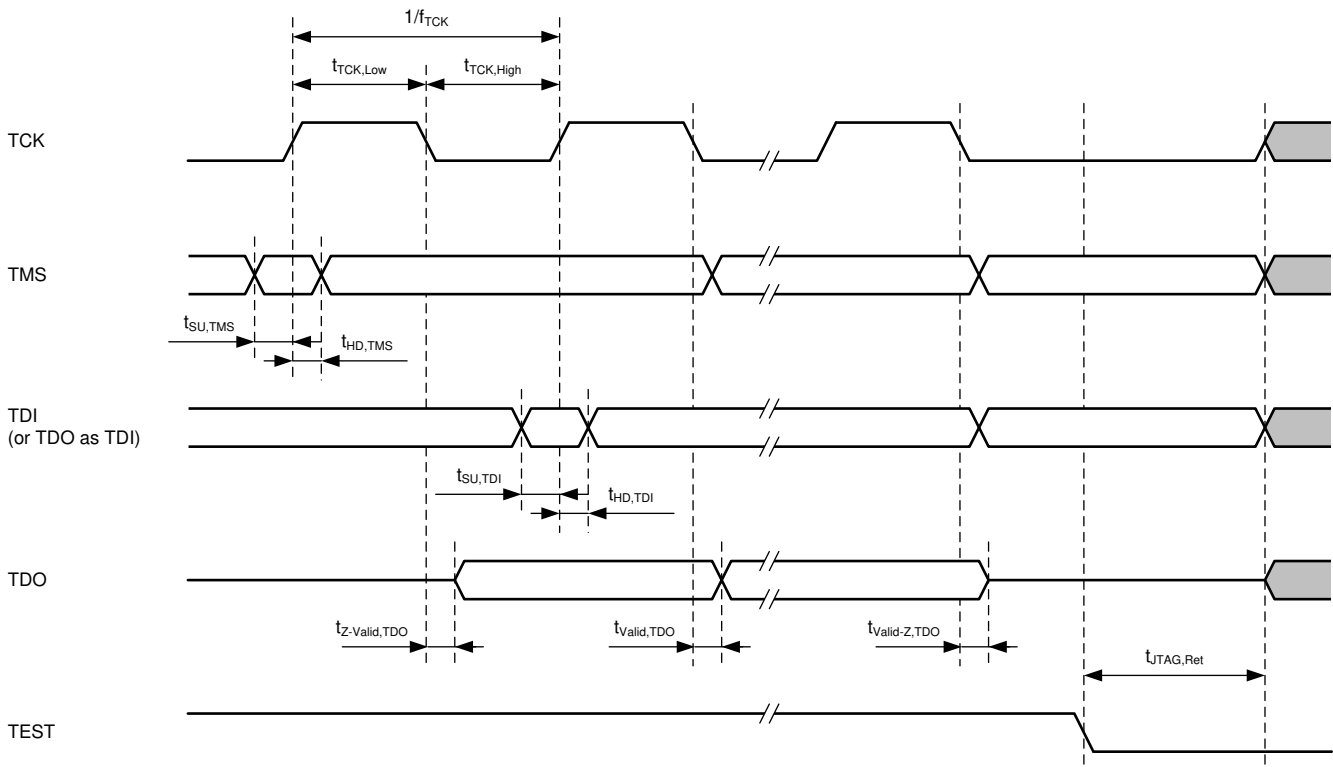
Table 5-27 lists the characteristics of the 4-wire JTAG interface.

**Table 5-27. JTAG, 4-Wire Interface**

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 5-18)

| PARAMETER                |                                                                     | V <sub>CC</sub> | MIN | TYP | MAX | UNIT |
|--------------------------|---------------------------------------------------------------------|-----------------|-----|-----|-----|------|
| f <sub>TCK</sub>         | TCK input frequency <sup>(1)</sup>                                  | 2 V, 3 V        | 0   |     | 10  | MHz  |
| t <sub>TCK,Low</sub>     | TCK low clock pulse duration                                        | 2 V, 3 V        | 15  |     |     | ns   |
| t <sub>TCK,High</sub>    | TCK high clock pulse duration                                       | 2 V, 3 V        | 15  |     |     | ns   |
| t <sub>SU,TMS</sub>      | TMS setup time (before rising edge of TCK)                          | 2 V, 3 V        | 11  |     |     | ns   |
| t <sub>HD,TMS</sub>      | TMS hold time (after rising edge of TCK)                            | 2 V, 3 V        | 3   |     |     | ns   |
| t <sub>SU,TDI</sub>      | TDI setup time (before rising edge of TCK)                          | 2 V, 3 V        | 13  |     |     | ns   |
| t <sub>HD,TDI</sub>      | TDI hold time (after rising edge of TCK)                            | 2 V, 3 V        | 5   |     |     | ns   |
| t <sub>Z-Valid,TDO</sub> | TDO high impedance to valid output time (after falling edge of TCK) | 2 V, 3 V        |     |     | 26  | ns   |
| t <sub>Valid,TDO</sub>   | TDO to new valid output time (after falling edge of TCK)            | 2 V, 3 V        |     |     | 26  | ns   |
| t <sub>Valid-Z,TDO</sub> | TDO valid to high-impedance output time (after falling edge of TCK) | 2 V, 3 V        |     |     | 26  | ns   |
| t <sub>JTAG,Ret</sub>    | Spy-Bi-Wire return to normal operation time                         |                 | 15  |     | 100 | μs   |
| R <sub>internal</sub>    | Internal pulldown resistance on TEST                                | 2 V, 3 V        | 20  | 35  | 50  | kΩ   |

(1) f<sub>TCK</sub> may be restricted to meet the timing requirements of the module selected.



**Figure 5-18. JTAG 4-Wire Timing**

## 6 Detailed Description

### 6.1 Overview

The MSP430FR263x and MSP430FR253x ultra-low-power MCUs are the first FRAM-based MCUs with integrated high-performance charge-transfer CapTIvate technology in ultra-low-power high-reliability high-flexibility MCUs. The MSP430FR263x and MSP430FR253x MCUs feature up to 16 self-capacitance or 64 mutual-capacitance electrodes, proximity sensing, and high accuracy up to 1-fF detection. The MCUs also include four 16-bit timers, eUSCs that support UART, SPI, and I<sup>2</sup>C, a hardware multiplier, an RTC module with alarm capabilities, and a high-performance 10-bit ADC.

### 6.2 CPU

The MSP430 CPU has a 16-bit RISC architecture that is highly transparent to the application. All operations, other than program-flow instructions, are performed as register operations in conjunction with seven addressing modes for source operand and four addressing modes for destination operand.

The CPU is integrated with 16 registers that provide reduced instruction execution time. The register-to-register operation execution time is one cycle of the CPU clock.

Four of the registers, R0 to R3, are dedicated as program counter (PC), stack pointer (SP), status register (SR), and constant generator (CG), respectively. The remaining registers are general-purpose registers.

Peripherals are connected to the CPU using data, address, and control buses. Peripherals can be managed with all instructions.

### 6.3 Operating Modes

The MSP430FR263x and MSP430FR253x MCUs have one active mode and several software-selectable low-power modes of operation (see [Table 6-1](#)). An interrupt event can wake the MCU from low-power mode (LPM0 or LPM3), service the request, and restore the MCU back to the low-power mode on return from the interrupt program. Low-power modes LPM3.5 and LPM4.5 disable the core supply to minimize power consumption.

**Table 6-1. Operating Modes**

| MODE                           |           | AM                    | LPM0            | LPM3                                      | LPM4                     | LPM3.5                                     | LPM4.5            |
|--------------------------------|-----------|-----------------------|-----------------|-------------------------------------------|--------------------------|--------------------------------------------|-------------------|
|                                |           | ACTIVE MODE (FRAM ON) | CPU OFF         | STANDBY                                   | OFF                      | ONLY RTC                                   | SHUTDOWN          |
| Maximum system clock           |           | 16 MHz                | 16 MHz          | 40 kHz                                    | 0                        | 40 kHz                                     | 0                 |
| Power consumption at 25°C, 3 V |           | 126 $\mu$ A/MHz       | 40 $\mu$ A/MHz  | 1.7 $\mu$ A/button average with 8-Hz scan | 0.49 $\mu$ A without SVS | 0.73 $\mu$ A with RTC counter only in LFXT | 16 nA without SVS |
| Wake-up time                   |           | N/A                   | Instant         | 10 $\mu$ s                                | 10 $\mu$ s               | 350 $\mu$ s                                | 350 $\mu$ s       |
| Wake-up events                 |           | N/A                   | All             | All                                       | CapTIvate I/O            | RTC I/O                                    | I/O               |
| Power                          | Regulator | Full Regulation       | Full Regulation | Partial Power Down                        | Partial Power Down       | Partial Power Down                         | Power Down        |
|                                | SVS       | On                    | On              | Optional                                  | Optional                 | Optional                                   | Optional          |
|                                | Brownout  | On                    | On              | On                                        | On                       | On                                         | On                |

**Table 6-1. Operating Modes (continued)**

| MODE                 |                                      | AM                    | LPM0     | LPM3       | LPM4       | LPM3.5     | LPM4.5     |
|----------------------|--------------------------------------|-----------------------|----------|------------|------------|------------|------------|
|                      |                                      | ACTIVE MODE (FRAM ON) | CPU OFF  | STANDBY    | OFF        | ONLY RTC   | SHUTDOWN   |
| Clock <sup>(1)</sup> | MCLK                                 | Active                | Off      | Off        | Off        | Off        | Off        |
|                      | SMCLK                                | Optional              | Optional | Off        | Off        | Off        | Off        |
|                      | FLL                                  | Optional              | Optional | Off        | Off        | Off        | Off        |
|                      | DCO                                  | Optional              | Optional | Off        | Off        | Off        | Off        |
|                      | MODCLK                               | Optional              | Optional | Off        | Off        | Off        | Off        |
|                      | REFO                                 | Optional              | Optional | Optional   | Off        | Off        | Off        |
|                      | ACLK                                 | Optional              | Optional | Optional   | Off        | Off        | Off        |
|                      | XT1CLK                               | Optional              | Optional | Optional   | Off        | Optional   | Off        |
|                      | VLOCLK                               | Optional              | Optional | Optional   | Off        | Optional   | Off        |
|                      | CapTivate MODCLK                     | Optional              | Optional | Optional   | Off        | Off        | Off        |
| Core                 | CPU                                  | On                    | Off      | Off        | Off        | Off        | Off        |
|                      | FRAM                                 | On                    | On       | Off        | Off        | Off        | Off        |
|                      | RAM                                  | On                    | On       | On         | On         | Off        | Off        |
|                      | Backup memory <sup>(2)</sup>         | On                    | On       | On         | On         | On         | Off        |
| Peripherals          | Timer0_A3                            | Optional              | Optional | Optional   | Off        | Off        | Off        |
|                      | Timer1_A3                            | Optional              | Optional | Optional   | Off        | Off        | Off        |
|                      | Timer2_A2                            | Optional              | Optional | Optional   | Off        | Off        | Off        |
|                      | Timer3_A2                            | Optional              | Optional | Optional   | Off        | Off        | Off        |
|                      | WDT                                  | Optional              | Optional | Optional   | Off        | Off        | Off        |
|                      | eUSCI_A0                             | Optional              | Optional | Off        | Off        | Off        | Off        |
|                      | eUSCI_A1                             | Optional              | Optional | Off        | Off        | Off        | Off        |
|                      | eUSCI_B0                             | Optional              | Optional | Off        | Off        | Off        | Off        |
|                      | CRC                                  | Optional              | Optional | Off        | Off        | Off        | Off        |
|                      | ADC                                  | Optional              | Optional | Optional   | Off        | Off        | Off        |
|                      | RTC                                  | Optional              | Optional | Optional   | Off        | Optional   | Off        |
|                      | CapTivate                            | Optional              | Optional | Optional   | Off        | Off        | Off        |
| I/O                  | General-purpose digital input/output | On                    | Optional | State Held | State Held | State Held | State Held |

(1) The status shown for LPM4 applies to internal clocks only.

(2) Backup memory contains 32 bytes of register space in peripheral memory. See [Table 6-24](#) and [Table 6-43](#) for its memory allocation.

#### NOTE

XT1CLK and VLOCLK can be active during LPM4 if requested by low-frequency peripherals, such as RTC, WDT, or CapTivate.



## 6.4 Interrupt Vector Addresses

The interrupt vectors and the power-up start address are in the address range 0FFFFh to 0FF80h (see [Table 6-2](#)). The vector contains the 16-bit address of the appropriate interrupt-handler instruction sequence.

**Table 6-2. Interrupt Sources, Flags, and Vectors**

| INTERRUPT SOURCE                                                                                                                                                                                                                    | INTERRUPT FLAG                                                                                                                                                                                                     | SYSTEM INTERRUPT | WORD ADDRESS   | PRIORITY    |
|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|--------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|------------------|----------------|-------------|
| <b>System Reset</b><br>Power up, Brownout, Supply supervisor<br>External reset RST<br>Watchdog time-out, Key violation<br>FRAM access time error<br>FRAM uncorrectable bit error detection<br>Software POR, BOR<br>FLL unlock error | PMMPORIFG, PMMBORIFG, SVSHIFG<br>PMMRSTIFG<br>WDTIFG<br>ACCTEIFG<br>UBDIFG<br>SYSRSTIV<br>FLLUNLOCKIFG                                                                                                             | Reset            | FFFEh          | 63, Highest |
| <b>System NMI</b><br>Vacant memory access<br>JTAG mailbox<br>FRAM bit error detection                                                                                                                                               | VMAIFG<br>JMBINIFG, JMBOUTIFG<br>CBDIFG, UBDIFG                                                                                                                                                                    | Nonmaskable      | FFFCh          | 62          |
| <b>User NMI</b><br>External NMI<br>Oscillator fault                                                                                                                                                                                 | NMIFG<br>OFIFG                                                                                                                                                                                                     | Nonmaskable      | FFFAh          | 61          |
| Timer0_A3                                                                                                                                                                                                                           | TA0CCR0 CCIFG0                                                                                                                                                                                                     | Maskable         | FFF8h          | 60          |
| Timer0_A3                                                                                                                                                                                                                           | TA0CCR1 CCIFG1, TA0CCR2 CCIFG2, TA0IFG (TA0IV)                                                                                                                                                                     | Maskable         | FFF6h          | 59          |
| Timer1_A3                                                                                                                                                                                                                           | TA1CCR0 CCIFG0                                                                                                                                                                                                     | Maskable         | FFF4h          | 58          |
| Timer1_A3                                                                                                                                                                                                                           | TA1CCR1 CCIFG1, TA1CCR2 CCIFG2, TA1IFG (TA1IV)                                                                                                                                                                     | Maskable         | FFF2h          | 57          |
| Timer2_A2                                                                                                                                                                                                                           | TA2CCR0 CCIFG0                                                                                                                                                                                                     | Maskable         | FFF0h          | 56          |
| Timer2_A2                                                                                                                                                                                                                           | TA2CCR1 CCIFG1, TA2IFG (TA2IV)                                                                                                                                                                                     |                  | FFEEh          | 55          |
| Timer3_A2                                                                                                                                                                                                                           | TA3CCR0 CCIFG0                                                                                                                                                                                                     | Maskable         | FFECCh         | 54          |
| Timer3_A2                                                                                                                                                                                                                           | TA3CCR1 CCIFG1, TA3IFG (TA3IV)                                                                                                                                                                                     |                  | FFEAh          | 53          |
| RTC                                                                                                                                                                                                                                 | RTCIFG                                                                                                                                                                                                             | Maskable         | FFE8h          | 52          |
| Watchdog timer interval mode                                                                                                                                                                                                        | WDTIFG                                                                                                                                                                                                             | Maskable         | FFE6h          | 51          |
| eUSCI_A0 receive or transmit                                                                                                                                                                                                        | UCTXCPTIFG, UCSTTIFG, UCRXIFG, UCTXIFG (UART mode)<br>UCRXIFG, UCTXIFG (SPI mode)<br>(UCA0IV)                                                                                                                      | Maskable         | FFE4h          | 50          |
| eUSCI_A1 receive or transmit                                                                                                                                                                                                        | UCTXCPTIFG, UCSTTIFG, UCRXIFG, UCTXIFG (UART mode)<br>UCRXIFG, UCTXIFG (SPI mode)<br>(UCA1IV)                                                                                                                      | Maskable         | FFE2h          | 49          |
| eUSCI_B0 receive or transmit                                                                                                                                                                                                        | UCB0RXIFG, UCB0TXIFG (SPI mode)<br>UCALIFG, UCNACKIFG, UCSTTIFG, UCSTPIFG, UCRXIFG0, UCTXIFG0, UCRXIFG1, UCTXIFG1, UCRXIFG2, UCTXIFG2, UCRXIFG3, UCTXIFG3, UCCNTIFG, UCBIT9IFG (I <sup>2</sup> C mode)<br>(UCB0IV) | Maskable         | FFE0h          | 48          |
| ADC                                                                                                                                                                                                                                 | ADCIFG0, ADCINIFG, ADCLOIFG, ADCHIIFG, ADCTOVIFG, ADCOVIFG (ADCIV)                                                                                                                                                 | Maskable         | FFDEh          | 47          |
| P1                                                                                                                                                                                                                                  | P1IFG.0 to P1IFG.7 (P1IV)                                                                                                                                                                                          | Maskable         | FFDCh          | 46          |
| P2                                                                                                                                                                                                                                  | P2IFG.0 to P2IFG.7 (P2IV)                                                                                                                                                                                          | Maskable         | FFDAh          | 45          |
| CapTivate                                                                                                                                                                                                                           | (See <a href="#">CapTivate Design Center</a> for details)                                                                                                                                                          | Maskable         | FFD8h          | 44, Lowest  |
| Reserved                                                                                                                                                                                                                            | Reserved                                                                                                                                                                                                           | Maskable         | FFD6h to FF88h |             |

**Table 6-2. Interrupt Sources, Flags, and Vectors (continued)**

| INTERRUPT SOURCE | INTERRUPT FLAG   | SYSTEM INTERRUPT | WORD ADDRESS | PRIORITY |
|------------------|------------------|------------------|--------------|----------|
| Signatures       | BSL Signature 2  |                  | 0FF86h       |          |
|                  | BSL Signature 1  |                  | 0FF84h       |          |
|                  | JTAG Signature 2 |                  | 0FF82h       |          |
|                  | JTAG Signature 1 |                  | 0FF80h       |          |

## 6.5 Bootloader (BSL)

The BSL lets users program the FRAM or RAM using either the UART serial interface or the I<sup>2</sup>C interface. Access to the MCU memory through the BSL is protected by an user-defined password. Use of the BSL requires four pins (see [Table 6-3](#) and [Table 6-4](#)). BSL entry requires a specific entry sequence on the  $\overline{\text{RST}}$ /NMI/SBWDIO and TEST/SBWTCK pins. This device supports the blank device detection to automatically invoke the BSL, skipping this special entry sequence, to save time and simplify onboard programming. For a complete description of the features of the BSL, see the [MSP430 FRAM Device Bootloader \(BSL\) User's Guide](#).

**Table 6-3. UART BSL Pin Requirements and Functions**

| DEVICE SIGNAL                       | BSL FUNCTION          |
|-------------------------------------|-----------------------|
| $\overline{\text{RST}}$ /NMI/SBWDIO | Entry sequence signal |
| TEST/SBWTCK                         | Entry sequence signal |
| P1.4                                | Data transmit         |
| P1.5                                | Data receive          |
| VCC                                 | Power supply          |
| VSS                                 | Ground supply         |

**Table 6-4. I<sup>2</sup>C BSL Pin Requirements and Functions**

| DEVICE SIGNAL                       | BSL FUNCTION              |
|-------------------------------------|---------------------------|
| $\overline{\text{RST}}$ /NMI/SBWDIO | Entry sequence signal     |
| TEST/SBWTCK                         | Entry sequence signal     |
| P1.2                                | Data transmit and receive |
| P1.3                                | Clock                     |
| VCC                                 | Power supply              |
| VSS                                 | Ground supply             |

## 6.6 JTAG Standard Interface

The MSP low-power microcontrollers support the standard JTAG interface, which requires four signals for sending and receiving data. The JTAG signals are shared with general-purpose I/O. The TEST/SBWTCK pin enables the JTAG signals. In addition to these signals, the  $\overline{\text{RST}}$ /NMI/SBWTDO is required to interface with MSP430 development tools and device programmers. Table 6-5 lists the JTAG pin requirements. For further details on interfacing to development tools and device programmers, see the [MSP430 Hardware Tools User's Guide](#). For details on using the JTAG interface, see [MSP430 Programming With the JTAG Interface](#).

**Table 6-5. JTAG Pin Requirements and Function**

| DEVICE SIGNAL                            | DIRECTION | JTAG FUNCTION               |
|------------------------------------------|-----------|-----------------------------|
| P1.4/UCA0TXD/UCA0SIMO/TA1.2/TCK/A4/VREF+ | IN        | JTAG clock input            |
| P1.5/UCA0RXD/UCA0SOMI/TA1.1/TMS/A5       | IN        | JTAG state control          |
| P1.6/UCA0CLK/TA1CLK/TDI/TCLK/A6          | IN        | JTAG data input, TCLK input |
| P1.7/UCA0STE/SMCLK/TDO/A7                | OUT       | JTAG data output            |
| TEST/SBWTCK                              | IN        | Enable JTAG pins            |
| $\overline{\text{RST}}$ /NMI/SBWTDO      | IN        | External reset              |
| DVCC                                     | –         | Power supply                |
| DVSS                                     | –         | Ground supply               |

## 6.7 Spy-Bi-Wire Interface (SBW)

The MSP low-power microcontrollers support the 2-wire SBW interface. SBW can be used to interface with MSP development tools and device programmers. Table 6-6 lists the SBW interface pin requirements. For further details on interfacing to development tools and device programmers, see the [MSP430 Hardware Tools User's Guide](#). For details on using the SBW interface, see the [MSP430 Programming With the JTAG Interface](#).

**Table 6-6. Spy-Bi-Wire Pin Requirements and Functions**

| DEVICE SIGNAL                       | DIRECTION | SBW FUNCTION                      |
|-------------------------------------|-----------|-----------------------------------|
| TEST/SBWTCK                         | IN        | Spy-Bi-Wire clock input           |
| $\overline{\text{RST}}$ /NMI/SBWTDO | IN, OUT   | Spy-Bi-Wire data input and output |
| DVCC                                | –         | Power supply                      |
| DVSS                                | –         | Ground supply                     |

## 6.8 FRAM

The FRAM can be programmed using the JTAG port, SBW, the BSL, or in-system by the CPU. Features of the FRAM include:

- Byte and word access capability
- Programmable wait state generation
- Error correction coding (ECC)

## 6.9 Memory Protection

The device features memory protection for user access authority and write protection, including options to:

- Secure the whole memory map to prevent unauthorized access from JTAG port or BSL, by writing JTAG and BSL signatures using the JTAG port, SBW, the BSL, or in-system by the CPU.
- Enable write protection to prevent unwanted write operation to FRAM contents by setting the control bits in the System Configuration 0 register. For detailed information, see the *System Resets, Interrupts, and Operating Modes, System Control Module (SYS)* chapter in the [MP430FR4xx and MP430FR2xx Family User's Guide](#).

## 6.10 Peripherals

Peripherals are connected to the CPU through data, address, and control buses. All peripherals can be handled by using all instructions in the memory map. For complete module description, see the [MP430FR4xx and MP430FR2xx Family User's Guide](#).

### 6.10.1 Power-Management Module (PMM)

The PMM includes an integrated voltage regulator that supplies the core voltage to the device. The PMM also includes supply voltage supervisor (SVS) and brownout protection. The brownout reset circuit (BOR) is implemented to provide the proper internal reset signal to the device during power on and power off. The SVS circuitry detects if the supply voltage drops below a user-selectable safe level. SVS circuitry is available on the primary supply.

The device contains two on-chip reference: 1.5 V for internal reference and 1.2 V for external reference.

The 1.5-V reference is internally connected to ADC channel 13. DVCC is internally connected to ADC channel 15. When DVCC is set as the reference voltage for ADC conversion, the DVCC can be easily represent as [Equation 1](#) by using ADC sampling 1.5-V reference without any external components support.

$$DVCC = (1023 \times 1.5 \text{ V}) \div 1.5\text{-V reference ADC result} \quad (1)$$

A 1.2-V reference voltage can be buffered and output to P1.4/MCLK/TCK/A4/VREF+, when EXTREFEN = 1 in the PMMCTL1 register. ADC channel 4 can also be selected to monitor this voltage. For more detailed information, see the [MP430FR4xx and MP430FR2xx Family User's Guide](#).

### 6.10.2 Clock System (CS) and Clock Distribution

The clock system includes a 32-kHz crystal oscillator (XT1), an internal very-low-power low-frequency oscillator (VLO), an integrated 32-kHz RC oscillator (REFO), an integrated internal digitally controlled oscillator (DCO) that may use frequency-locked loop (FLL) locking with internal or external 32-kHz reference clock, and an on-chip asynchronous high-speed clock (MODOSC). The clock system is designed for cost-effective designs with minimal external components. A fail-safe mechanism is included for XT1. The clock system module offers the following clock signals.

- **Main Clock (MCLK):** The system clock used by the CPU and all relevant peripherals accessed by the bus. All clock sources except MODOSC can be selected as the source with a predivider of 1, 2, 4, 8, 16, 32, 64, or 128.
- **Sub-Main Clock (SMCLK):** The subsystem clock used by the peripheral modules. SMCLK derives from the MCLK with a predivider of 1, 2, 4, or 8. This means SMCLK is always equal to or less than MCLK.
- **Auxiliary Clock (ACLK):** This clock is derived from the external XT1 clock or internal REFO clock up to 40 kHz.

All peripherals may have one or several clock sources depending on specific functionality. [Table 6-7](#) lists the clock distribution used in this device.

**Table 6-7. Clock Distribution**

|                 | CLOCK<br>SOURCE<br>SELECT<br>BITS | MCLK         | SMCLK        | ACLK         | MODCLK           | XT1CLK       | VLOCLK            | EXTERNAL PIN      |
|-----------------|-----------------------------------|--------------|--------------|--------------|------------------|--------------|-------------------|-------------------|
| Frequency Range |                                   | DC to 16 MHz | DC to 16 MHz | DC to 40 kHz | 5 MHz $\pm 10\%$ | DC to 40 kHz | 10 kHz $\pm 50\%$ | –                 |
| CPU             | N/A                               | Default      | –            | –            | –                | –            | –                 | –                 |
| FRAM            | N/A                               | Default      | –            | –            | –                | –            | –                 | –                 |
| RAM             | N/A                               | Default      | –            | –            | –                | –            | –                 | –                 |
| CRC             | N/A                               | Default      | –            | –            | –                | –            | –                 | –                 |
| I/O             | N/A                               | Default      | –            | –            | –                | –            | –                 | –                 |
| TA0             | TASSEL                            | –            | 10b          | 01b          | –                | –            | –                 | 00b (TA0CLK pin)  |
| TA1             | TASSEL                            | –            | 10b          | 01b          | –                | –            | –                 | 00b (TA1CLK pin)  |
| TA2             | TASSEL                            | –            | 10b          | 01b          | –                | –            | –                 | –                 |
| TA3             | TASSEL                            | –            | 10b          | 01b          | –                | –            | –                 | –                 |
| eUSCI_A0        | UCSSEL                            | –            | 10b or 11b   | –            | 01b              | –            | –                 | 00b (UCA0CLK pin) |
| eUSCI_A1        | UCSSEL                            | –            | 10b or 11b   | –            | 01b              | –            | –                 | 00b (UCA1CLK pin) |
| eUSCI_B0        | UCSSEL                            | –            | 10b or 11b   | –            | 01b              | –            | –                 | 00b (UCB0CLK pin) |
| WDT             | WDTSEL                            | –            | 00b          | 01b          | –                | –            | 10b or 11b        | –                 |
| ADC             | ADCSSEL                           | –            | 11b          | 01b          | 00b              | –            | –                 | –                 |
| CapTivate       | CAPTSEL                           | –            |              | 00b          | –                | –            | 01b               | –                 |
|                 | CAPCLKSEL                         | –            | 1b           | –            | –                | –            | –                 | –                 |
| RTC             | RTCSS                             | –            | 01b          | –            | –                | 10b          | 11b               | –                 |

### 6.10.3 General-Purpose Input/Output Port (I/O)

Up to 19 I/O ports are implemented.

- P1 and P2 are full 8-bit ports; P3 has 3 bits implemented.
- All individual I/O bits are independently programmable.
- Any combination of input, output, and interrupt conditions is possible.
- All ports support programmable pullup or pulldown.
- Edge-selectable interrupt and LPM3.5 and LPM4.5 wake-up input capability is available for P1 and P2.
- Read and write access to port-control registers is supported by all instructions.
- Ports can be accessed byte-wise or word-wise in pairs.
- CapTivate functionality is supported on all CAPx.y pins.

#### NOTE

##### Configuration of digital I/Os after BOR reset

To prevent any cross currents during start-up of the device, all port pins are high-impedance with Schmitt triggers and module functions disabled. To enable the I/O functions after a BOR reset, the ports must be configured first and then the LOCKLPM5 bit must be cleared. For details, see the *Configuration After Reset* section in the *Digital I/O* chapter of the [MP430FR4xx and MP430FR2xx Family User's Guide](#).

#### 6.10.4 Watchdog Timer (WDT)

The primary function of the WDT module is to perform a controlled system restart after a software problem occurs. If the selected time interval expires, a system reset is generated. If the watchdog function is not needed in an application, the module can be configured as interval timer and can generate interrupts at selected time intervals. [Table 6-8](#) lists the system clocks that can be used to source the WDT.

**Table 6-8. WDT Clocks**

| WDTSEL | NORMAL OPERATION<br>(WATCHDOG AND INTERVAL TIMER MODE) |
|--------|--------------------------------------------------------|
| 00     | SMCLK                                                  |
| 01     | ACLK                                                   |
| 10     | VLOCLK                                                 |
| 11     | Reserved                                               |

### 6.10.5 System (SYS) Module

The SYS module handles many of the system functions within the device. These features include power-on reset (POR) and power-up clear (PUC) handling, NMI source selection and management, reset interrupt vector generators, bootloader entry mechanisms, and configuration management (device descriptors). The SYS module also includes a data exchange mechanism through SBW called a JTAG mailbox mail box that can be used in the application. Table 6-9 summarizes the interrupts that are managed by the SYS module.

**Table 6-9. System Module Interrupt Vector Registers**

| INTERRUPT VECTOR REGISTER | ADDRESS | INTERRUPT EVENT                           | VALUE           | PRIORITY |
|---------------------------|---------|-------------------------------------------|-----------------|----------|
| SYSRSTIV, System Reset    | 015Eh   | No interrupt pending                      | 00h             |          |
|                           |         | Brownout (BOR)                            | 02h             | Highest  |
|                           |         | RSTIFG $\overline{\text{RST}}$ /NMI (BOR) | 04h             |          |
|                           |         | PMMSWBOR software BOR (BOR)               | 06h             |          |
|                           |         | LPMx.5 wake up (BOR)                      | 08h             |          |
|                           |         | Security violation (BOR)                  | 0Ah             |          |
|                           |         | Reserved                                  | 0Ch             |          |
|                           |         | SVSHIFG SVSH event (BOR)                  | 0Eh             |          |
|                           |         | Reserved                                  | 10h             |          |
|                           |         | Reserved                                  | 12h             |          |
|                           |         | PMMSWPOR software POR (POR)               | 14h             |          |
|                           |         | WDTIFG watchdog time-out (PUC)            | 16h             |          |
|                           |         | WDTPW password violation (PUC)            | 18h             |          |
|                           |         | FRCTLPW password violation (PUC)          | 1Ah             |          |
|                           |         | Uncorrectable FRAM bit error detection    | 1Ch             |          |
|                           |         | Peripheral area fetch (PUC)               | 1Eh             |          |
|                           |         | PMMPW PMM password violation (PUC)        | 20h             |          |
|                           |         | FLL unlock (PUC)                          | 24h             |          |
|                           |         | Reserved                                  | 22h, 26h to 3Eh | Lowest   |
| SYSSNIV, System NMI       | 015Ch   | No interrupt pending                      | 00h             |          |
|                           |         | SVS low-power reset entry                 | 02h             | Highest  |
|                           |         | Uncorrectable FRAM bit error detection    | 04h             |          |
|                           |         | Reserved                                  | 06h             |          |
|                           |         | Reserved                                  | 08h             |          |
|                           |         | Reserved                                  | 0Ah             |          |
|                           |         | Reserved                                  | 0Ch             |          |
|                           |         | Reserved                                  | 0Eh             |          |
|                           |         | Reserved                                  | 10h             |          |
|                           |         | VMAIFG Vacant memory access               | 12h             |          |
|                           |         | JMBINIFG JTAG mailbox input               | 14h             |          |
|                           |         | JMBOUTIFG JTAG mailbox output             | 16h             |          |
|                           |         | Correctable FRAM bit error detection      | 18h             |          |
|                           |         | Reserved                                  | 1Ah to 1Eh      | Lowest   |
| SYSUNIV, User NMI         | 015Ah   | No interrupt pending                      | 00h             |          |
|                           |         | NMIIFG NMI pin or SVS <sub>H</sub> event  | 02h             | Highest  |
|                           |         | OFIFG oscillator fault                    | 04h             |          |
|                           |         | Reserved                                  | 06h to 1Eh      | Lowest   |

### 6.10.6 Cyclic Redundancy Check (CRC)

The 16-bit cyclic redundancy check (CRC) module produces a signature based on a sequence of data values and can be used for data checking purposes. The CRC generation polynomial is compliant with CRC-16-CCITT standard of  $x^{16} + x^{12} + x^5 + 1$ .

### 6.10.7 Enhanced Universal Serial Communication Interface (eUSCI\_A0, eUSCI\_B0)

The eUSCI modules are used for serial data communications. The eUSCI\_A module supports either UART or SPI communications. The eUSCI\_B module supports either SPI or I<sup>2</sup>C communications. Additionally, eUSCI\_A supports automatic baud-rate detection and IrDA. [Table 6-10](#) lists the pin configurations that are required for each eUSCI mode.

**Table 6-10. eUSCI Pin Configurations**

|          | PIN  | UART             | SPI  |
|----------|------|------------------|------|
| eUSCI_A0 | P1.4 | TXD              | SIMO |
|          | P1.5 | RXD              | SOMI |
|          | P1.6 | –                | SCLK |
|          | P1.7 | –                | STE  |
| eUSCI_A1 | P2.6 | TXD              | SIMO |
|          | P2.5 | RXD              | SOMI |
|          | P2.4 | –                | SCLK |
|          | P3.1 | –                | STE  |
|          | PIN  | I <sup>2</sup> C | SPI  |
| eUSCI_B0 | P1.0 | –                | STE  |
|          | P1.1 | –                | SCLK |
|          | P1.2 | SDA              | SIMO |
|          | P1.3 | SCL              | SOMI |



### 6.10.8 Timers (Timer0\_A3, Timer1\_A3, Timer2\_A2 and Timer3\_A2)

The Timer0\_A3 and Timer1\_A3 modules are 16-bit timers and counters with three capture/compare registers each. Both timers support multiple captures or compares, PWM outputs, and interval timing (see [Table 6-11](#) and [Table 6-12](#)). Both timers have extensive interrupt capabilities. Interrupts may be generated from the counter on overflow conditions and from each capture/compare register.

The CCR0 registers on Timer0\_A3 and Timer1\_A3 are not externally connected and can be used only for hardware period timing and interrupt generation. In Up mode, these CCR0 registers can be used to set the overflow value of the counter.

**Table 6-11. Timer0\_A3 Signal Connections**

| PORT PIN | DEVICE INPUT SIGNAL | MODULE INPUT NAME | MODULE BLOCK | MODULE OUTPUT SIGNAL | DEVICE OUTPUT SIGNAL            |
|----------|---------------------|-------------------|--------------|----------------------|---------------------------------|
| P1.0     | TA0CLK              | TACLK             | Timer        | N/A                  |                                 |
|          | ACLK (internal)     | ACLK              |              |                      |                                 |
|          | SMCLK (internal)    | SMCLK             |              |                      |                                 |
|          |                     | CCI0A             | CCR0         | TA0                  |                                 |
|          |                     | CCI0B             |              |                      | Timer1_A3 CCI0B input           |
|          | DVSS                | GND               |              |                      |                                 |
|          | DVCC                | VCC               |              |                      |                                 |
| P1.1     | TA0.1               | CCI1A             | CCR1         | TA1                  | TA0.1                           |
|          | from RTC (internal) | CCI1B             |              |                      | Timer1_A3 CCI1B input           |
|          | DVSS                | GND               |              |                      |                                 |
|          | DVCC                | VCC               |              |                      |                                 |
| P1.2     | TA0.2               | CCI2A             | CCR2         | TA2                  | TA0.2                           |
|          |                     | CCI2B             |              |                      | Timer1_A3 CCI2B input, IR Input |
|          | DVSS                | GND               |              |                      |                                 |
|          | DVCC                | VCC               |              |                      |                                 |

**Table 6-12. Timer1\_A3 Signal Connections**

| PORT PIN | DEVICE INPUT SIGNAL               | MODULE INPUT NAME | MODULE BLOCK | MODULE OUTPUT SIGNAL | DEVICE OUTPUT SIGNAL |
|----------|-----------------------------------|-------------------|--------------|----------------------|----------------------|
| P1.6     | TA1CLK                            | TACLK             | Timer        | N/A                  |                      |
|          | ACLK (internal)                   | ACLK              |              |                      |                      |
|          | SMCLK (internal)                  | SMCLK             |              |                      |                      |
|          |                                   | CCI0A             | CCR0         | TA0                  |                      |
|          | Timer0_A3 CCR0B output (internal) | CCI0B             |              |                      |                      |
|          | DVSS                              | GND               |              |                      |                      |
|          | DVCC                              | VCC               |              |                      |                      |
| P1.5     | TA1.1                             | CCI1A             | CCR1         | TA1                  | TA1.1                |
|          | Timer0_A3 CCR1B output (internal) | CCI1B             |              |                      | to ADC trigger       |
|          | DVSS                              | GND               |              |                      |                      |
|          | DVCC                              | VCC               |              |                      |                      |
| P1.4     | TA1.2                             | CCI2A             | CCR2         | TA2                  | TA1.2                |
|          | Timer0_A3 CCR2B output (internal) | CCI2B             |              |                      | IR Input             |
|          | DVSS                              | GND               |              |                      |                      |
|          | DVCC                              | VCC               |              |                      |                      |

The interconnection of Timer0\_A3 and Timer1\_A3 can be used to modulate the eUSCI\_A pin of UCA0TXD/UCA0SIMO in either ASK or FSK mode, with which a user can easily acquire a modulated infrared command for directly driving an external IR diode. The IR functions are fully controlled by SYS configuration registers 1 including IREN (enable), IRPSEL (polarity select), IRMSEL (mode select), IRDSSEL (data select), and IRDATA (data) bits. For more information, see the *System Resets, Interrupts, and Operating Modes, System Control Module (SYS)* chapter in the [MP430FR4xx and MP430FR2xx Family User's Guide](#).

The Timer2\_A2 and Timer3\_A2 modules are 16-bit timers and counters with two capture/compare registers each. Both timers support multiple captures or compares and interval timing (see [Table 6-13](#) and [Table 6-14](#)). Both timers have extensive interrupt capabilities. Interrupts may be generated from the counter on overflow conditions and from each capture register.

The CCR0 registers on Timer2\_TA2 and Timer3\_TA2 are not externally connected and can be used only for hardware period timing and interrupt generation. In Up mode, these CCR0 registers can be used to set the overflow value of the counter. Timer2\_A2 and Timer3\_A2 are only internally connected and do not support PWM output.

**Table 6-13. Timer2\_A2 Signal Connections**

| DEVICE INPUT SIGNAL | MODULE INPUT NAME | MODULE BLOCK | MODULE OUTPUT SIGNAL | DEVICE OUTPUT SIGNAL  |
|---------------------|-------------------|--------------|----------------------|-----------------------|
| ACLK (internal)     | ACLK              | Timer        | N/A                  |                       |
| SMCLK (internal)    | SMCLK             |              |                      |                       |
|                     | CCI0A             | CCR0         | TA0                  |                       |
|                     | CCI0B             |              |                      | Timer3_A3 CCI0B input |
| DVSS                | GND               |              |                      |                       |
| DVCC                | VCC               |              |                      |                       |
|                     | CCI1A             | CCR1         | CCR1                 |                       |
|                     | CCI1B             |              |                      | Timer3_A3 CCI1B input |
| DVSS                | GND               |              |                      |                       |
| DVCC                | VCC               |              |                      |                       |

**Table 6-14. Timer3\_A2 Signal Connections**

| DEVICE INPUT SIGNAL   | MODULE INPUT NAME | MODULE BLOCK | MODULE OUTPUT SIGNAL | DEVICE OUTPUT SIGNAL |
|-----------------------|-------------------|--------------|----------------------|----------------------|
| ACLK (internal)       | ACLK              | Timer        | N/A                  |                      |
| SMCLK (internal)      | SMCLK             |              |                      |                      |
|                       | CCI0A             | CCR0         | TA0                  |                      |
| Timer3_A3 CCI0B input | CCI0B             |              |                      |                      |
| DVSS                  | GND               |              |                      |                      |
| DVCC                  | VCC               |              |                      |                      |
|                       | CCI1A             | CCR1         | CCR1                 |                      |
| Timer3_A3 CCI1B input | CCI1B             |              |                      |                      |
| DVSS                  | GND               |              |                      |                      |
| DVCC                  | VCC               |              |                      |                      |

### 6.10.9 Hardware Multiplier (MPY)

The multiplication operation is supported by a dedicated peripheral module. The module performs operations with 32-, 24-, 16-, and 8-bit operands. The MPY module supports signed multiplication, unsigned multiplication, signed multiply-and-accumulate, and unsigned multiply-and-accumulate operations.

### 6.10.10 Backup Memory (BAKMEM)

The BAKMEM supports data retention during LPM3.5. This device provides up to 32 bytes that are retained during LPM3.5.

### 6.10.11 Real-Time Clock (RTC)

The RTC is a 16-bit modulo counter that is functional in AM, LPM0, LPM3, and LPM3.5. This module may periodically wake up the CPU from LPM0, LPM3, and LPM3.5 based on timing from a low-power clock source such as the XT1 and VLO clocks. In AM, SMCLK can drive the RTC to generate high-frequency timing events and interrupts. The RTC overflow events trigger:

- Timer0\_A3 CCR1B
- ADC conversion trigger when ADCSHSx bits are set as 01b

### 6.10.12 10-Bit Analog-to-Digital Converter (ADC)

The 10-bit ADC module supports fast 10-bit analog-to-digital conversions with single-ended input. The module implements a 10-bit SAR core, sample select control, reference generator and a conversion result buffer. A window comparator with lower and upper limits allows CPU-independent result monitoring with three window comparator interrupt flags.

The ADC supports 10 external inputs and 4 internal inputs (see [Table 6-15](#)).

**Table 6-15. ADC Channel Connections**

| ADCINCHx | ADC CHANNELS               | EXTERNAL PINOUT |
|----------|----------------------------|-----------------|
| 0        | A0/Veref+                  | P1.0            |
| 1        | A1                         | P1.1            |
| 2        | A2/Veref-                  | P1.2            |
| 3        | A3                         | P1.3            |
| 4        | A4 <sup>(1)</sup>          | P1.4            |
| 5        | A5                         | P1.5            |
| 6        | A6                         | P1.6            |
| 7        | A7                         | P1.7            |
| 8        | A8                         | NA              |
| 9        | A9                         | NA              |
| 10       | Not used                   | N/A             |
| 11       | Not used                   | N/A             |
| 12       | On-chip temperature sensor | N/A             |
| 13       | Reference voltage (1.5 V)  | N/A             |
| 14       | DVSS                       | N/A             |
| 15       | DVCC                       | N/A             |

(1) When A4 is used, the PMM 1.2-V reference voltage can be output to this pin by setting the PMM control register. The 1.2-V voltage can be directly measured by A4 channel.

Software or a hardware trigger can start the analog-to-digital conversion. [Table 6-16](#) lists the trigger sources that are available.

**Table 6-16. ADC Trigger Signal Connections**

| ADC SHSx |         | TRIGGER SOURCE               |
|----------|---------|------------------------------|
| BINARY   | DECIMAL |                              |
| 00       | 0       | ADCSC bit (software trigger) |
| 01       | 1       | RTC event                    |
| 10       | 2       | TA1.1B                       |
| 11       | 3       | --                           |

### 6.10.13 CapTivate Technology

The CapTivate module detects the capacitance changed with a charge-transfer method and is functional in AM, LPM0, LPM3, and LPM4. The CapTivate module can periodically wake the CPU from LPM0, LPM3, or LPM4 based on a CapTivate timer source such as ACLK or VLO clock. The CapTivate module supports the following touch-sensing capability:

- Up to 64 CapTivate buttons composed of 4 CapTivate blocks. Each block consists of 4 I/Os, and these blocks scan in parallel of 4 electrodes.
- Each block can be individually configured in self or mutual mode. Each CapTivate I/O can be used for either self or mutual electrodes.
- Supports a wake-on-touch state machine.
- Supports synchronized conversion on a zero-crossing event trigger.
- Processing logic to perform filter calculation and threshold detection.

To learn more about MSP MCUs featuring CapTivate technology, see the [CapTivate™ Technology Guide](#).

### 6.10.14 Embedded Emulation Module (EEM)

The EEM supports real-time in-system debugging. The EEM on these devices has the following features:

- Three hardware triggers or breakpoints on memory access
- One hardware trigger or breakpoint on CPU register write access
- Up to four hardware triggers that can be combined to form complex triggers or breakpoints
- One cycle counter
- Clock control on module level
- EEM version: S



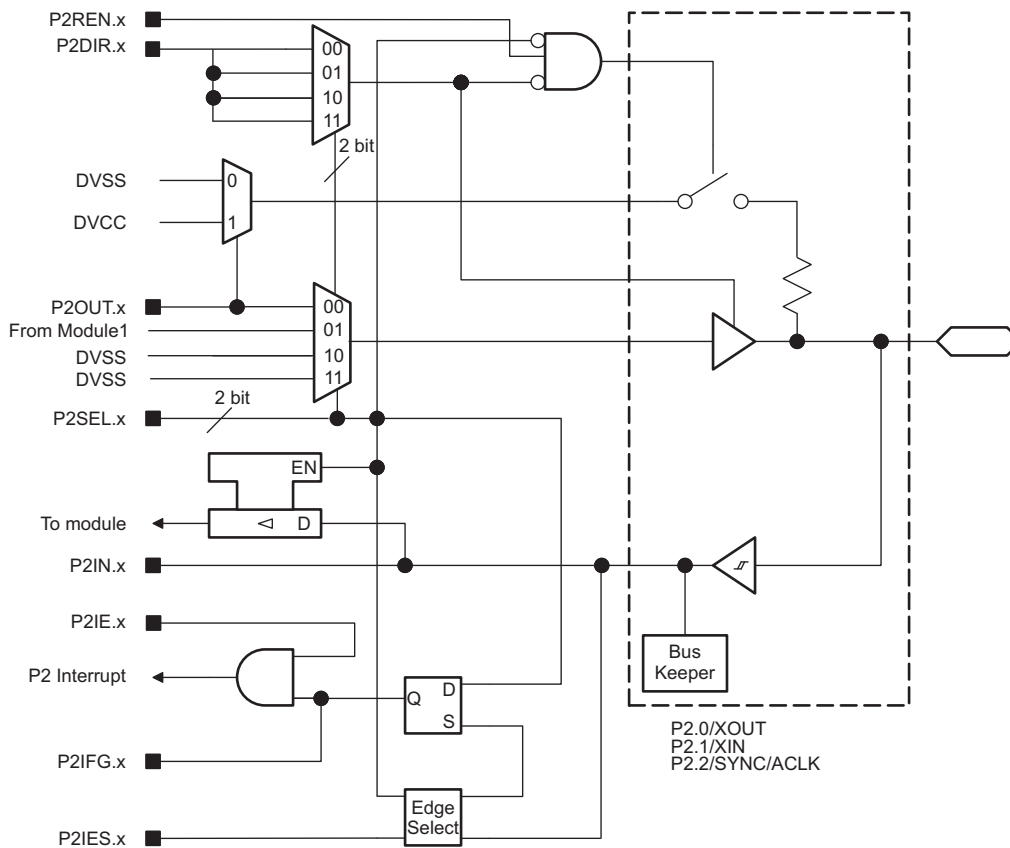
Table 6-17. Port P1 (P1.0 to P1.7) Pin Functions

| PIN NAME (P1.x)                                   | x | FUNCTION         | CONTROL BITS AND SIGNALS <sup>(1)</sup> |        |                         |          |
|---------------------------------------------------|---|------------------|-----------------------------------------|--------|-------------------------|----------|
|                                                   |   |                  | P1DIR.x                                 | P1SELx | ADCPCTLx <sup>(2)</sup> | JTAG     |
| P1.0/UCB0STE/<br>TA0CLK/A0                        | 0 | P1.0 (I/O)       | I: 0; O: 1                              | 00     | 0                       | N/A      |
|                                                   |   | UCB0STE          | X                                       | 01     | 0                       | N/A      |
|                                                   |   | TA0CLK           | 0                                       | 10     | 0                       | N/A      |
|                                                   |   | A0/Veref+        | X                                       | X      | 1 (x = 0)               | N/A      |
| P1.1/UCB0CLK/TA0.1/<br>A1                         | 1 | P1.1 (I/O)       | I: 0; O: 1                              | 00     | 0                       | N/A      |
|                                                   |   | UCB0CLK          | X                                       | 01     | 0                       | N/A      |
|                                                   |   | TA0.CCI1A        | 0                                       | 10     | 0                       | N/A      |
|                                                   |   | TA0.1            | 1                                       |        |                         |          |
|                                                   |   | A1               | X                                       | X      | 1 (x = 1)               | N/A      |
| P1.2/UCB0SIMO/<br>UCB0SDA/TA0.2/A2                | 2 | P1.2 (I/O)       | I: 0; O: 1                              | 00     | 0                       | N/A      |
|                                                   |   | UCB0SIMO/UCB0SDA | X                                       | 01     | 0                       | N/A      |
|                                                   |   | TA0.CCI2A        | 0                                       | 10     | 0                       | N/A      |
|                                                   |   | TA0.2            | 1                                       |        |                         |          |
|                                                   |   | A2/Veref-        | X                                       | X      | 1 (x = 2)               | N/A      |
| P1.3/UCB0SOMI/<br>UCB0SCL/MCLK/A3                 | 3 | P1.3 (I/O)       | I: 0; O: 1                              | 00     | 0                       | N/A      |
|                                                   |   | UCB0SOMI/UCB0SCL | X                                       | 01     | 0                       | N/A      |
|                                                   |   | MCLK             | 1                                       | 10     | 0                       | N/A      |
|                                                   |   | A3               | X                                       | X      | 1 (x = 3)               | N/A      |
| P1.4/UCA0TXD/<br>UCA0SIMO/TA1.2/TCK/<br>A4 /VREF+ | 4 | P1.4 (I/O)       | I: 0; O: 1                              | 00     | 0                       | Disabled |
|                                                   |   | UCA0TXD/UCA0SIMO | X                                       | 01     | 0                       | Disabled |
|                                                   |   | TA1.CCI2A        | 0                                       | 10     | 0                       | Disabled |
|                                                   |   | TA1.2            | 1                                       |        |                         |          |
|                                                   |   | A4, VREF+        | X                                       | X      | 1 (x = 4)               | Disabled |
|                                                   |   | JTAG TCK         | X                                       | X      | X                       | TCK      |
| P1.5/UCA0RXD/<br>UCA0SOMI/TA1.1/TMS/<br>A5        | 5 | P1.5 (I/O)       | I: 0; O: 1                              | 00     | 0                       | Disabled |
|                                                   |   | UCA0RXD/UCA0SOMI | X                                       | 01     | 0                       | Disabled |
|                                                   |   | TA1.CCI1A        | 0                                       | 10     | 0                       | Disabled |
|                                                   |   | TA1.1            | 1                                       |        |                         |          |
|                                                   |   | A5               | X                                       | X      | 1 (x = 5)               | Disabled |
|                                                   |   | JTAG TMS         | X                                       | X      | X                       | TMS      |
| P1.6/UCA0CLK/<br>TA1CLK/TDI/TCLK/A6               | 6 | P1.6 (I/O)       | I: 0; O: 1                              | 00     | 0                       | Disabled |
|                                                   |   | UCA0CLK          | X                                       | 01     |                         | Disabled |
|                                                   |   | TA1CLK           | 0                                       | 10     | 0                       | Disabled |
|                                                   |   | A6               | X                                       | X      | 1 (x = 6)               | Disabled |
|                                                   |   | JTAG TDI/TCLK    | X                                       | X      | X                       | TDI/TCLK |
| P1.7/UCA0STE/SMCLK/<br>TDO/A7                     | 7 | P1.7 (I/O)       | I: 0; O: 1                              | 00     | 0                       | Disabled |
|                                                   |   | UCA0STE          | X                                       | 01     | 0                       | Disabled |
|                                                   |   | SMCLK            | 1                                       | 10     | 0                       | Disabled |
|                                                   |   | A7               | X                                       | X      | 1 (x = 7)               | Disabled |
|                                                   |   | JTAG TDO         | X                                       | X      | X                       | TDO      |

(1) X = don't care

(2) Setting the ADCPCTLx bit in SYSCFG2 register disables both the output driver and input Schmitt trigger to prevent leakage when analog signals are applied.

Figure 6-2 shows the port diagram. Table 6-18 summarizes the selection of pin function.



### Figure 6-2. Port P2 (P2.0 to P2.2) Input/Output With Schmitt Trigger

### Table 6-18. Port P2 (P2.0 to P2.2) Pin Functions

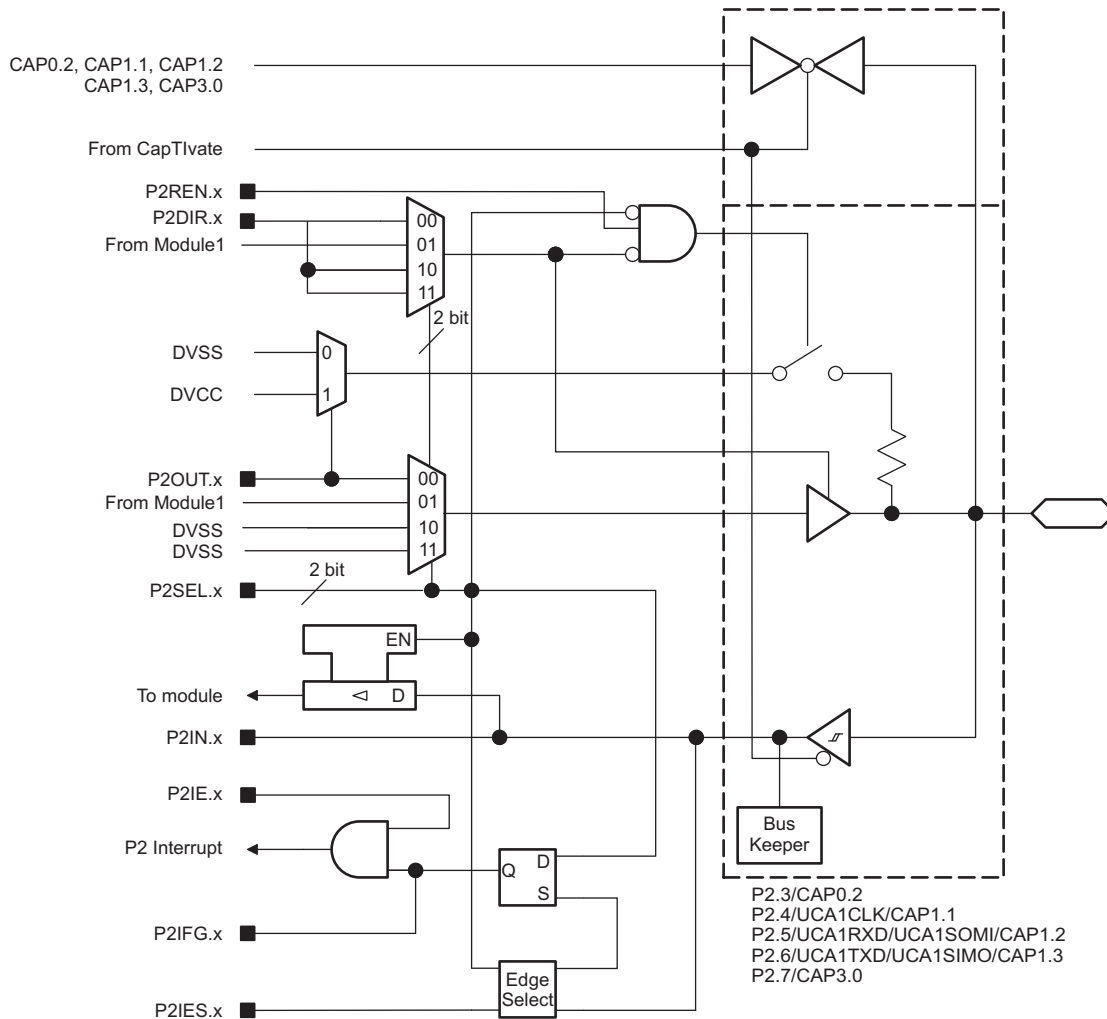
| PIN NAME (P2.x) | x | FUNCTION   | CONTROL BITS AND SIGNALS <sup>(1)</sup> |        |
|-----------------|---|------------|-----------------------------------------|--------|
|                 |   |            | P2DIR.x                                 | P2SELx |
| P2.0/XOUT       | 0 | P2.0 (I/O) | I: 0; O: 1                              | 00     |
|                 |   | XOUT       | X                                       | 01     |
| P2.1/XIN        | 1 | P2.1 (I/O) | I: 0; O: 1                              | 00     |
|                 |   | XIN        | X                                       | 01     |
| P2.2/SYNC/ACLK  | 2 | P2.2 (I/O) | I: 0; O: 1                              | 00     |
|                 |   | SYNC       | 0                                       | 01     |
|                 |   | ACLK       | 1                                       | 10     |

(1)  $X = \text{don't care}$



### 6.11.3 Port P2 (P2.3 to P2.7) Input/Output With Schmitt Trigger

Figure 6-3 shows the port diagram. Table 6-19 summarizes the selection of pin function.



**Figure 6-3. Port P2 (P2.3 to P2.7) Input/Output With Schmitt Trigger**

**Table 6-19. Port P2 (P2.3 to P2.7) Pin Functions**

| PIN NAME (P2.x)                  | x | FUNCTION         | CONTROL BITS AND SIGNALS <sup>(1)</sup> |        |                 |
|----------------------------------|---|------------------|-----------------------------------------|--------|-----------------|
|                                  |   |                  | P2DIR.x                                 | P2SELx | ANALOG FUNCTION |
| P2.3/CAP0.2                      | 3 | P2.3 (I/O)       | I: 0; O: 1                              | 00     | 0               |
|                                  |   | CAP0.2           | X                                       | X      | 1               |
| P2.4/UCA1CLK/<br>CAP1.1          | 4 | P2.4 (I/O)       | I: 0; O: 1                              | 00     | 0               |
|                                  |   | UCA1CLK          | X                                       | 01     | 0               |
|                                  |   | CAP1.1           | X                                       | X      | 1               |
| P2.5/UCA1RXD/<br>UCA1SOMI/CAP1.2 | 5 | P2.5 (I/O)       | I: 0; O: 1                              | 00     | 0               |
|                                  |   | UCA1RXD/UCA1SOMI | X                                       | 01     | 0               |
|                                  |   | CAP1.2           | X                                       | X      | 1               |
| P2.6/UCA1TXD/<br>UCA1SIMO/CAP1.3 | 6 | P2.6 (I/O)       | I: 0; O: 1                              | 00     | 0               |
|                                  |   | UCA1TXD/UCA1SIMO | X                                       | 01     | 0               |
|                                  |   | CAP1.3           | X                                       | X      | 1               |
| P2.7/CAP3.0                      | 7 | P2.7 (I/O)       | I: 0; O: 1                              | 0      | 0               |
|                                  |   | CAP3.0           | X                                       | X      | 1               |

(1) X = don't care



**Table 6-20. Port P3 (P3.0 to P3.2) Pin Functions**

| PIN NAME (P3.x)         | x | FUNCTION   | CONTROL BITS AND SIGNALS <sup>(1)</sup> |         |                 |
|-------------------------|---|------------|-----------------------------------------|---------|-----------------|
|                         |   |            | P3DIR.x                                 | P3SEL.x | ANALOG FUNCTION |
| P3.0/CAP0.0             | 0 | P3.0 (I/O) | I: 0; O: 1                              | 00      | 0               |
|                         |   | CAP0.0     | X                                       | X       | 1               |
| P3.1/UCA1STE/<br>CAP1.0 | 1 | P3.1 (I/O) | I: 0; O: 1                              | 00      | 0               |
|                         |   | UCA1STE    | X                                       | 01      | 0               |
|                         |   | CAP1.0     | X                                       | X       | 1               |
| P3.2/CAP3.2             | 2 | P3.2 (I/O) | I: 0; O: 1                              | 00      | 0               |
|                         |   | CAP3.2     | X                                       | X       | 1               |

(1) X = don't care

## 6.12 Device Descriptors

Table 6-21 lists the Device IDs of the devices. Table 6-22 lists the contents of the device descriptor tag-length-value (TLV) structure for the devices.

**Table 6-21. Device IDs**

| DEVICE       | DEVICE ID |       |
|--------------|-----------|-------|
|              | 1A05h     | 1A04h |
| MSP430FR2633 | 82h       | 3Ch   |
| MSP430FR2533 | 82h       | 3Dh   |
| MSP430FR2632 | 82h       | 3Eh   |
| MSP430FR2532 | 82h       | 3Fh   |

**Table 6-22. Device Descriptors**

| DESCRIPTION       |                                      | MSP430FR2633, MSP430FR2632,<br>MSP430FR2533, MSP430FR2532 |                 |
|-------------------|--------------------------------------|-----------------------------------------------------------|-----------------|
|                   |                                      | ADDRESS                                                   | VALUE           |
| Information Block | Info length                          | 1A00h                                                     | 06h             |
|                   | CRC length                           | 1A01h                                                     | 06h             |
|                   | CRC value <sup>(1)</sup>             | 1A02h                                                     | Per unit        |
|                   |                                      | 1A03h                                                     | Per unit        |
|                   | Device ID                            | 1A04h                                                     | See Table 6-21. |
|                   |                                      | 1A05h                                                     |                 |
|                   | Hardware revision                    | 1A06h                                                     | Per unit        |
|                   | Firmware revision                    | 1A07h                                                     | Per unit        |
| Die Record        | Die record tag                       | 1A08h                                                     | 08h             |
|                   | Die record length                    | 1A09h                                                     | 0Ah             |
|                   | Lot wafer ID                         | 1A0Ah                                                     | Per unit        |
|                   |                                      | 1A0Bh                                                     | Per unit        |
|                   |                                      | 1A0Ch                                                     | Per unit        |
|                   |                                      | 1A0Dh                                                     | Per unit        |
|                   | Die X position                       | 1A0Eh                                                     | Per unit        |
|                   |                                      | 1A0Fh                                                     | Per unit        |
|                   | Die Y position                       | 1A10h                                                     | Per unit        |
|                   |                                      | 1A11h                                                     | Per unit        |
| ADC Calibration   | Test result                          | 1A12h                                                     | Per unit        |
|                   |                                      | 1A13h                                                     | Per unit        |
|                   | ADC calibration tag                  | 1A14h                                                     | Per unit        |
|                   | ADC calibration length               | 1A15h                                                     | Per unit        |
|                   | ADC gain factor                      | 1A16h                                                     | Per unit        |
|                   |                                      | 1A17h                                                     | Per unit        |
|                   | ADC offset                           | 1A18h                                                     | Per unit        |
|                   |                                      | 1A19h                                                     | Per unit        |
|                   | ADC 1.5-V reference temperature 30°C | 1A1Ah                                                     | Per unit        |
|                   |                                      | 1A1Bh                                                     | Per unit        |
|                   | ADC 1.5-V reference temperature 85°C | 1A1Ch                                                     | Per unit        |
|                   |                                      | 1A1Dh                                                     | Per unit        |

(1) The CRC value covers the checksum from 0x1A04h to 0x1AF5h by applying the CRC-CCITT-16 polynomial of  $x^{16} + x^{12} + x^5 + 1$ .

**Table 6-22. Device Descriptors (continued)**

| DESCRIPTION                   |                                                             | MSP430FR2633, MSP430FR2632,<br>MSP430FR2533, MSP430FR2532 |          |
|-------------------------------|-------------------------------------------------------------|-----------------------------------------------------------|----------|
|                               |                                                             | ADDRESS                                                   | VALUE    |
| Reference and DCO Calibration | Calibration tag                                             | 1A1Eh                                                     | 12h      |
|                               | Calibration length                                          | 1A1Fh                                                     | 04h      |
|                               | 1.5-V reference factor                                      | 1A20h                                                     | Per unit |
|                               |                                                             | 1A21h                                                     | Per unit |
|                               | DCO tap setting for 16 MHz, temperature 30°C <sup>(2)</sup> | 1A22h                                                     | Per unit |
|                               |                                                             | 1A23h                                                     | Per unit |

- (2) This value can be directly loaded into DCO bits in CSCTL0 registers to get accurate 16-MHz frequency at room temperature, especially when the MCU exits from LPM3 and below. TI suggests using the predivider to decrease the frequency if the temperature drift might result an overshoot beyond 16 MHz.

## 6.13 Memory

### 6.13.1 Memory Organization

Table 6-23 summarizes the memory map of the devices.

**Table 6-23. Memory Organization**

|                                                                              | ACCESS                                                | MSP430FR2633                             | MSP430FR2632                            | MSP430FR2533                             | MSP430FR2532                            |
|------------------------------------------------------------------------------|-------------------------------------------------------|------------------------------------------|-----------------------------------------|------------------------------------------|-----------------------------------------|
| Memory (FRAM)<br>Main: interrupt vectors and signatures<br>Main: code memory | Read/Write<br>(Optional Write Protect) <sup>(1)</sup> | 15KB<br>FFFFh to FF80h<br>FFFFh to C400h | 8KB<br>FFFFh to FF80h<br>FFFFh to E000h | 15KB<br>FFFFh to FF80h<br>FFFFh to C400h | 8KB<br>FFFFh to FF80h<br>FFFFh to E000h |
| RAM                                                                          | Read/Write                                            | 4KB<br>2FFFh to 2000h                    | 2KB<br>27FFh to 2000h                   | 2KB<br>27FFh to 2000h                    | 1KB<br>23FFh to 2000h                   |
| Information Memory (FRAM)                                                    | Read/Write<br>(Optional Write Protect) <sup>(2)</sup> | 512 bytes<br>19FFh to 1800h              | 512 bytes<br>19FFh to 1800h             | 512 bytes<br>19FFh to 1800h              | 512 bytes<br>19FFh to 1800h             |
| Bootstrap loader (BSL1)<br>Memory (ROM)                                      | Read only                                             | 2KB<br>17FFh to 1000h                    | 2KB<br>17FFh to 1000h                   | 2KB<br>17FFh to 1000h                    | 2KB<br>17FFh to 1000h                   |
| Bootstrap loader (BSL2)<br>Memory (ROM)                                      | Read only                                             | 1KB<br>FFFFFh to FFC00h                  | 1KB<br>FFFFFh to FFC00h                 | 1KB<br>FFFFFh to FFC00h                  | 1KB<br>FFFFFh to FFC00h                 |
| CapTivate Libraries and<br>Driver Libraries (ROM)                            | Read only                                             | 12KB<br>6FFFh to 4000h                   | 12KB<br>6FFFh to 4000h                  | 12KB<br>6FFFh to 4000h                   | 12KB<br>6FFFh to 4000h                  |
| Peripherals                                                                  | Read/Write                                            | 4KB<br>0FFFh to 0000h                    | 4KB<br>0FFFh to 0000h                   | 4KB<br>0FFFh to 0000h                    | 4KB<br>0FFFh to 0000h                   |

- (1) The Program FRAM can be write protected by setting the PFWP bit in the SYSCFG0 register. See the SYS chapter in the [MSP430FR4xx and MSP430FR2xx Family User's Guide](#) for more details.
- (2) The Information FRAM can be write protected by setting the DFWP bit in the SYSCFG0 register. See the SYS chapter in the [MSP430FR4xx and MSP430FR2xx Family User's Guide](#) for more details.

### 6.13.2 Peripheral File Map

Table 6-24 lists the available peripherals and the register base address for each. Table 6-25 to list the registers and address offsets for each peripheral.

**Table 6-24. Peripherals Summary**

| MODULE NAME                                         | BASE ADDRESS | SIZE  |
|-----------------------------------------------------|--------------|-------|
| Special Functions (See Table 6-25)                  | 0100h        | 0010h |
| PMM (See Table 6-26)                                | 0120h        | 0020h |
| SYS (See Table 6-27)                                | 0140h        | 0040h |
| CS (See Table 6-28)                                 | 0180h        | 0020h |
| FRAM (See Table 6-29)                               | 01A0h        | 0010h |
| CRC (See Table 6-30)                                | 01C0h        | 0008h |
| WDT (See Table 6-31)                                | 01CCh        | 0002h |
| Port P1, P2 (See Table 6-32)                        | 0200h        | 0020h |
| Port P3 (See Table 6-33)                            | 0220h        | 0020h |
| RTC (See Table 6-34)                                | 0300h        | 0010h |
| Timer0_A3 (See Table 6-35)                          | 0380h        | 0030h |
| Timer1_A3 (See Table 6-36)                          | 03C0h        | 0030h |
| Timer2_A2 (See Table 6-37)                          | 0400h        | 0030h |
| Timer3_A2 (See Table 6-38)                          | 0440h        | 0030h |
| MPY32 (See Table 6-39)                              | 04C0h        | 0030h |
| eUSCI_A0 (See Table 6-40)                           | 0500h        | 0020h |
| eUSCI_A1 (See Table 6-41)                           | 0520h        | 0020h |
| eUSCI_B0 (See Table 6-42)                           | 0540h        | 0030h |
| Backup Memory (See Table 6-43)                      | 0660h        | 0020h |
| ADC (See Table 6-44)                                | 0700h        | 0040h |
| CapTivate (See CapTivate Design Center for details) | 0A00h        | 0200h |

**Table 6-25. Special Function Registers (Base Address: 0100h)**

| REGISTER DESCRIPTION  | ACRONYM | OFFSET |
|-----------------------|---------|--------|
| SFR interrupt enable  | SFRIE1  | 00h    |
| SFR interrupt flag    | SFRIFG1 | 02h    |
| SFR reset pin control | SFRRPCR | 04h    |

**Table 6-26. PMM Registers (Base Address: 0120h)**

| REGISTER DESCRIPTION | ACRONYM | OFFSET |
|----------------------|---------|--------|
| PMM control 0        | PMMCTL0 | 00h    |
| PMM control 1        | PMMCTL1 | 02h    |
| PMM control 2        | PMMCTL2 | 04h    |
| PMM interrupt flags  | PMMIFG  | 0Ah    |
| PM5 control 0        | PM5CTL0 | 10h    |

**Table 6-27. SYS Registers (Base Address: 0140h)**

| REGISTER DESCRIPTION          | ACRONYM   | OFFSET |
|-------------------------------|-----------|--------|
| System control                | SYSCTL    | 00h    |
| Bootloader configuration area | SYSBSLC   | 02h    |
| JTAG mailbox control          | SYSJMBC   | 06h    |
| JTAG mailbox input 0          | SYSJMBI0  | 08h    |
| JTAG mailbox input 1          | SYSJMBI1  | 0Ah    |
| JTAG mailbox output 0         | SYSJMBO0  | 0Ch    |
| JTAG mailbox output 1         | SYSJMBO1  | 0Eh    |
| Bus error vector generator    | SYSBERRIV | 18h    |
| User NMI vector generator     | SYSUNIV   | 1Ah    |
| System NMI vector generator   | SYSSNIV   | 1Ch    |
| Reset vector generator        | SYSRSTIV  | 1Eh    |
| System configuration 0        | SYSCFG0   | 20h    |
| System configuration 1        | SYSCFG1   | 22h    |
| System configuration 2        | SYSCFG2   | 24h    |

**Table 6-28. CS Registers (Base Address: 0180h)**

| REGISTER DESCRIPTION | ACRONYM | OFFSET |
|----------------------|---------|--------|
| CS control 0         | CSCTL0  | 00h    |
| CS control 1         | CSCTL1  | 02h    |
| CS control 2         | CSCTL2  | 04h    |
| CS control 3         | CSCTL3  | 06h    |
| CS control 4         | CSCTL4  | 08h    |
| CS control 5         | CSCTL5  | 0Ah    |
| CS control 6         | CSCTL6  | 0Ch    |
| CS control 7         | CSCTL7  | 0Eh    |
| CS control 8         | CSCTL8  | 10h    |

**Table 6-29. FRAM Registers (Base Address: 01A0h)**

| REGISTER DESCRIPTION | ACRONYM | OFFSET |
|----------------------|---------|--------|
| FRAM control 0       | FRCTL0  | 00h    |
| General control 0    | GCCTL0  | 04h    |
| General control 1    | GCCTL1  | 06h    |

**Table 6-30. CRC Registers (Base Address: 01C0h)**

| REGISTER DESCRIPTION          | ACRONYM   | OFFSET |
|-------------------------------|-----------|--------|
| CRC data input                | CRC16DI   | 00h    |
| CRC data input reverse byte   | CRCDIRB   | 02h    |
| CRC initialization and result | CRCINIRES | 04h    |
| CRC result reverse byte       | CRCRESR   | 06h    |

**Table 6-31. WDT Registers (Base Address: 01CCh)**

| REGISTER DESCRIPTION   | ACRONYM | OFFSET |
|------------------------|---------|--------|
| Watchdog timer control | WDTCTL  | 00h    |



**Table 6-32. Port P1, P2 Registers (Base Address: 0200h)**

| REGISTER DESCRIPTION          | ACRONYM | OFFSET |
|-------------------------------|---------|--------|
| Port P1 input                 | P1IN    | 00h    |
| Port P1 output                | P1OUT   | 02h    |
| Port P1 direction             | P1DIR   | 04h    |
| Port P1 pulling enable        | P1REN   | 06h    |
| Port P1 selection 0           | P1SEL0  | 0Ah    |
| Port P1 selection 1           | P1SEL1  | 0Ch    |
| Port P1 interrupt vector word | P1IV    | 0Eh    |
| Port P1 complement selection  | P1SELC  | 16h    |
| Port P1 interrupt edge select | P1IES   | 18h    |
| Port P1 interrupt enable      | P1IE    | 1Ah    |
| Port P1 interrupt flag        | P1IFG   | 1Ch    |
| Port P2 input                 | P2IN    | 01h    |
| Port P2 output                | P2OUT   | 03h    |
| Port P2 direction             | P2DIR   | 05h    |
| Port P2 pulling enable        | P2REN   | 07h    |
| Port P2 selection 0           | P2SEL0  | 0Bh    |
| Port P2 selection 1           | P2SEL1  | 0Dh    |
| Port P2 interrupt vector word | P2IV    | 1Eh    |
| Port P2 complement selection  | P2SELC  | 17h    |
| Port P2 interrupt edge select | P2IES   | 19h    |
| Port P2 interrupt enable      | P2IE    | 1Bh    |
| Port P2 interrupt flag        | P2IFG   | 1Dh    |

**Table 6-33. Port P3 Registers (Base Address: 0220h)**

| REGISTER DESCRIPTION         | ACRONYM | OFFSET |
|------------------------------|---------|--------|
| Port P3 input                | P3IN    | 00h    |
| Port P3 output               | P3OUT   | 02h    |
| Port P3 direction            | P3DIR   | 04h    |
| Port P3 pulling enable       | P3REN   | 06h    |
| Port P3 selection 0          | P3SEL0  | 0Ah    |
| Port P3 selection 1          | P3SEL1  | 0      |
| Port P3 complement selection | P3SELC  | 16h    |

**Table 6-34. RTC Registers (Base Address: 0300h)**

| REGISTER DESCRIPTION | ACRONYM | OFFSET |
|----------------------|---------|--------|
| RTC control          | RTCCTL  | 00h    |
| RTC interrupt vector | RTCIV   | 04h    |
| RTC modulo           | RTCMOD  | 08h    |
| RTC counter          | RTCCNT  | 0Ch    |

**Table 6-35. Timer0\_A3 Registers (Base Address: 0380h)**

| REGISTER DESCRIPTION      | ACRONYM  | OFFSET |
|---------------------------|----------|--------|
| TA0 control               | TA0CTL   | 00h    |
| Capture/compare control 0 | TA0CCTL0 | 02h    |
| Capture/compare control 1 | TA0CCTL1 | 04h    |
| Capture/compare control 2 | TA0CCTL2 | 06h    |
| TA0 counter               | TA0R     | 10h    |
| Capture/compare 0         | TA0CCR0  | 12h    |
| Capture/compare 1         | TA0CCR1  | 14h    |
| Capture/compare 2         | TA0CCR2  | 16h    |
| TA0 expansion 0           | TA0EX0   | 20h    |
| TA0 interrupt vector      | TA0IV    | 2Eh    |

**Table 6-36. Timer1\_A3 Registers (Base Address: 03C0h)**

| REGISTER DESCRIPTION      | ACRONYM  | OFFSET |
|---------------------------|----------|--------|
| TA1 control               | TA1CTL   | 00h    |
| Capture/compare control 0 | TA1CCTL0 | 02h    |
| Capture/compare control 1 | TA1CCTL1 | 04h    |
| Capture/compare control 2 | TA1CCTL2 | 06h    |
| TA1 counter               | TA1R     | 10h    |
| Capture/compare 0         | TA1CCR0  | 12h    |
| Capture/compare 1         | TA1CCR1  | 14h    |
| Capture/compare 2         | TA1CCR2  | 16h    |
| TA1 expansion 0           | TA1EX0   | 20h    |
| TA1 interrupt vector      | TA1IV    | 2Eh    |

**Table 6-37. Timer2\_A2 Registers (Base Address: 0400h)**

| REGISTER DESCRIPTION      | ACRONYM  | OFFSET |
|---------------------------|----------|--------|
| TA2 control               | TA2CTL   | 00h    |
| Capture/compare control 0 | TA2CCTL0 | 02h    |
| Capture/compare control 1 | TA2CCTL1 | 04h    |
| TA2 counter               | TA2R     | 10h    |
| Capture/compare 0         | TA2CCR0  | 12h    |
| Capture/compare 1         | TA2CCR1  | 14h    |
| TA2 expansion 0           | TA2EX0   | 20h    |
| TA2 interrupt vector      | TA2IV    | 2Eh    |

**Table 6-38. Timer3\_A2 Registers (Base Address: 0440h)**

| REGISTER DESCRIPTION      | ACRONYM  | OFFSET |
|---------------------------|----------|--------|
| TA3 control               | TA3CTL   | 00h    |
| Capture/compare control 0 | TA3CCTL0 | 02h    |
| Capture/compare control 1 | TA3CCTL1 | 04h    |
| TA3 counter               | TA3R     | 10h    |
| Capture/compare 0         | TA3CCR0  | 12h    |
| Capture/compare 1         | TA3CCR1  | 14h    |
| TA3 expansion 0           | TA3EX0   | 20h    |
| TA3 interrupt vector      | TA3IV    | 2Eh    |

**Table 6-39. MPY32 Registers (Base Address: 04C0h)**

| REGISTER DESCRIPTION                                    | ACRONYM   | OFFSET |
|---------------------------------------------------------|-----------|--------|
| 16-bit operand 1 – multiply                             | MPY       | 00h    |
| 16-bit operand 1 – signed multiply                      | MPYS      | 02h    |
| 16-bit operand 1 – multiply accumulate                  | MAC       | 04h    |
| 16-bit operand 1 – signed multiply accumulate           | MACS      | 06h    |
| 16-bit operand 2                                        | OP2       | 08h    |
| 16 × 16 result low word                                 | RESLO     | 0Ah    |
| 16 × 16 result high word                                | RESHI     | 0Ch    |
| 16 × 16 sum extension                                   | SUMEXT    | 0Eh    |
| 32-bit operand 1 – multiply low word                    | MPY32L    | 10h    |
| 32-bit operand 1 – multiply high word                   | MPY32H    | 12h    |
| 32-bit operand 1 – signed multiply low word             | MPYS32L   | 14h    |
| 32-bit operand 1 – signed multiply high word            | MPYS32H   | 16h    |
| 32-bit operand 1 – multiply accumulate low word         | MAC32L    | 18h    |
| 32-bit operand 1 – multiply accumulate high word        | MAC32H    | 1Ah    |
| 32-bit operand 1 – signed multiply accumulate low word  | MACS32L   | 1Ch    |
| 32-bit operand 1 – signed multiply accumulate high word | MACS32H   | 1Eh    |
| 32-bit operand 2 – low word                             | OP2L      | 20h    |
| 32-bit operand 2 – high word                            | OP2H      | 22h    |
| 32 × 32 result 0 – least significant word               | RES0      | 24h    |
| 32 × 32 result 1                                        | RES1      | 26h    |
| 32 × 32 result 2                                        | RES2      | 28h    |
| 32 × 32 result 3 – most significant word                | RES3      | 2Ah    |
| MPY32 control 0                                         | MPY32CTL0 | 2Ch    |

**Table 6-40. eUSCI\_A0 Registers (Base Address: 0500h)**

| REGISTER DESCRIPTION          | ACRONYM     | OFFSET |
|-------------------------------|-------------|--------|
| eUSCI_A control word 0        | UCA0CTLW0   | 00h    |
| eUSCI_A control word 1        | UCA0CTLW1   | 02h    |
| eUSCI_A control rate 0        | UCA0BR0     | 06h    |
| eUSCI_A control rate 1        | UCA0BR1     | 07h    |
| eUSCI_A modulation control    | UCA0MCTLW   | 08h    |
| eUSCI_A status                | UCA0STAT    | 0Ah    |
| eUSCI_A receive buffer        | UCA0RXBUF   | 0Ch    |
| eUSCI_A transmit buffer       | UCA0TXBUF   | 0Eh    |
| eUSCI_A LIN control           | UCA0ABCTL   | 10h    |
| eUSCI_A IrDA transmit control | IUCA0IRTCTL | 12h    |
| eUSCI_A IrDA receive control  | IUCA0IRRCTL | 13h    |
| eUSCI_A interrupt enable      | UCA0IE      | 1Ah    |
| eUSCI_A interrupt flags       | UCA0IFG     | 1Ch    |
| eUSCI_A interrupt vector word | UCA0IV      | 1Eh    |

**Table 6-41. eUSCI\_A1 Registers (Base Address: 0520h)**

| REGISTER DESCRIPTION          | ACRONYM     | OFFSET |
|-------------------------------|-------------|--------|
| eUSCI_A control word 0        | UCA1CTLW0   | 00h    |
| eUSCI_A control word 1        | UCA1CTLW1   | 02h    |
| eUSCI_A control rate 0        | UCA1BR0     | 06h    |
| eUSCI_A control rate 1        | UCA1BR1     | 07h    |
| eUSCI_A modulation control    | UCA1MCTLW   | 08h    |
| eUSCI_A status                | UCA1STAT    | 0Ah    |
| eUSCI_A receive buffer        | UCA1RXBUF   | 0Ch    |
| eUSCI_A transmit buffer       | UCA1TXBUF   | 0Eh    |
| eUSCI_A LIN control           | UCA1ABCTL   | 10h    |
| eUSCI_A IrDA transmit control | IUCA1IRTCTL | 12h    |
| eUSCI_A IrDA receive control  | IUCA1IRRCTL | 13h    |
| eUSCI_A interrupt enable      | UCA1IE      | 1Ah    |
| eUSCI_A interrupt flags       | UCA1IFG     | 1Ch    |
| eUSCI_A interrupt vector word | UCA1IV      | 1Eh    |

**Table 6-42. eUSCI\_B0 Registers (Base Address: 0540h)**

| REGISTER DESCRIPTION           | ACRONYM     | OFFSET |
|--------------------------------|-------------|--------|
| eUSCI_B control word 0         | UCB0CTLW0   | 00h    |
| eUSCI_B control word 1         | UCB0CTLW1   | 02h    |
| eUSCI_B bit rate 0             | UCB0BR0     | 06h    |
| eUSCI_B bit rate 1             | UCB0BR1     | 07h    |
| eUSCI_B status word            | UCB0STATW   | 08h    |
| eUSCI_B byte counter threshold | UCB0TBCNT   | 0Ah    |
| eUSCI_B receive buffer         | UCB0RXBUF   | 0Ch    |
| eUSCI_B transmit buffer        | UCB0TXBUF   | 0Eh    |
| eUSCI_B I2C own address 0      | UCB0I2COA0  | 14h    |
| eUSCI_B I2C own address 1      | UCB0I2COA1  | 16h    |
| eUSCI_B I2C own address 2      | UCB0I2COA2  | 18h    |
| eUSCI_B I2C own address 3      | UCB0I2COA3  | 1Ah    |
| eUSCI_B receive address        | UCB0ADDRX   | 1Ch    |
| eUSCI_B address mask           | UCB0ADDMASK | 1Eh    |
| eUSCI_B I2C slave address      | UCB0I2CSA   | 20h    |
| eUSCI_B interrupt enable       | UCB0IE      | 2Ah    |
| eUSCI_B interrupt flags        | UCB0IFG     | 2Ch    |
| eUSCI_B interrupt vector word  | UCB0IV      | 2Eh    |

**Table 6-43. Backup Memory Registers (Base Address: 0660h)**

| REGISTER DESCRIPTION | ACRONYM  | OFFSET |
|----------------------|----------|--------|
| Backup memory 0      | BAKMEM0  | 00h    |
| Backup memory 1      | BAKMEM1  | 02h    |
| Backup memory 2      | BAKMEM2  | 04h    |
| Backup memory 3      | BAKMEM3  | 06h    |
| Backup memory 4      | BAKMEM4  | 08h    |
| Backup memory 5      | BAKMEM5  | 0Ah    |
| Backup memory 6      | BAKMEM6  | 0Ch    |
| Backup memory 7      | BAKMEM7  | 0Eh    |
| Backup memory 8      | BAKMEM8  | 10h    |
| Backup memory 9      | BAKMEM9  | 12h    |
| Backup memory 10     | BAKMEM10 | 14h    |
| Backup memory 11     | BAKMEM11 | 16h    |
| Backup memory 12     | BAKMEM12 | 18h    |
| Backup memory 13     | BAKMEM13 | 1Ah    |
| Backup memory 14     | BAKMEM14 | 1Ch    |
| Backup memory 15     | BAKMEM15 | 1Eh    |

**Table 6-44. ADC Registers (Base Address: 0700h)**

| REGISTER DESCRIPTION                 | ACRONYM  | OFFSET |
|--------------------------------------|----------|--------|
| ADC control 0                        | ADCCTL0  | 00h    |
| ADC control 1                        | ADCCTL1  | 02h    |
| ADC control 2                        | ADCCTL2  | 04h    |
| ADC window comparator low threshold  | ADCLO    | 06h    |
| ADC window comparator high threshold | ADCHI    | 08h    |
| ADC memory control 0                 | ADCMCTL0 | 0Ah    |
| ADC conversion memory                | ADCMEM0  | 12h    |
| ADC interrupt enable                 | ADCIE    | 1Ah    |
| ADC interrupt flags                  | ADCIFG   | 1Ch    |
| ADC interrupt vector word            | ADCIV    | 1Eh    |

## 6.14 Identification

### 6.14.1 Revision Identification

The device revision information is included as part of the top-side marking on the device package. The device-specific errata sheet describes these markings (see [§ 8.4](#)).

The hardware revision is also stored in the Device Descriptor structure in the Information Block section. For details on this value, see the Hardware Revision entries in [Table 6-22](#).

### 6.14.2 Device Identification

The device type can be identified from the top-side marking on the device package. The device-specific errata sheet describes these markings (see [§ 8.4](#)).

A device identification value is also stored in the Device Descriptor structure in the Information Block section. For details on this value, see the Device ID entries in [Table 6-22](#).

### 6.14.3 JTAG Identification

Programming through the JTAG interface, including reading and identifying the JTAG ID, is described in [MSP430 Programming With the JTAG Interface](#).

## 7 Applications, Implementation, and Layout

### NOTE

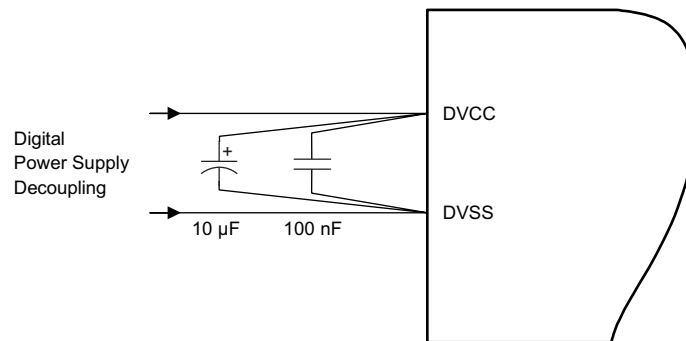
Information in the following Applications section is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

### 7.1 Device Connection and Layout Fundamentals

This section discusses the recommended guidelines when designing with the MSP430 devices. These guidelines are to make sure that the device has proper connections for powering, programming, debugging, and optimum analog performance.

#### 7.1.1 Power Supply Decoupling and Bulk Capacitors

TI recommends connecting a combination of a 10- $\mu$ F and a 100-nF low-ESR ceramic decoupling capacitor to the DVCC and DVSS pins (see [Figure 7-1](#)). Higher-value capacitors may be used but can impact supply rail ramp-up time. Decoupling capacitors must be placed as close as possible to the pins that they decouple (within a few millimeters). Additionally, TI recommends separated grounds with a single-point connection for better noise isolation from digital-to-analog circuits on the board and to achieve high analog accuracy.



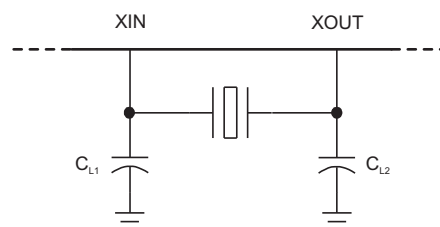
**Figure 7-1. Power Supply Decoupling**

#### 7.1.2 External Oscillator

This device supports only a low-frequency crystal (32 kHz) on the XIN and XOUT pins. External bypass capacitors for the crystal oscillator pins are required.

It is also possible to apply digital clock signals to the XIN input pin that meet the specifications of the respective oscillator if the appropriate XT1BYPASS mode is selected. In this case, the associated XOUT pin can be used for other purposes. If the XIN and XOUT pins are not used, they must be terminated according to [Section 4.6](#).

[Figure 7-2](#) shows a typical connection diagram.



**Figure 7-2. Typical Crystal Connection**

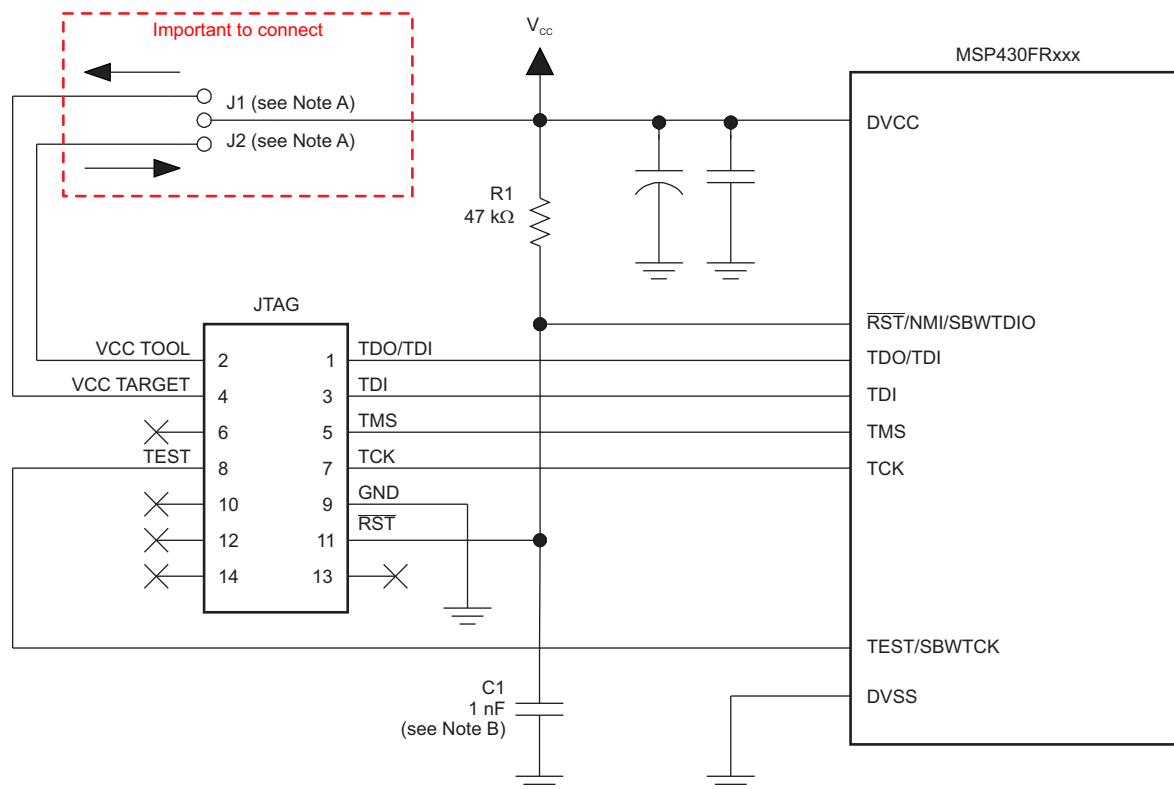
See [MSP430 32-kHz Crystal Oscillators](#) for more information on selecting, testing, and designing a crystal oscillator with the MSP430 devices.

### 7.1.3 JTAG

With the proper connections, the debugger and a hardware JTAG interface (such as the MSP-FET or MSP-FET430UIF) can be used to program and debug code on the target board. In addition, the connections also support the MSP-GANG production programmers, thus providing an easy way to program prototype boards, if desired. [Figure 7-3](#) shows the connections between the 14-pin JTAG connector and the target device required to support in-system programming and debugging for 4-wire JTAG communication. [Figure 7-4](#) shows the connections for 2-wire JTAG mode (Spy-Bi-Wire).

The connections for the MSP-FET and MSP-FET430UIF interface modules and the MSP-GANG are identical. Both can supply  $V_{CC}$  to the target board (through pin 2). In addition, the MSP-FET and MSP-FET430UIF interface modules and MSP-GANG have a  $V_{CC}$  sense feature that, if used, requires an alternate connection (pin 4 instead of pin 2). The  $V_{CC}$  sense feature detects the local  $V_{CC}$  present on the target board (that is, a battery or other local power supply) and adjusts the output signals accordingly. [Figure 7-3](#) and [Figure 7-4](#) show a jumper block that supports both scenarios of supplying  $V_{CC}$  to the target board. If this flexibility is not required, the desired  $V_{CC}$  connections may be hard-wired to eliminate the jumper block. Pins 2 and 4 must not be connected at the same time.

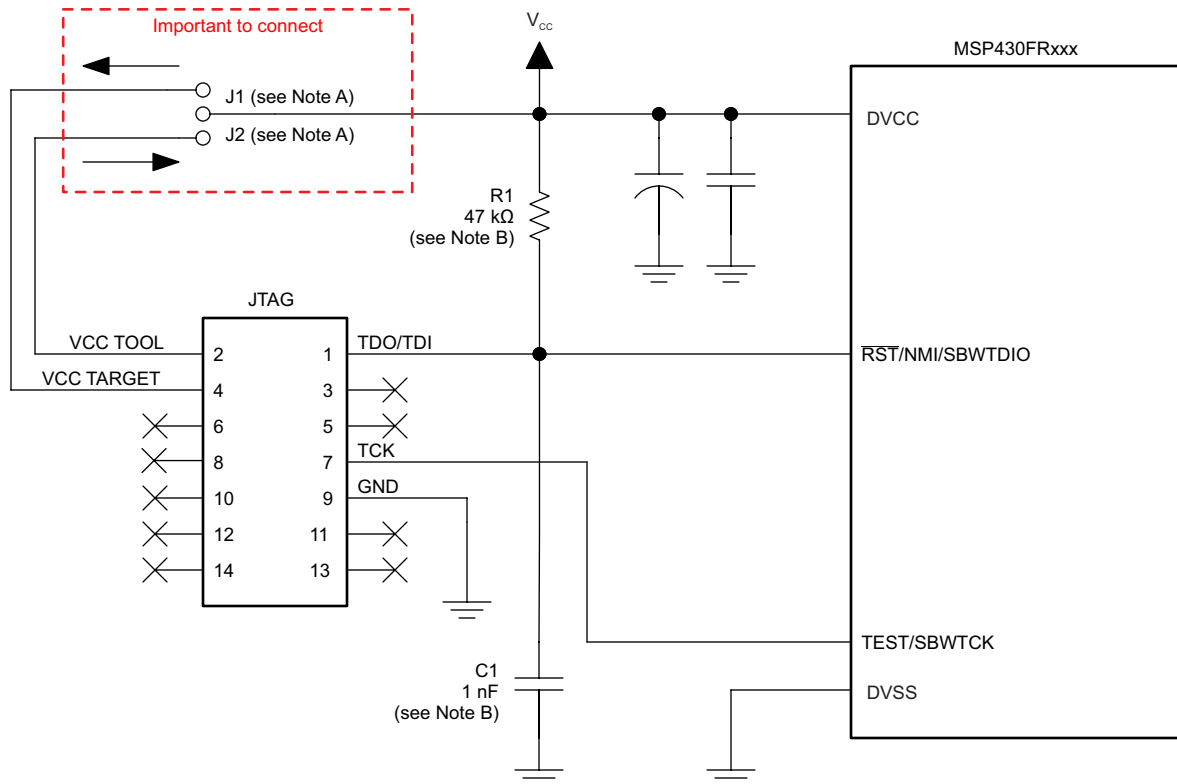
For additional design information regarding the JTAG interface, see the [MSP430 Hardware Tools User's Guide](#).



- If a local target power supply is used, make connection J1. If power from the debug or programming adapter is used, make connection J2.
- The upper limit for C1 is 1.1 nF when using current TI tools.

**Figure 7-3. Signal Connections for 4-Wire JTAG Communication**





- Make connection J1 if a local target power supply is used, or make connection J2 if the target is powered from the debug or programming adapter.
- The device  $\overline{\text{RST}}/\text{NMI}/\text{SBWTIO}$  pin is used in 2-wire mode for bidirectional communication with the device during JTAG access, and any capacitance that is attached to this signal may affect the ability to establish a connection with the device. The upper limit for C1 is 1.1 nF when using current TI tools.

**Figure 7-4. Signal Connections for 2-Wire JTAG Communication (Spy-Bi-Wire)**

### 7.1.4 Reset

The reset pin can be configured as a reset function (default) or as an NMI function in the Special Function Register (SFR),  $\text{SFRRPCR}$ .

In reset mode, the  $\overline{\text{RST}}/\text{NMI}$  pin is active low, and a pulse applied to this pin that meets the reset timing specifications generates a BOR-type device reset.

Setting  $\text{SYSNMI}$  causes the  $\overline{\text{RST}}/\text{NMI}$  pin to be configured as an external NMI source. The external NMI is edge sensitive, and its edge is selectable by  $\text{SYSNMIIES}$ . Setting the  $\text{NMIIE}$  enables the interrupt of the external NMI. When an external NMI event occurs, the  $\text{NMIIFG}$  is set.

The  $\overline{\text{RST}}/\text{NMI}$  pin can have either a pullup or pulldown that is enabled or not.  $\text{SYSRSTUP}$  selects either pullup or pulldown, and  $\text{SYSRSTRE}$  causes the pullup (default) or pulldown to be enabled (default) or not. If the  $\overline{\text{RST}}/\text{NMI}$  pin is unused, it is required either to select and enable the internal pullup or to connect an external 47-k $\Omega$  pullup resistor to the  $\overline{\text{RST}}/\text{NMI}$  pin with a 1.1-nF pulldown capacitor. The pulldown capacitor should not exceed 1.1 nF when using devices with Spy-Bi-Wire interface in Spy-Bi-Wire mode or in 4-wire JTAG mode with TI tools like FET interfaces or GANG programmers.

See the [MSP430FR4xx and MSP430FR2xx Family User's Guide](#) for more information on the referenced control registers and bits.

### 7.1.5 Unused Pins

For details on the connection of unused pins, see [Section 4.6](#).

### 7.1.6 General Layout Recommendations

- Proper grounding and short traces for external crystal to reduce parasitic capacitance. For recommended layout guidelines, see [MSP430 32-kHz Crystal Oscillators](#).
- Proper bypass capacitors on DVCC and reference pins, if used.
- Avoid routing any high-frequency signal close to an analog signal line. For example, keep digital switching signals such as PWM or JTAG signals away from the oscillator circuit and ADC signals.
- Proper ESD level protection should be considered to protect the device from unintended high-voltage electrostatic discharge. For guidelines see [MSP430 System-Level ESD Considerations](#).

### 7.1.7 Do's and Don'ts

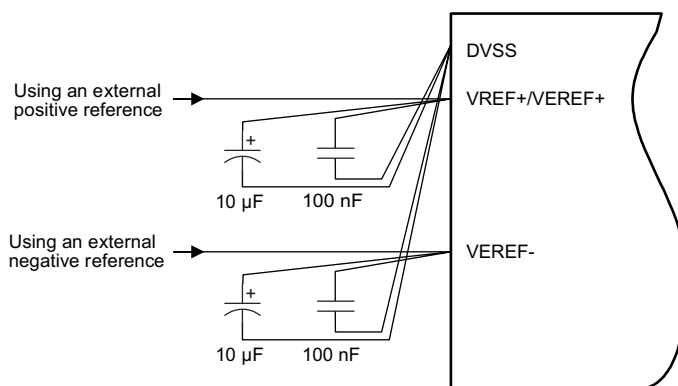
During power up, power down, and device operation, DVCC must not exceed the limits specified in [Section 5.1](#). Exceeding the specified limits may cause malfunction of the device including erroneous writes to RAM and FRAM.

## 7.2 Peripheral- and Interface-Specific Design Information

### 7.2.1 ADC Peripheral

#### 7.2.1.1 Partial Schematic

[Figure 7-5](#) shows the recommended decoupling circuit when an external voltage reference is used.



**Figure 7-5. ADC Grounding and Noise Considerations**

#### 7.2.1.2 Design Requirements

As with any high-resolution ADC, appropriate PCB layout and grounding techniques must be followed to eliminate ground loops, unwanted parasitic effects, and noise.

Ground loops are formed when return current from the ADC flows through paths that are common with other analog or digital circuitry. If care is not taken, this current can generate small unwanted offset voltages that can add to or subtract from the reference or input voltages of the ADC. The general guidelines in [Section 7.1.1](#) combined with the connections shown in [Figure 7-5](#) prevent this.

Quickly switching digital signals and noisy power supply lines can corrupt the conversion results, so keep the ADC input trace shielded from those digital and power supply lines. Putting the MCU in low-power mode during the ADC conversion improves the ADC performance in a noisy environment. If the device includes the analog power pair inputs (AVCC and AVSS), TI recommends a noise-free design using separate analog and digital ground planes with a single-point connection to achieve high accuracy.

[Figure 7-5](#) shows the recommended decoupling circuit when an external voltage reference is used. The internal reference module has a maximum drive current as described in the sections *ADC Pin Enable* and *1.2-V Reference Settings* of the [MSP430FR4xx and MSP430FR2xx Family User's Guide](#).

The reference voltage must be a stable voltage for accurate measurements. The capacitor values that are selected in the general guidelines filter out the high- and low-frequency ripple before the reference voltage enters the device. In this case, the 10- $\mu$ F capacitor buffers the reference pin and filters any low-frequency ripple. A bypass capacitor of 100 nF filters out any high-frequency noise.

### 7.2.1.3 Layout Guidelines

Components that are shown in the partial schematic (see [Figure 7-5](#)) should be placed as close as possible to the respective device pins to avoid long traces, because they add additional parasitic capacitance, inductance, and resistance on the signal.

Avoid routing analog input signals close to a high-frequency pin (for example, a high-frequency PWM), because the high-frequency switching can be coupled into the analog signal.

## 7.2.2 CapTIvate Peripheral

This section provides a brief introduction to the CapTIvate technology with examples of PCB layout and performance from the design kit. A more detailed description of the CapTIvate technology and the tools needed to be successful, application development tools, hardware design guides, and software library, can be found in the [CapTIvate™ Technology Guide](#).

### 7.2.2.1 Device Connection and Layout Fundamentals

To learn more on how to design the CapTIvate Technology, see the [Capacitive Touch Design Flow for MSP430™ MCUs With CapTIvate™ Technology](#) application report.

## 7.2.2.2 Measurements

The following measurements are taken from the [CapTivate Technology Design Center](#), using the [CAPTIVATE-PHONE](#) and [CAPTIVATE-BSWP](#) panels. Unless otherwise stated, the settings used are the out-of-box settings, which can be found in the example projects. The intent of these measurements is to show performance in a configuration that is readily available and reproducible.



Figure 7-6. CAPTIVATE-PHONE and CAPTIVATE-BSWP Panels

### 7.2.2.2.1 SNR

The [Sensitivity, SNR, and Design Margin in Capacitive Touch Applications](#) application report provides a specific view for analyzing the signal-to-noise ratio of each element.

### 7.2.2.2.2 Sensitivity

To show sensitivity, in terms of farads, the internal reference capacitor is used as the change in capacitance. In the mutual-capacitance case, the 0.1-pF capacitor is used. In the self-capacitance case, the 1-pF reference capacitor is used. For simplicity, the results for only button 1 on both the CAPTIVATE-PHONE and CAPTIVATE-BSWP panels are reported in [Table 7-1](#).

Table 7-1. Button Sensitivity

| CONVERSION<br>COUNT | CONVERSION<br>GAIN | CAPTIVATE-PHONE BUTTON 1 |                                | CAPTIVATE-BSWP BUTTON 1 |                           |
|---------------------|--------------------|--------------------------|--------------------------------|-------------------------|---------------------------|
|                     |                    | CONVERSION<br>TIME (μs)  | COUNTS FOR<br>0.1-pF<br>CHANGE | CONVERSION<br>TIME (μs) | COUNTS FOR<br>1-pF CHANGE |
| 100                 | 100                | 25                       | 6                              | 50                      | 8                         |
| 200                 | 200                | 50                       | 10                             | 100                     | 16                        |
| 200                 | 100                | 50                       | 21                             | 100                     | 31                        |
| 800                 | 400                | 200                      | 70                             | 400                     | 112                       |
| 800                 | 200                | 200                      | 140                            | 400                     | 202                       |
| 800                 | 100                | 200                      | 257                            | 400                     | 333                       |

An alternative measure in sensitivity is the ability to resolve capacitance change over a wide range of base capacitance. [Table 7-2](#) shows example conversion times (for a self-mode measurement of discrete capacitors) that can be used to achieve the desired resolution for a given parasitic load capacitance.

**Table 7-2. Button Sensitivity**

| CAPACITANCE, C <sub>p</sub><br>(pF) <sup>(1)</sup> | CONVERSION<br>COUNT/GAIN | CONVERSION TIME<br>(μs) | COUNTS FOR<br>0.130-pF CHANGE | COUNTS FOR<br>0.260-pF CHANGE | COUNTS FOR<br>0.520-pF CHANGE |
|----------------------------------------------------|--------------------------|-------------------------|-------------------------------|-------------------------------|-------------------------------|
| 23                                                 | 400/100                  | 200                     | 10                            | 23                            | 35                            |
| 50                                                 | 550/100                  | 275                     | 11                            | 24                            | 37                            |
| 78                                                 | 650/100                  | 325                     | 11                            | 23                            | 36                            |
| 150                                                | 850/100                  | 425                     | 11                            | 22                            | 35                            |
| 150 <sup>(2)</sup>                                 | 1200/200                 | 600                     | 11                            | 23                            | 37                            |
| 200 <sup>(2)</sup>                                 | 1200/150                 | 600                     | 13                            | 26                            | 41                            |

(1) These measurements were taken with the CapTIvate MCU processor board with the 470-Ω series resistors replaced with 0-Ω resistors.

(2) 0-V discharge voltage is used.

### 7.2.2.2.3 Power

The low-power mode LPM3 specifications in [Section 5.7](#) are derived from the CapTIvate technology design kit as indicated in the notes.

## 7.3 CapTIvate Technology Evaluation

[Table 7-3](#) lists tools that demonstrate the use of the MSP430FR263x devices. See [CapTIvate Evaluation Tools](#) to get started with evaluating the CapTIvate technology in various real-world application scenarios. Consult these evaluation tool designs for additional guidance regarding schematics, layout, and software implementation.

**Table 7-3. Evaluation Tools**

| NAME                                                        | LINK                                                                                                                  |
|-------------------------------------------------------------|-----------------------------------------------------------------------------------------------------------------------|
| MSP CapTIvate MCU Development Kit                           | <a href="http://www.ti.com/tool/msp-capt-fr2633">http://www.ti.com/tool/msp-capt-fr2633</a>                           |
| Capacitive Touch Thermostat User Interface Reference Design | <a href="http://www.ti.com/tool/tidm-captivate-thermostat-ui">http://www.ti.com/tool/tidm-captivate-thermostat-ui</a> |

## 8 器件和文档支持

### 8.1 入门和后续步骤

更过有关 MSP 低功耗微控制器以及开发协助工具和库的信息，请访问《[MSP430™ 超低功耗传感和测量 MCU 概述](#)》。

### 8.2 器件命名规则

为了标示产品开发周期所处的阶段，TI 为所有 MSP MCU 器件的部件号分配了前缀。每个 MSP MCU 商用系列产品成员都具有以下两个前缀之一：MSP 或 XMS。这些前缀代表了产品的发展阶段，即从工程原型 (XMS) 直到完全合格的生产器件 (MSP)。

**XMS** - 实验器件，不一定代表最终器件的电气规格

**MSP** - 完全合格的生产器件

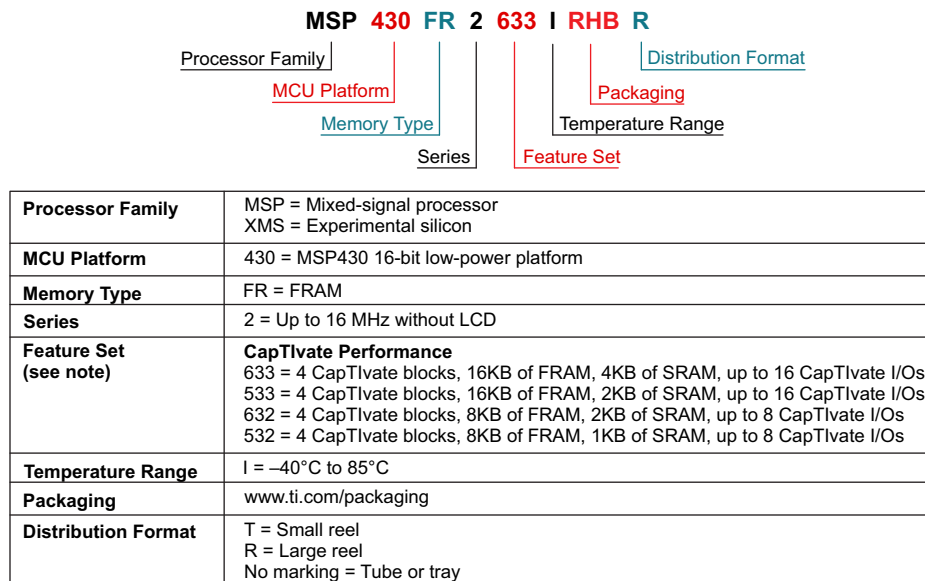
XMS 器件在供货时附带如下免责声明：

“开发中的产品用于内部评估用途。”

MSP 器件的特性已经全部明确，并且器件的质量和可靠性已经完全论证。TI 的标准保修证书对该器件适用。

预测显示原型器件 (XMS) 的故障率大于标准生产器件。由于这些器件的预计最终使用故障率尚不确定，德州仪器 (TI) 建议不要将它们用于任何生产系统。请仅使用合格的生产器件。

TI 器件的命名规则还包括一个带有器件系列名称的后缀。此后缀表示温度范围、封装类型和配送形式。图 8-1 提供了解读完整器件名称的图例。



NOTE: 有关采用 CapTIvate 触控技术的器件的更多指导，请参阅《[CapTIvate 技术指南](#)》中的器件选择基准。

图 8-1. 器件命名规则

### 8.3 工具和软件

所有 MSP 微控制器均受多种软件和硬件开发工具的支持。相关工具由 TI 以及多家第三方供应商提供。可从 [低功耗 MCU 开发套件和软件](#) 获取全部信息。

表 8-1 列 调试 的调试功能。请参阅《[适用于 MSP430 MCU 的 Code Composer Studio IDE 用户指南](#)》，以了解有关可用 功能）的详细信息。

表 8-1. 硬件调试 特性

| MSP430 架构 | 四线制 JTAG | 两线制 JTAG | 断点 (N) | 范围断点 | 时钟控制 | 状态序列发生器 | 跟踪缓冲器 | LPMx.5 调试支持 | EEM 版本 |
|-----------|----------|----------|--------|------|------|---------|-------|-------------|--------|
| MSP430Xv2 | 有        | 有        | 3      | 有    | 是    | 否       | 否     | 否           | S      |

#### 设计套件与评估模块

##### MSP CapTivate MCU 开发套件

MSP CapTivate MCU 开发套件是一种用于评估采用电容式触控技术的 MSP430FR2633 微控制器的易用综合性平台。此套件包含基于 MSP430FR2633 的处理器板、采用 EnergyTrace 技术的编程器和调试器板（用于通过 Code Composer Studio IDE 测量能耗），以及用于评估自电容、互电容、手势和接近传感的传感器板。

#### 软件

##### MSP430Ware 软件

MSP430Ware 是一套设计资源集，可帮助用户高效地创建和构建 MSP430 代码。MSP430Ware 包括各种高度抽象的软件库，范围涵盖 MSP 驱动程序库或 USB 等特定于器件和外设的库，以及图形库和电容式触控库等特定于应用的库。MSP430 驱动程序库是一个尤为重要的库，可以帮助软件开发人员利用便捷的 API 来控制错综复杂的低级别硬件外设，从而使生成的代码更易于读取和维护。

##### MSP430FR243x、MSP430FR253x、MSP430FR263x 代码示例

根据不同应用需求配置各集成外设的每个 MSP 器件均具备相应的 C 代码示例。

##### MSP 驱动程序库

MSP 驱动程序库的抽象 API 提供易用的函数调用，无需直接操纵 MSP430 硬件的位与字节。完整的文档通过具有帮助意义的 API 指南交付，其中包括有关每个函数调用和经过验证的参数的详细信息。开发人员可以使用驱动程序库功能，以最低开销编写完整项目。

##### MSP EnergyTrace™ 技术

适用于 MSP430 微控制器的 EnergyTrace 技术是基于电能的代码分析工具，适用于测量和显示应用的电能系统配置并帮助优化应用以实现超低功耗。

##### ULP（超低功耗）Advisor

ULP Advisor™ 软件是一款辅助工具，旨在指导开发人员编写更为高效的代码，从而充分利用 MSP430 和 MSP432 微控制器 独特 功能。ULP Advisor 的目标人群是微控制器的资深开发者和开发新手，可以根据详尽的 ULP 检验表检查代码，以便最大限度地减少应用程序的能耗。在编译时，ULP Advisor 会提供通知和备注以突出显示代码中可以进一步优化的区域，进而实现更低功耗。



## IEC60730 软件包

IEC60730 MSP430 软件包经过专门开发，用于协助客户达到 IEC 60730-1:2010（家用及类似用途的自动化电气控制 - 第 1 部分：一般要求）B 类产品的要求。其中涵盖家用电器、电弧检测器、电源转换器、电动工具、电动自行车及其他诸多产品。IEC60730 MSP430 软件包可以嵌入在 MSP430 MCU 中运行的客户应用，从而帮助客户简化其消费类器件在功能安全方面遵循 IEC 60730-1:2010 B 类规范的认证工作。

## 适用于 MSP 的定点数学库

MSP IQmath 和 Qmath 库是为 C 语言编程器提供的经过高度优化的高精度数学运算函数集合，能够将浮点算法无缝嵌入 MSP430 和 MSP432 器件的定点代码中。这些例程通常用于计算密集型实时应用，而优化的执行速度、高精度以及超低能耗通常是影响这些实时应用的关键因素。与使用浮点数学算法编写的同等代码相比，使用 IQmath 和 Qmath 库可以大幅提高执行速度并显著降低能耗。

## 适用于 MSP430 的浮点数学库

TI 在低功耗和低成本微控制器领域锐意创新，为您提供 MSPMATHLIB。此标量函数的浮点数学库，能够充分利用器件的智能外设，使速度最高达到标准 MSP430 数学函数的 26 倍。Mathlib 能够轻松集成到您的设计中。该运算库免费使用并集成在 Code Composer Studio IDE 和 IAR Embedded Workbench IDE 中。

## 开发工具

### 适用于 MSP 微控制器的 Code Composer Studio™ 集成开发环境

Code Composer Studio (CCS) 集成开发环境 (IDE) 支持所有 MSP 微控制器器件。CCS 包含一整套用于开发和调试嵌入式应用的工具。它包含了优化的 C/C++ 编译器、源代码编辑器、项目构建环境、调试器、描述器以及其他多种功能。

### 命令行编程器

MSP Flasher 是一款基于 shell 的开源接口，可使用 JTAG 或 Spy-Bi-Wire (SBW) 通信通过 FET 编程器或 eZ430 对 MSP 微控制器进行编程。MSP Flasher 可用于将二进制文件（.txt 或 .hex 文件）直接下载到 MSP 微控制器，而无需使用 IDE。

### MSP MCU 编程器和调试器

MSP-FET 是一款强大的仿真开发工具（通常称为调试探针），可让用户在 MSP 低功耗微控制器 (MCU) 上快速进行应用开发。创建 MCU 软件通常需要将生成的二进制程序下载到 MSP 器件，以进行验证和调试。MSP-FET 在主机和目标 MSP 间提供调试通信通道。此外，MSP-FET 还在计算机的 USB 接口和 MSP UART 之间提供反向通道 UART 连接。这为 MSP 编程器提供了一种便捷方法，实现了 MSP 和在计算机上运行的终端之间的串行通信。

### MSP-GANG 生产编程器

MSP Gang 编程器可同时对多达八个完全相同的 MSP430 或 MSP432 闪存或 FRAM 器件进行编程。MSP Gang 编程器可使用标准的 RS-232 或 USB 连接与主机 PC 相连并提供灵活的编程选项，允许用户完全自定义流程。MSP Gang 编程器配有扩展板“Gang 分离器”，可在 MSP Gang 编程器和多个目标器件间实现互连。



## 8.4 文档支持

以下文档对 MSP430FR263x 和 MSP430FR253x MCU 进行了介绍。[www.ti.com.cn](http://www.ti.com.cn) 网站上提供了这些文档的副本。

### 接收文档更新通知

如需接收文档更新通知（包括器件勘误表），请转至 [ti.com.cn](http://ti.com.cn) 上相关器件的产品文件夹（关于这些产品文件夹的链接，请参阅节 8.5）。单击右上角的“提醒我”(Alert me) 按钮。点击注册后，即可收到产品信息更改每周摘要（如有）。有关更改的详细信息，请查阅已修订文档的修订历史记录。

### 勘误

#### 《MSP430FR2633 器件勘误表》

说明了功能规格的已知例外情况。

#### 《MSP430FR2533 器件勘误表》

说明了功能规格的已知例外情况。

#### 《MSP430FR2632 器件勘误表》

说明了功能规格的已知例外情况。

#### 《MSP430FR2532 器件勘误表》

说明了功能规格的已知例外情况。

### 用户指南

#### 《MSP430FR4xx 和 MSP430FR2xx 系列用户指南》

详细介绍了该器件系列提供的模块和外设。

#### 《MSP430 FRAM 器件引导加载程序 (BSL) 用户指南》

在 MSP430 MCU 项目开发和更新阶段，引导加载程序 (BSL) 提供存储器的编程方法。该程序可由使用串行协议发送命令的工具激活。BSL 支持用户控制 MSP430 MCU 的活动，可与个人计算机或其他设备进行数据交换。

#### 《MSP430 硬件工具用户指南》

此手册介绍了 TI MSP-FET430 闪存仿真工具 (FET) 的硬件。FET 是针对 MSP430 超低功耗微控制器的程序开发工具。

### 应用报告

#### MSP430 FRAM 技术 – 操作方法和最佳实践

FRAM 采用非易失性存储器技术，行为与 SRAM 类似，支持大量新应用，还改变了固件的设计方式。该应用程序报告从嵌入式软件开发方面概述了 FRAM 技术在 MSP430 中的使用方法和最佳实践。其中介绍了如何按照应用程序特定的代码、常量、数据空间要求实施存储器布局以及如何使用 FRAM 优化应用程序的能耗。

#### MSP430FR4xx 和 MSP430FR2xx 系列的 VLO 校准

MSP430FR4xx 和 MSP430FR2xx (FR4xx/FR2xx) 系列微控制器 (MCU) 提供了各种时钟源，包括一些高速、高精度时钟以及一些低功耗、低系统成本时钟。用户可以选择以最佳方式权衡了性能、功耗和系统成本的时钟。片上超低频振荡器 (VLO) 是 FR4xx/FR2xx 系列 MCU 中包含的频率为 10kHz（典型值）的时钟源。VLO 具有超低的功耗，因而广泛适用于各种应用。

### 《MSP430 32kHz 晶体振荡器》

选择合适的晶体、正确的负载电路和适当的电路板布局是实现稳定的晶体振荡器的关键。该应用报告总结了晶体振荡器的功能，介绍了用于选择合适的晶体以实现 **MSP430** 超低功耗运行的参数。此外，还给出了正确电路板布局的提示和示例。此外，为了确保振荡器在大规模生产后能够稳定运行，还可能需要进行一些振荡器测试，该文档中提供了有关这些测试的详细信息。

### 《MSP430 系统级 ESD 注意事项》

随着芯片技术向更低电压方向发展以及设计具有成本效益的超低功耗组件的需求的出现，系统级 **ESD** 要求变得越来越苛刻。该应用报告介绍了不同的 **ESD** 主题，旨在帮助电路板设计人员和 **OEM** 理解并设计出稳健耐用的系统级设计。

## 8.5 相关链接

表 8-2 列出了快速访问链接。类别包括技术文档、支持和社区资源、工具和软件，以及立即订购快速访问。

表 8-2. 相关链接

| 器件           | 产品文件夹                | 立即订购                 | 技术文档                 | 工具和软件                | 支持和社区                |
|--------------|----------------------|----------------------|----------------------|----------------------|----------------------|
| MSP430FR2633 | <a href="#">单击此处</a> | <a href="#">单击此处</a> | <a href="#">单击此处</a> | <a href="#">单击此处</a> | <a href="#">单击此处</a> |
| MSP430FR2632 | <a href="#">单击此处</a> | <a href="#">单击此处</a> | <a href="#">单击此处</a> | <a href="#">单击此处</a> | <a href="#">单击此处</a> |
| MSP430FR2533 | <a href="#">单击此处</a> | <a href="#">单击此处</a> | <a href="#">单击此处</a> | <a href="#">单击此处</a> | <a href="#">单击此处</a> |
| MSP430FR2532 | <a href="#">单击此处</a> | <a href="#">单击此处</a> | <a href="#">单击此处</a> | <a href="#">单击此处</a> | <a href="#">单击此处</a> |

## 8.6 社区资源

下列链接提供到 **TI** 社区资源的连接。链接的内容由各个分销商“按照原样”提供。这些内容并不构成 **TI** 技术规范，并且不一定反映 **TI** 的观点；请参见 **TI** 的《使用条款》。

### TI E2E™ 社区

**TI** 的工程师交流 (**E2E**) 社区。此社区的创建目的是为了促进工程师之间协作。在 [e2e.ti.com](http://e2e.ti.com) 中，您可以提问、共享知识、拓展思路，在同领域工程师的帮助下解决问题。

### TI 嵌入式处理器维基网页

德州仪器 (**TI**) 嵌入式处理器维基网页。此网站的建立是为了帮助开发人员熟悉德州仪器 (**TI**) 的嵌入式处理器，并且也为了促进与这些器件相关的硬件和软件的总体知识的创新和增长。

## 8.7 商标

CapTIvate, EnergyTrace, ULP Advisor, 适用于 MSP 微控制器的 Code Composer Studio, E2E are trademarks of Texas Instruments.

All other trademarks are the property of their respective owners.

## 8.8 静电放电警告



ESD 可能会损坏该集成电路。德州仪器 (TI) 建议通过适当的预防措施处理所有集成电路。如果不遵守正确的处理措施和安装程序，可能会损坏集成电路。

ESD 的损坏小至导致微小的性能降级，大至整个器件故障。精密的集成电路可能更容易受到损坏，这是因为非常细微的参数更改都可能会导致器件与其发布的规格不相符。

## 8.9 Export Control Notice

Recipient agrees to not knowingly export or re-export, directly or indirectly, any product or technical data (as defined by the U.S., EU, and other Export Administration Regulations) including software, or any controlled product restricted by other applicable national regulations, received from disclosing party under nondisclosure obligations (if any), or any direct product of such technology, to any destination to which such export or re-export is restricted or prohibited by U.S. or other applicable laws, without obtaining prior authorization from U.S. Department of Commerce and other competent Government authorities to the extent required by those laws.

## 8.10 Glossary

**TI Glossary** This glossary lists and explains terms, acronyms, and definitions.

## 9 机械、封装和可订购信息

以下页面包含机械、封装和可订购信息。这些信息是指定器件的最新可用数据。这些数据会在无通知且不对本文档进行修订的情况下发生改变。欲获得该数据表的浏览器版本，请查阅左侧的导航栏。

## PACKAGING INFORMATION

| Orderable Device  | Status<br>(1) | Package Type | Package<br>Drawing | Pins | Package<br>Qty | Eco Plan<br>(2) | Lead finish/<br>Ball material<br>(6) | MSL Peak Temp<br>(3) | Op Temp (°C) | Device Marking<br>(4/5) | Samples                 |
|-------------------|---------------|--------------|--------------------|------|----------------|-----------------|--------------------------------------|----------------------|--------------|-------------------------|-------------------------|
| MSP430FR2532IRGER | ACTIVE        | VQFN         | RGE                | 24   | 3000           | RoHS & Green    | NIPDAU                               | Level-2-260C-1 YEAR  | -40 to 85    | FR2532                  | <a href="#">Samples</a> |
| MSP430FR2532IRGET | ACTIVE        | VQFN         | RGE                | 24   | 250            | RoHS & Green    | NIPDAU                               | Level-2-260C-1 YEAR  | -40 to 85    | FR2532                  | <a href="#">Samples</a> |
| MSP430FR2533IDA   | ACTIVE        | TSSOP        | DA                 | 32   | 46             | RoHS & Green    | NIPDAU                               | Level-2-260C-1 YEAR  | -40 to 85    | FR2533                  | <a href="#">Samples</a> |
| MSP430FR2533IDAR  | ACTIVE        | TSSOP        | DA                 | 32   | 2000           | RoHS & Green    | NIPDAU                               | Level-2-260C-1 YEAR  | -40 to 85    | FR2533                  | <a href="#">Samples</a> |
| MSP430FR2533IRHBR | ACTIVE        | VQFN         | RHB                | 32   | 3000           | RoHS & Green    | NIPDAU                               | Level-2-260C-1 YEAR  | -40 to 85    | FR2533                  | <a href="#">Samples</a> |
| MSP430FR2533IRHBT | ACTIVE        | VQFN         | RHB                | 32   | 250            | RoHS & Green    | NIPDAU                               | Level-2-260C-1 YEAR  | -40 to 85    | FR2533                  | <a href="#">Samples</a> |
| MSP430FR2632IRGER | ACTIVE        | VQFN         | RGE                | 24   | 3000           | RoHS & Green    | NIPDAU                               | Level-2-260C-1 YEAR  | -40 to 85    | FR2632                  | <a href="#">Samples</a> |
| MSP430FR2632IRGET | ACTIVE        | VQFN         | RGE                | 24   | 250            | RoHS & Green    | NIPDAU                               | Level-2-260C-1 YEAR  | -40 to 85    | FR2632                  | <a href="#">Samples</a> |
| MSP430FR2632IYQWR | ACTIVE        | DSBGA        | YQW                | 24   | 3000           | RoHS & Green    | SNAGCU                               | Level-1-260C-UNLIM   | -40 to 85    | 430FR2632               | <a href="#">Samples</a> |
| MSP430FR2632IYQWT | ACTIVE        | DSBGA        | YQW                | 24   | 250            | RoHS & Green    | SNAGCU                               | Level-1-260C-UNLIM   | -40 to 85    | 430FR2632               | <a href="#">Samples</a> |
| MSP430FR2633IDA   | ACTIVE        | TSSOP        | DA                 | 32   | 46             | RoHS & Green    | NIPDAU                               | Level-2-260C-1 YEAR  | -40 to 85    | FR2633                  | <a href="#">Samples</a> |
| MSP430FR2633IDAR  | ACTIVE        | TSSOP        | DA                 | 32   | 2000           | RoHS & Green    | NIPDAU                               | Level-2-260C-1 YEAR  | -40 to 85    | FR2633                  | <a href="#">Samples</a> |
| MSP430FR2633IRHBR | ACTIVE        | VQFN         | RHB                | 32   | 3000           | RoHS & Green    | NIPDAU                               | Level-2-260C-1 YEAR  | -40 to 85    | FR2633                  | <a href="#">Samples</a> |
| MSP430FR2633IRHBT | ACTIVE        | VQFN         | RHB                | 32   | 250            | RoHS & Green    | NIPDAU                               | Level-2-260C-1 YEAR  | -40 to 85    | FR2633                  | <a href="#">Samples</a> |
| MSP430FR2633IYQWR | ACTIVE        | DSBGA        | YQW                | 24   | 3000           | RoHS & Green    | SNAGCU                               | Level-1-260C-UNLIM   | -40 to 85    | 430FR2633               | <a href="#">Samples</a> |
| MSP430FR2633IYQWT | ACTIVE        | DSBGA        | YQW                | 24   | 250            | RoHS & Green    | SNAGCU                               | Level-1-260C-UNLIM   | -40 to 85    | 430FR2633               | <a href="#">Samples</a> |

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

**RoHS Exempt:** TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

**Green:** TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of  $\leq 1000$ ppm threshold. Antimony trioxide based flame retardants must also meet the  $\leq 1000$ ppm threshold requirement.

<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

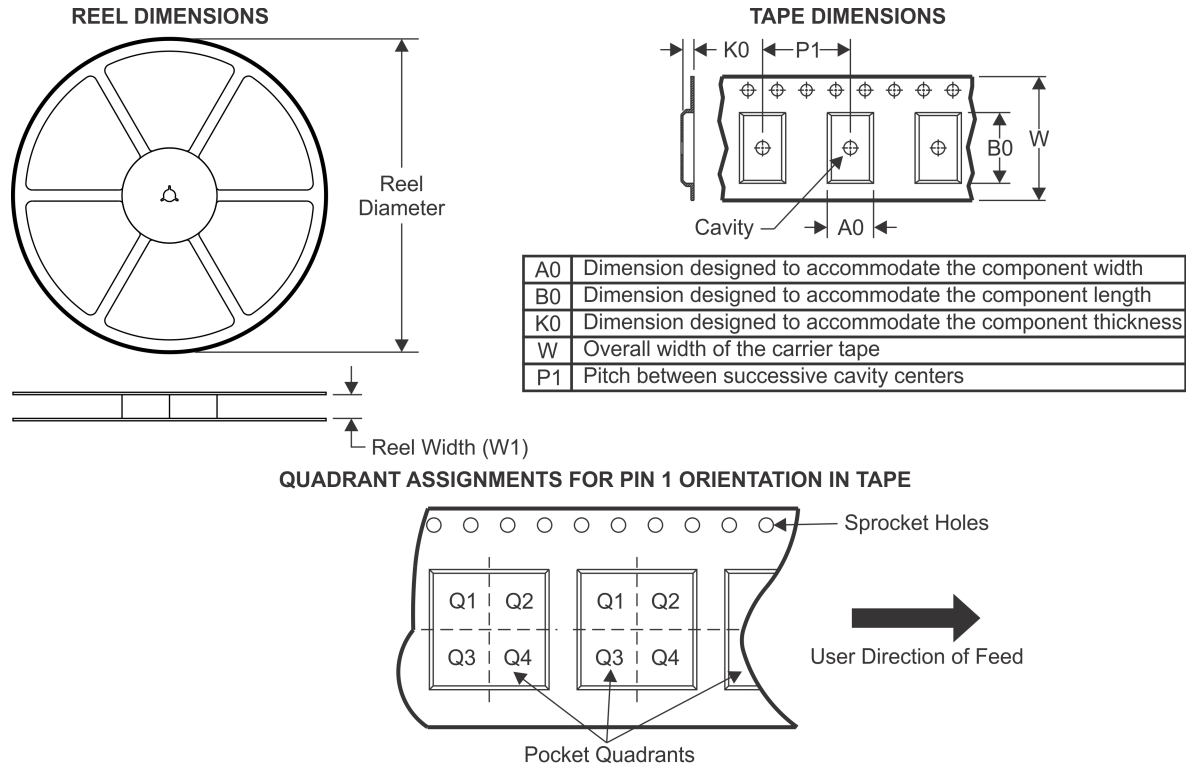
<sup>(5)</sup> Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

<sup>(6)</sup> Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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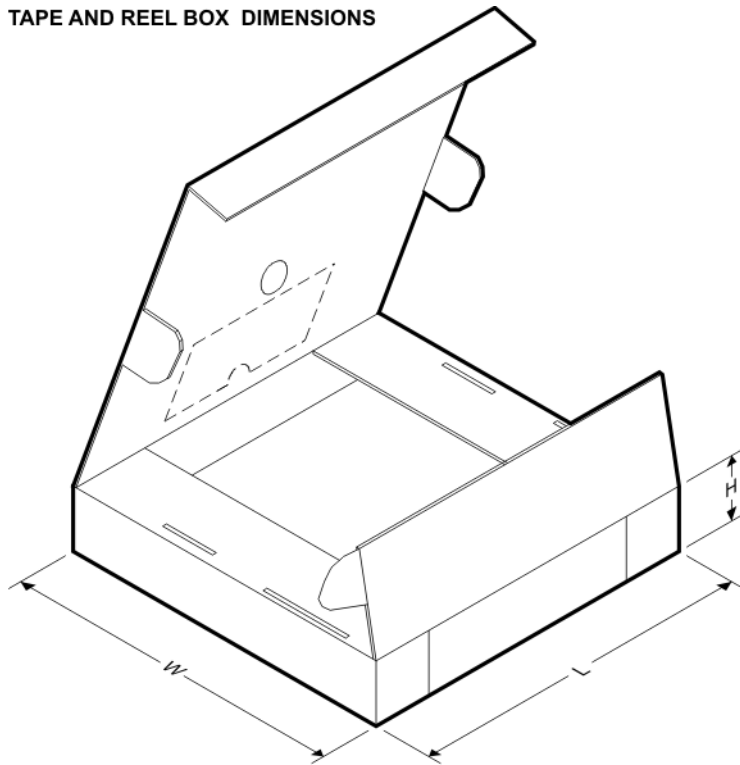
## TAPE AND REEL INFORMATION



\*All dimensions are nominal

| Device            | Package Type | Package Drawing | Pins | SPQ  | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|-------------------|--------------|-----------------|------|------|--------------------|--------------------|---------|---------|---------|---------|--------|---------------|
| MSP430FR2532IRGER | VQFN         | RGE             | 24   | 3000 | 330.0              | 12.4               | 4.25    | 4.25    | 1.15    | 8.0     | 12.0   | Q2            |
| MSP430FR2533IDAR  | TSSOP        | DA              | 32   | 2000 | 330.0              | 24.4               | 8.6     | 11.5    | 1.6     | 12.0    | 24.0   | Q1            |
| MSP430FR2533IRHBR | VQFN         | RHB             | 32   | 3000 | 330.0              | 12.4               | 5.3     | 5.3     | 1.1     | 8.0     | 12.0   | Q2            |
| MSP430FR2632IRGER | VQFN         | RGE             | 24   | 3000 | 330.0              | 12.4               | 4.25    | 4.25    | 1.15    | 8.0     | 12.0   | Q2            |
| MSP430FR2632IYQWR | DSBGA        | YQW             | 24   | 3000 | 180.0              | 8.4                | 2.38    | 2.4     | 0.8     | 4.0     | 8.0    | Q1            |
| MSP430FR2632IYQWT | DSBGA        | YQW             | 24   | 250  | 180.0              | 8.4                | 2.38    | 2.4     | 0.8     | 4.0     | 8.0    | Q1            |
| MSP430FR2633IDAR  | TSSOP        | DA              | 32   | 2000 | 330.0              | 24.4               | 8.6     | 11.5    | 1.6     | 12.0    | 24.0   | Q1            |
| MSP430FR2633IRHBR | VQFN         | RHB             | 32   | 3000 | 330.0              | 12.4               | 5.3     | 5.3     | 1.1     | 8.0     | 12.0   | Q2            |
| MSP430FR2633IYQWR | DSBGA        | YQW             | 24   | 3000 | 180.0              | 8.4                | 2.38    | 2.4     | 0.8     | 4.0     | 8.0    | Q1            |
| MSP430FR2633IYQWT | DSBGA        | YQW             | 24   | 250  | 180.0              | 8.4                | 2.38    | 2.4     | 0.8     | 4.0     | 8.0    | Q1            |

## TAPE AND REEL BOX DIMENSIONS

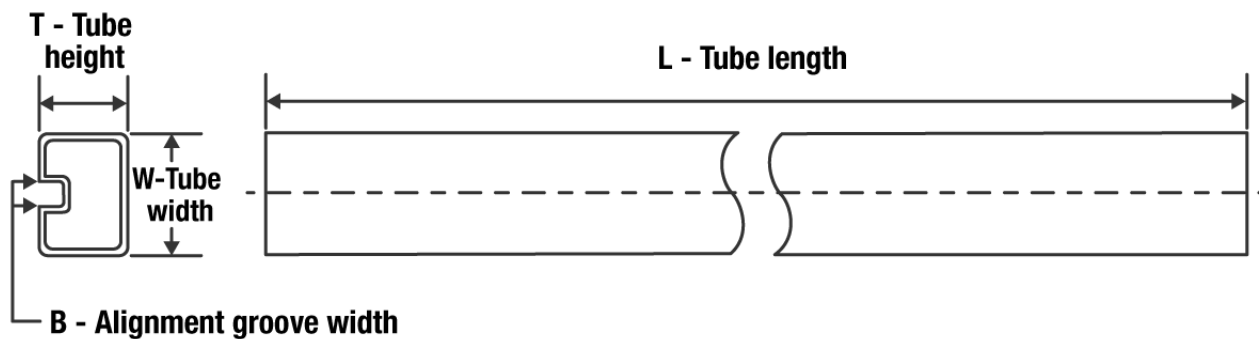


\*All dimensions are nominal

| Device            | Package Type | Package Drawing | Pins | SPQ  | Length (mm) | Width (mm) | Height (mm) |
|-------------------|--------------|-----------------|------|------|-------------|------------|-------------|
| MSP430FR2532IRGER | VQFN         | RGE             | 24   | 3000 | 367.0       | 367.0      | 35.0        |
| MSP430FR2533IDAR  | TSSOP        | DA              | 32   | 2000 | 350.0       | 350.0      | 43.0        |
| MSP430FR2533IRHBR | VQFN         | RHB             | 32   | 3000 | 367.0       | 367.0      | 35.0        |
| MSP430FR2632IRGER | VQFN         | RGE             | 24   | 3000 | 367.0       | 367.0      | 35.0        |
| MSP430FR2632IYQWR | DSBGA        | YQW             | 24   | 3000 | 182.0       | 182.0      | 20.0        |
| MSP430FR2632IYQWT | DSBGA        | YQW             | 24   | 250  | 182.0       | 182.0      | 20.0        |
| MSP430FR2633IDAR  | TSSOP        | DA              | 32   | 2000 | 350.0       | 350.0      | 43.0        |
| MSP430FR2633IRHBR | VQFN         | RHB             | 32   | 3000 | 367.0       | 367.0      | 35.0        |
| MSP430FR2633IYQWR | DSBGA        | YQW             | 24   | 3000 | 182.0       | 182.0      | 20.0        |
| MSP430FR2633IYQWT | DSBGA        | YQW             | 24   | 250  | 182.0       | 182.0      | 20.0        |



## TUBE



\*All dimensions are nominal

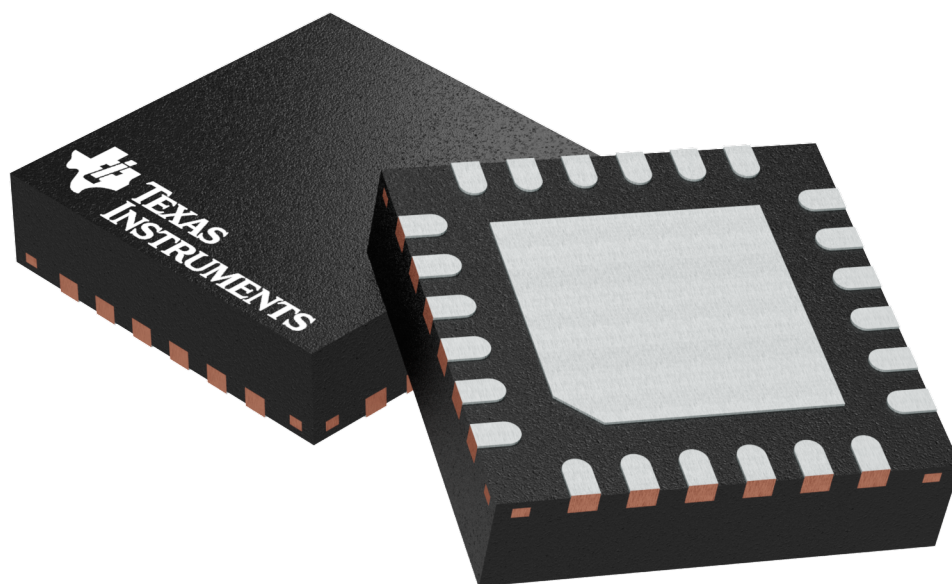
| Device          | Package Name | Package Type | Pins | SPQ | L (mm) | W (mm) | T (μm) | B (mm) |
|-----------------|--------------|--------------|------|-----|--------|--------|--------|--------|
| MSP430FR2533IDA | DA           | TSSOP        | 32   | 46  | 530    | 11.89  | 3600   | 4.9    |
| MSP430FR2633IDA | DA           | TSSOP        | 32   | 46  | 530    | 11.89  | 3600   | 4.9    |

**RGE 24**

**GENERIC PACKAGE VIEW**

**VQFN - 1 mm max height**

PLASTIC QUAD FLATPACK - NO LEAD



Images above are just a representation of the package family, actual package may vary.  
Refer to the product data sheet for package details.

4204104/H

**VQFN - 1 mm max height**

[illegible]

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.

**VQFN - 1 mm max height**

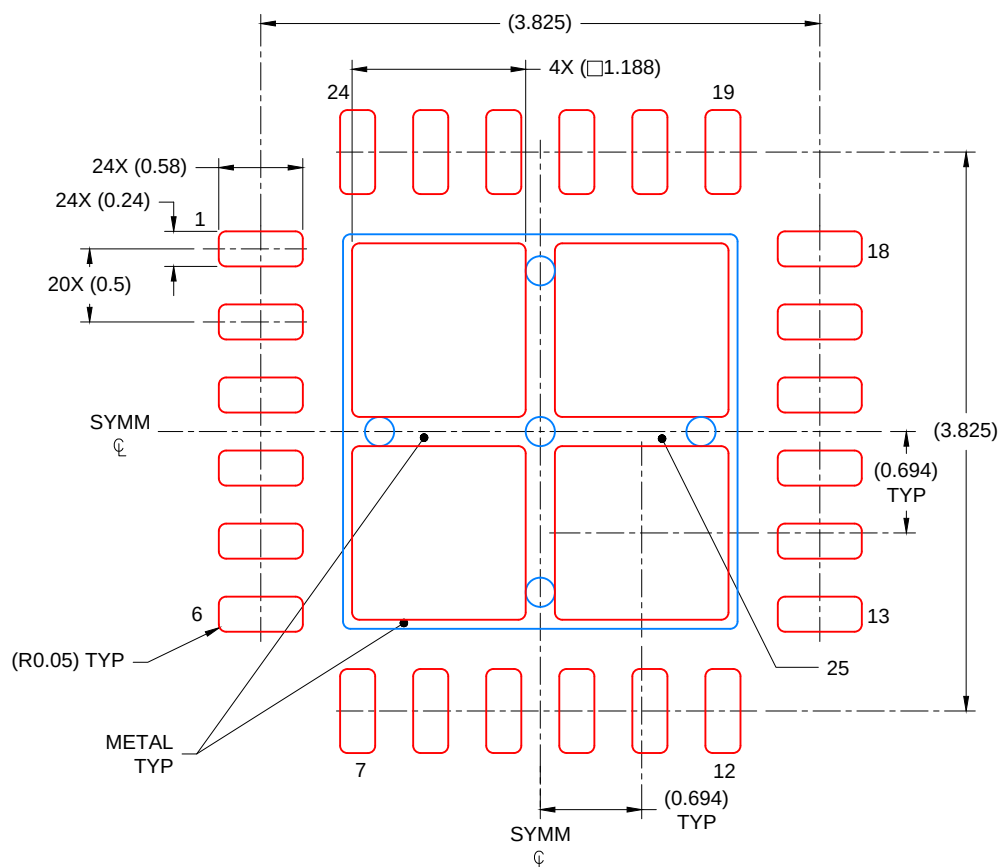
[illegible]

The diagram illustrates two types of solder mask openings on a PCB:

- NON SOLDER MASK DEFINED (PREFERRED):** This type shows a rectangular opening in the solder mask. The opening is defined by the metal pad. The dimension "0.07 MAX ALL AROUND" indicates the maximum width of the metal pad surrounding the opening. Labels include "METAL" pointing to the pad and "SOLDER MASK OPENING" pointing to the central area.
- SOLDER MASK DEFINED:** This type shows a rectangular opening in the solder mask. The opening is defined by the solder mask itself. The dimension "0.07 MIN ALL AROUND" indicates the minimum width of the metal pad surrounding the opening. Labels include "SOLDER MASK OPENING" pointing to the central area and "METAL UNDER SOLDER MASK" pointing to the pad area.

**SOLDER MASK DETAILS**

4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 ([www.ti.com/lit/slua271](http://www.ti.com/lit/slua271)).
5. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SOLDER PASTE EXAMPLE  
BASED ON 0.125 mm THICK STENCIL

EXPOSED PAD  
78% PRINTED COVERAGE BY AREA  
SCALE: 20X

4219016 / A 08/2017

NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations..

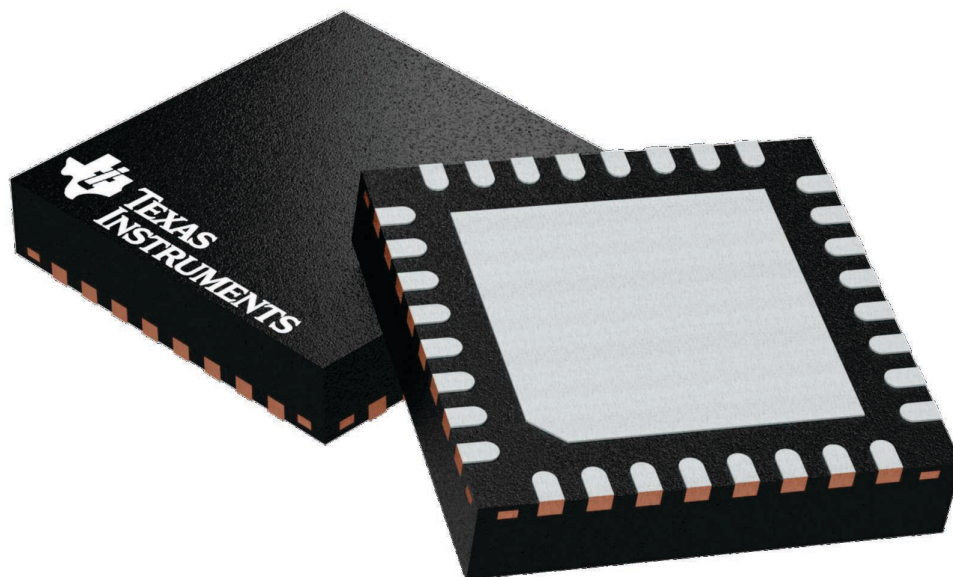
## GENERIC PACKAGE VIEW

**RHB 32**

**VQFN - 1 mm max height**

5 x 5, 0.5 mm pitch

PLASTIC QUAD FLATPACK - NO LEAD



Images above are just a representation of the package family, actual package may vary.  
Refer to the product data sheet for package details.

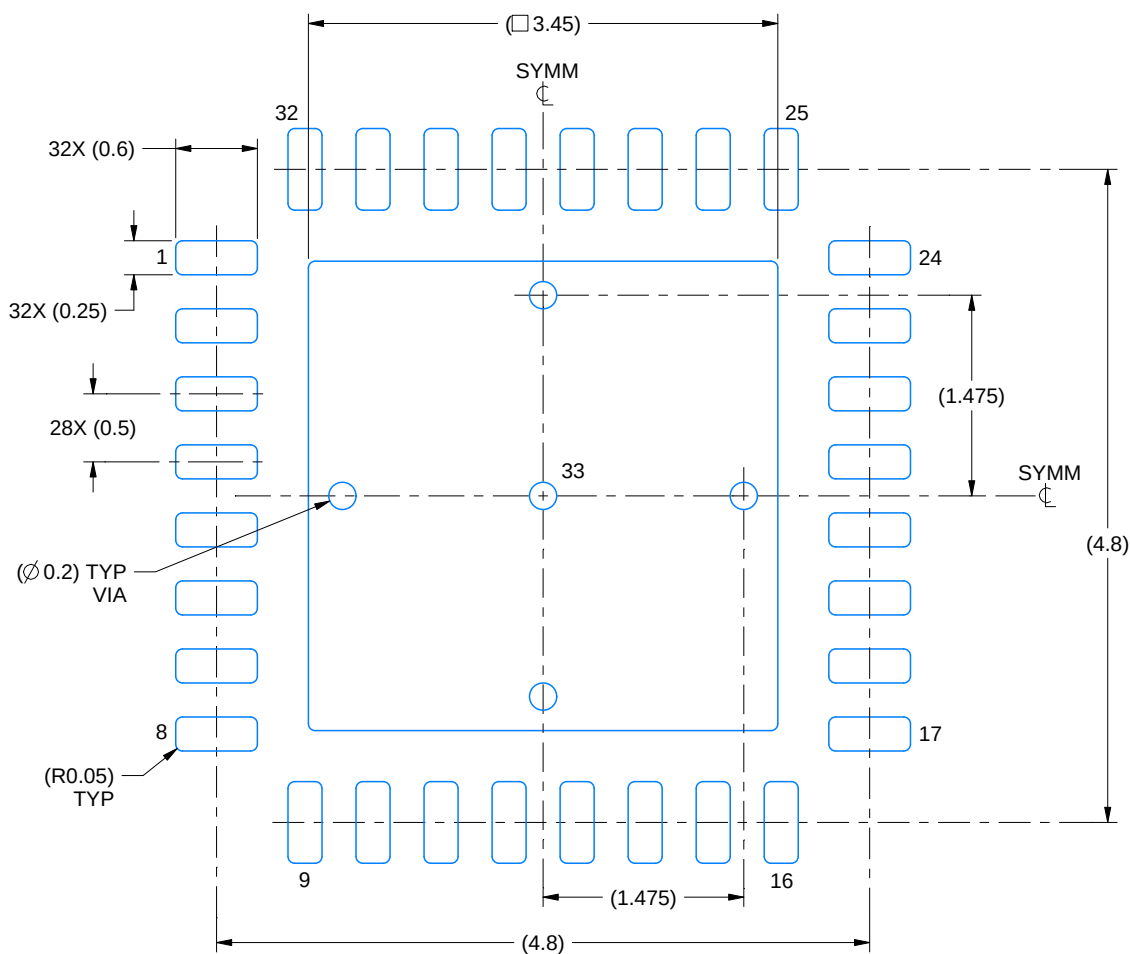
4224745/A

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.

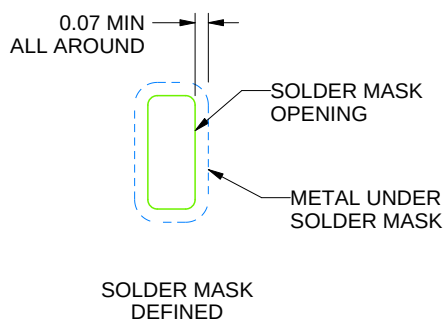
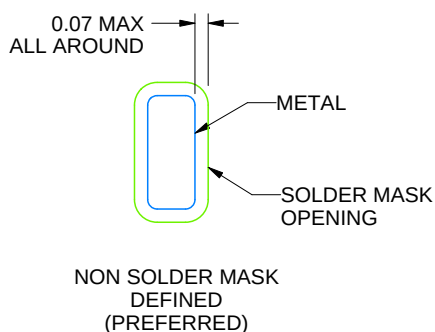
**RHB0032E**

**VQFN - 1 mm max height**

PLASTIC QUAD FLATPACK - NO LEAD



LAND PATTERN EXAMPLE  
SCALE:18X



## SOLDER MASK DETAILS

4223442/B 08/2019

NOTES: (continued)

4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 ([www.ti.com/lit/sluea271](http://www.ti.com/lit/sluea271)).
5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.

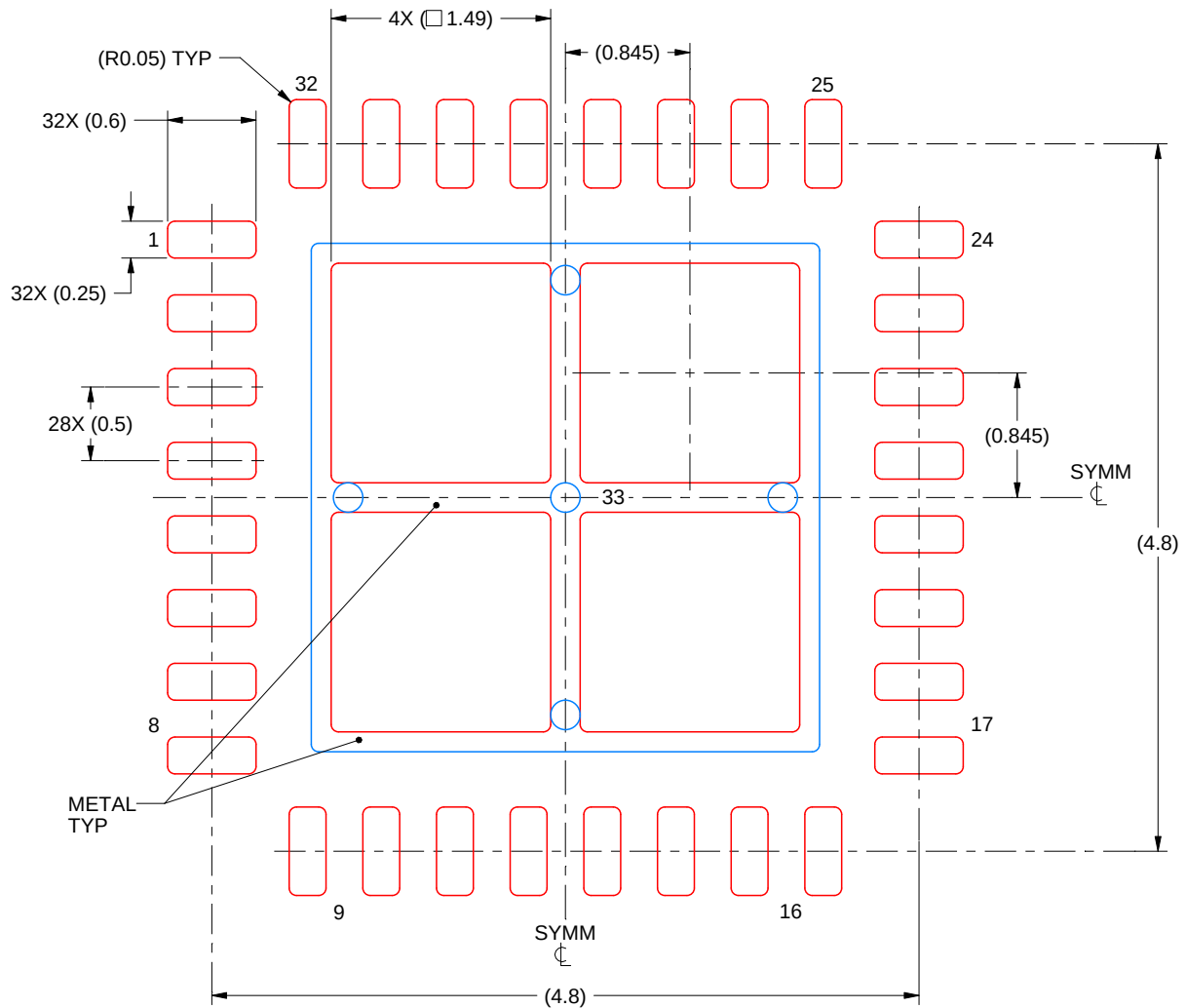


# EXAMPLE STENCIL DESIGN

RHB0032E

VQFN - 1 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



**SOLDER PASTE EXAMPLE**  
BASED ON 0.125 mm THICK STENCIL

EXPOSED PAD 33:  
75% PRINTED SOLDER COVERAGE BY AREA UNDER PACKAGE  
SCALE:20X

4223442/B 08/2019

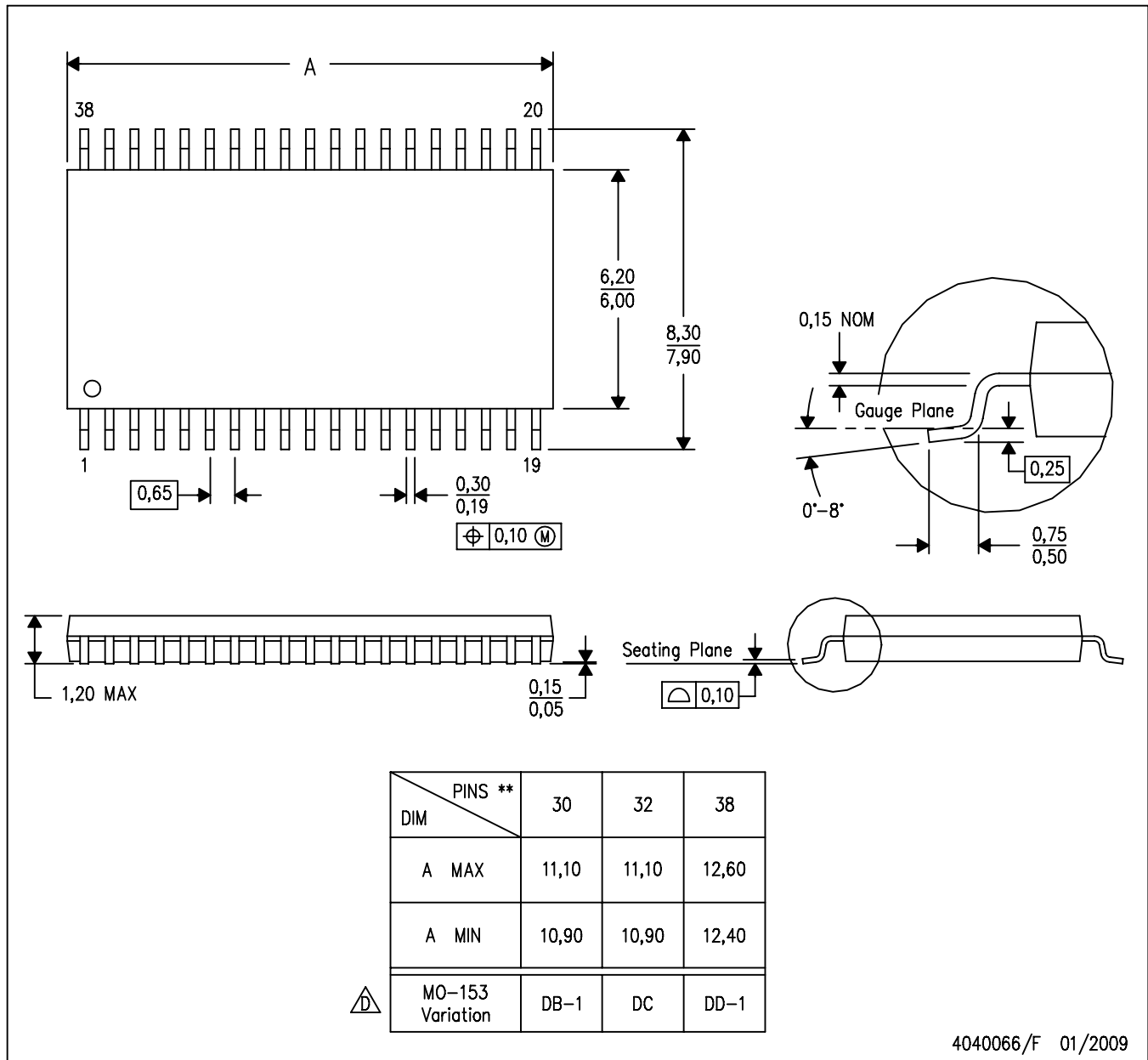
NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

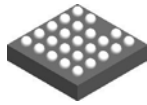
DA (R-PDSO-G\*\*)

38 PIN SHOWN

PLASTIC SMALL-OUTLINE PACKAGE



- NOTES:
- A. All linear dimensions are in millimeters.
  - B. This drawing is subject to change without notice.
  - C. Body dimensions do not include mold flash or protrusion. Mold flash and protrusion shall not exceed 0.15 per side.
  - D. Falls within JEDEC MO-153, except 30 pin body length.

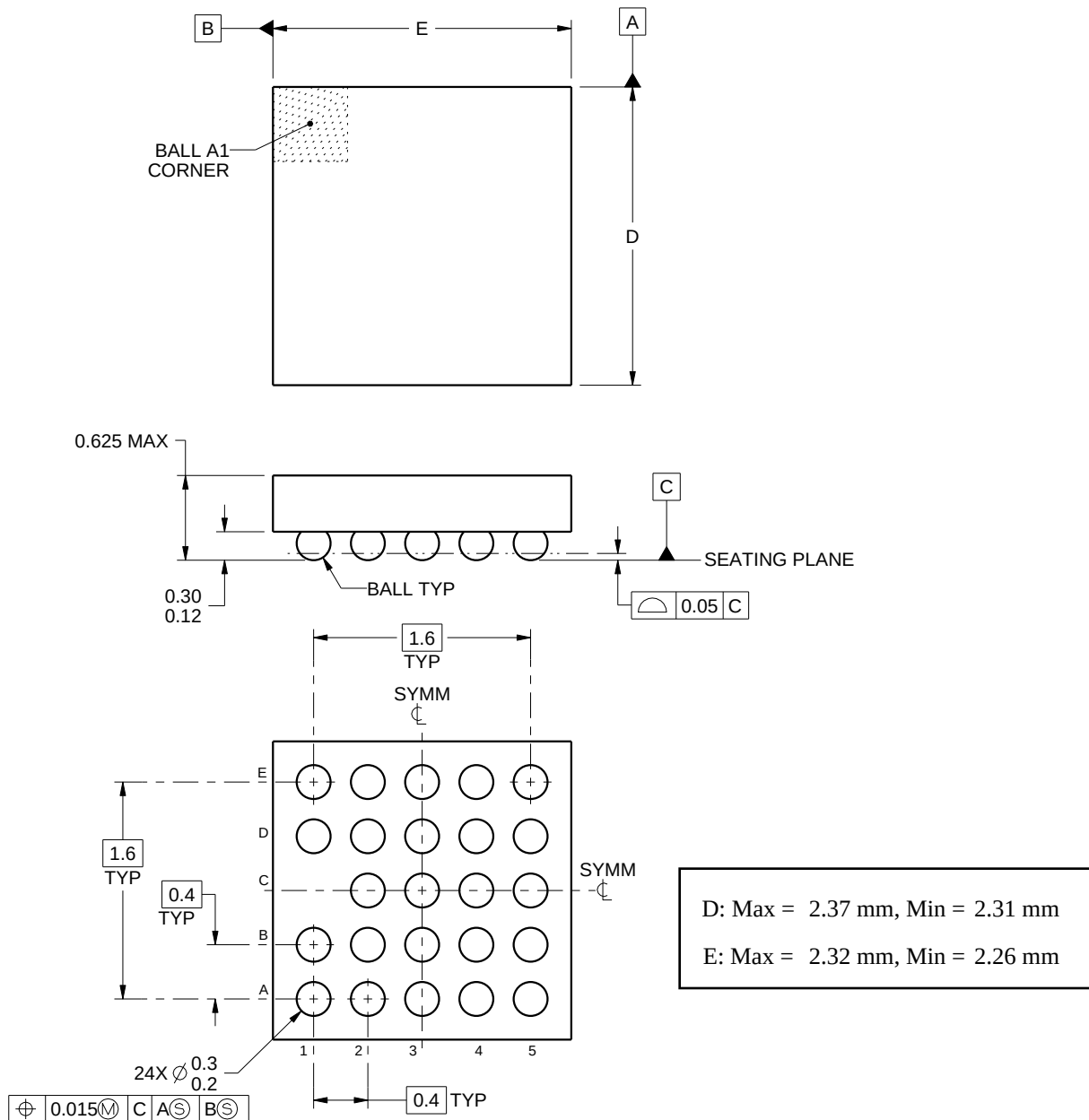


YQW0024

## PACKAGE OUTLINE

DSBGA - 0.625 mm max height

DIE SIZE BALL GRID ARRAY



4221561/A 02/2016

### NOTES:

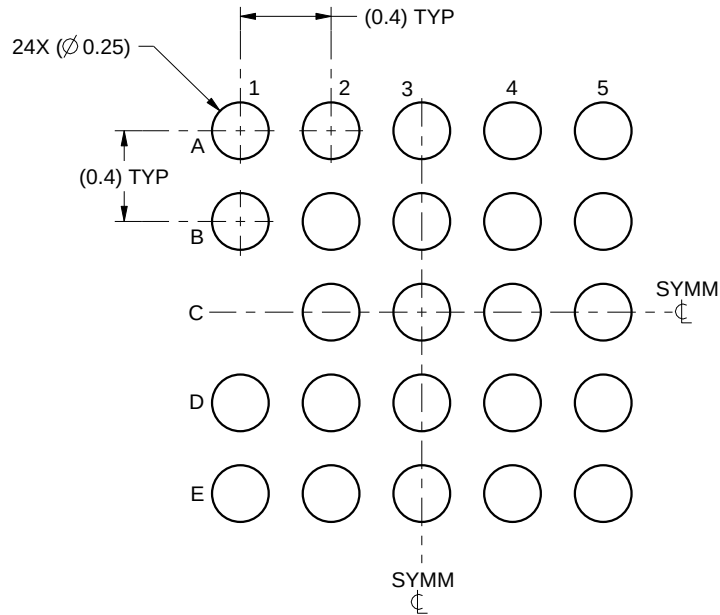
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.

# EXAMPLE BOARD LAYOUT

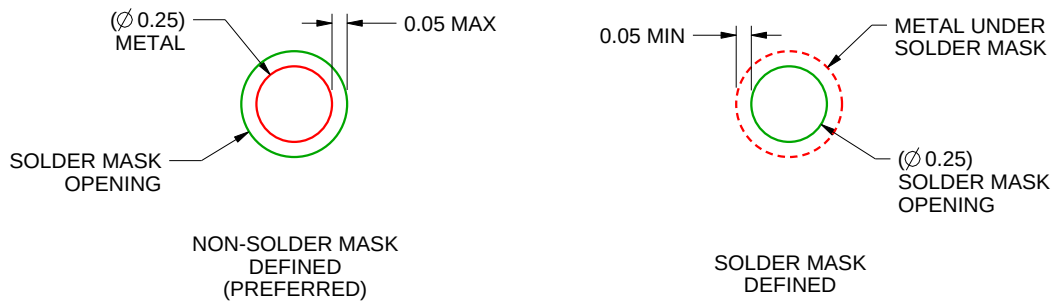
YQW0024

DSBGA - 0.625 mm max height

DIE SIZE BALL GRID ARRAY



LAND PATTERN EXAMPLE  
SCALE:30X



SOLDER MASK DETAILS  
NOT TO SCALE

4221561/A 02/2016

NOTES: (continued)

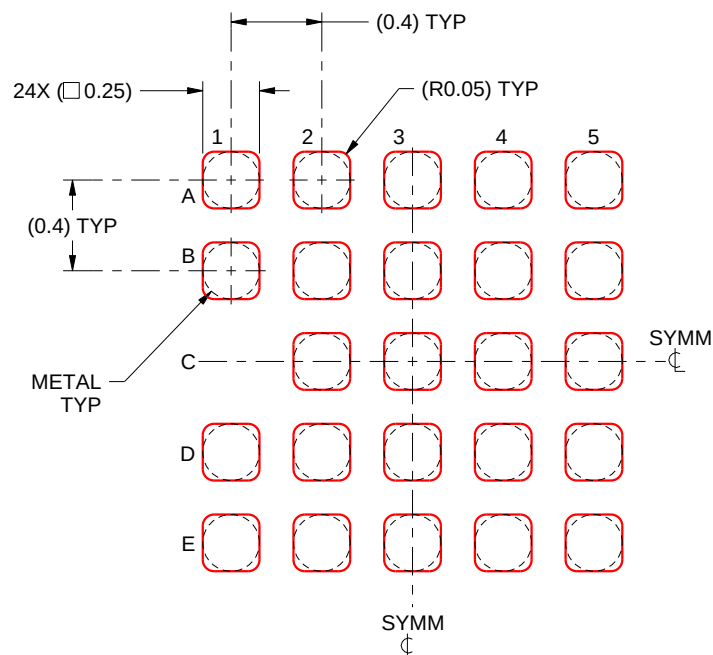
- Final dimensions may vary due to manufacturing tolerance considerations and also routing constraints. See Texas Instruments Literature No. SNVA009 ([www.ti.com/lit/snva009](http://www.ti.com/lit/snva009)).

## EXAMPLE STENCIL DESIGN

YQW0024

DSBGA - 0.625 mm max height

DIE SIZE BALL GRID ARRAY



SOLDER PASTE EXAMPLE  
BASED ON 0.1 mm THICK STENCIL  
SCALE:30X

4221561/A 02/2016

NOTES: (continued)

4. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release.

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